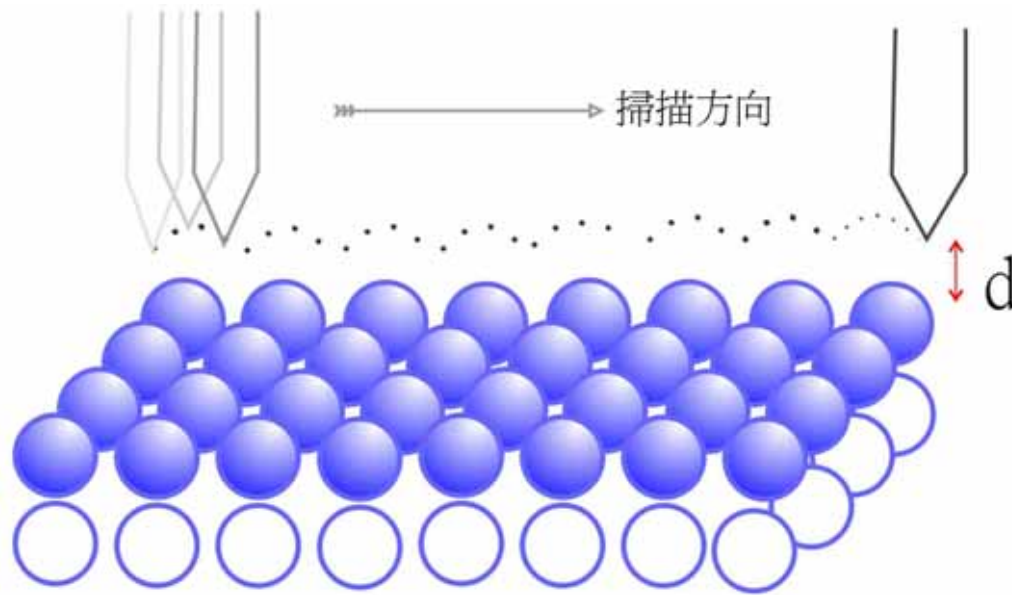


# Scanning Tunneling Microscopy

## 掃描穿隧顯微術

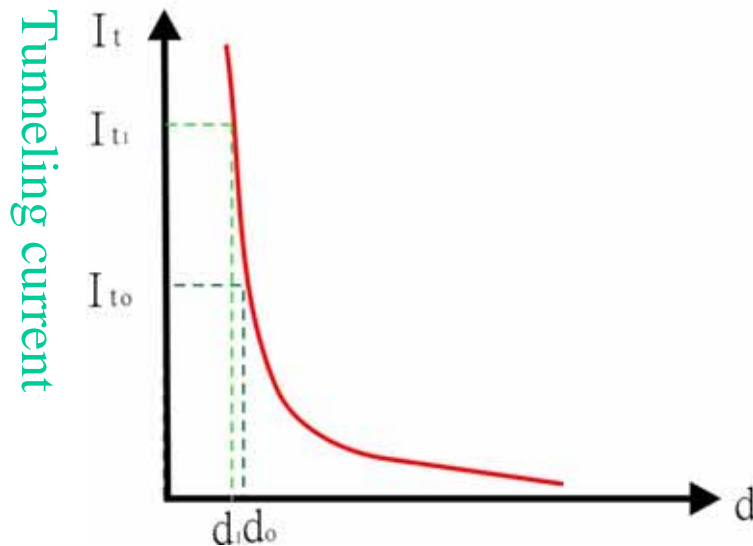
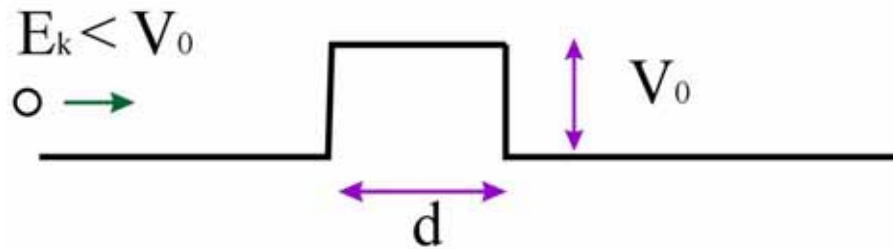


### References

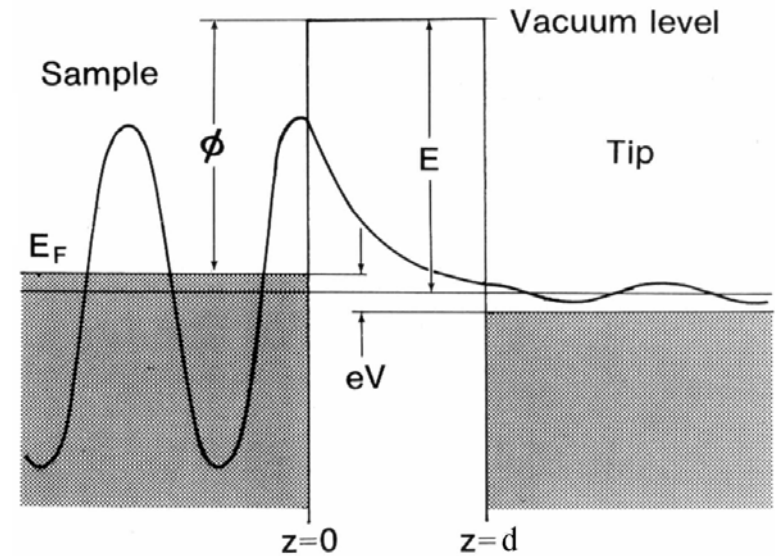
1. G. Binnig, H. Rohrer, C. Gerber, and Weibel, Phys. Rev. Lett. **49**, 57(1982); and ibid **50**, 120(1983).
2. J. Chen, *Introduction to Scanning Tunneling Microscopy*, New York, Oxford Univ. Press (1993).
3. 黃英碩, 科儀新知95, 18 (3), 4 (1996)。
4. 黃英碩, 科儀新知144, 26 (4), 7 (2005)。

# Tunneling

## Classical



## Quantum Mechanics



Tunneling current  $I_t$

$$I_t \propto (V/d) \exp(-A\phi^{1/2}d)$$

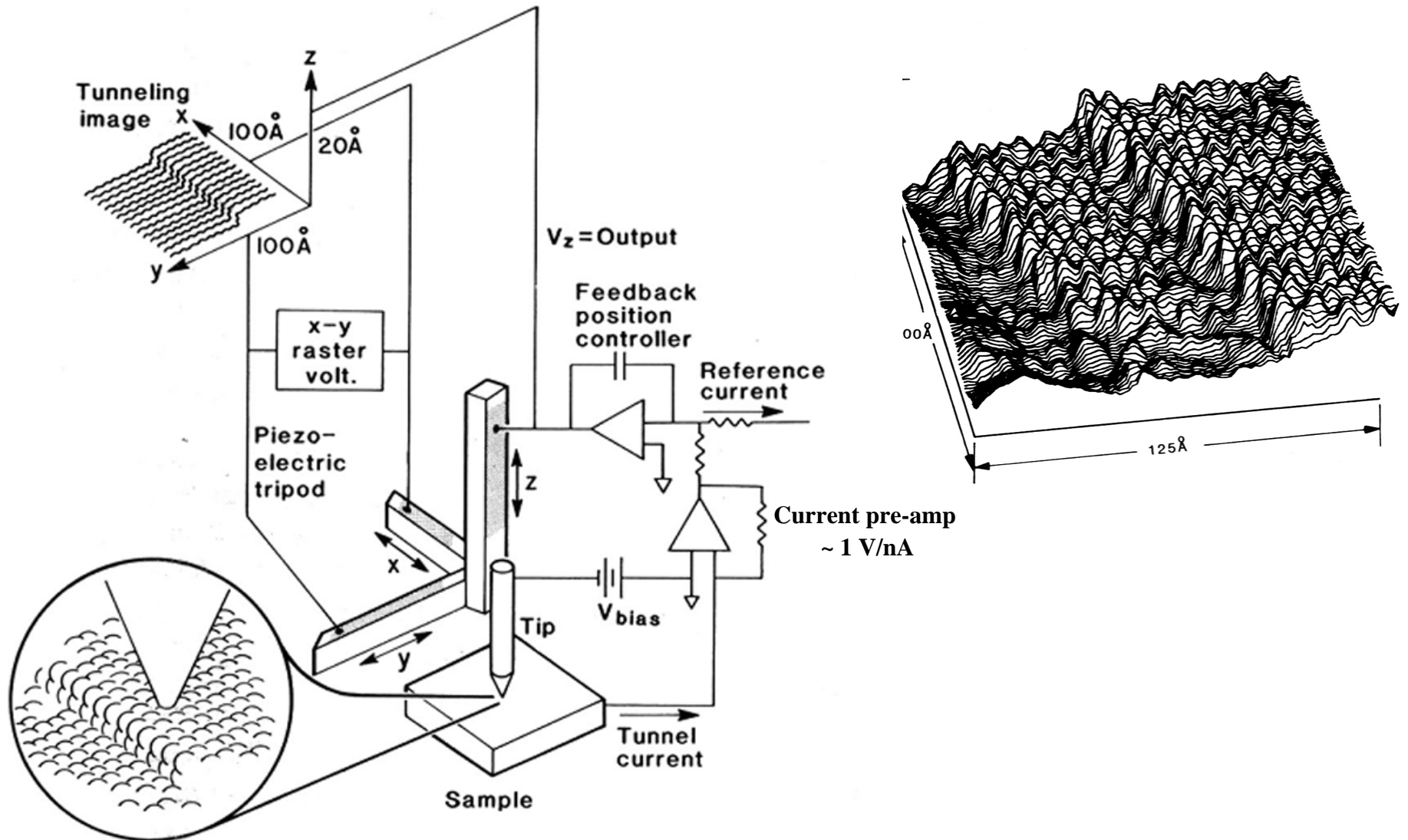
$$A = 1.025 (\text{eV})^{-1/2} \text{\AA}^{-1}$$

$$I_t = 10 \text{ pA} \sim 10 \text{ nA}$$

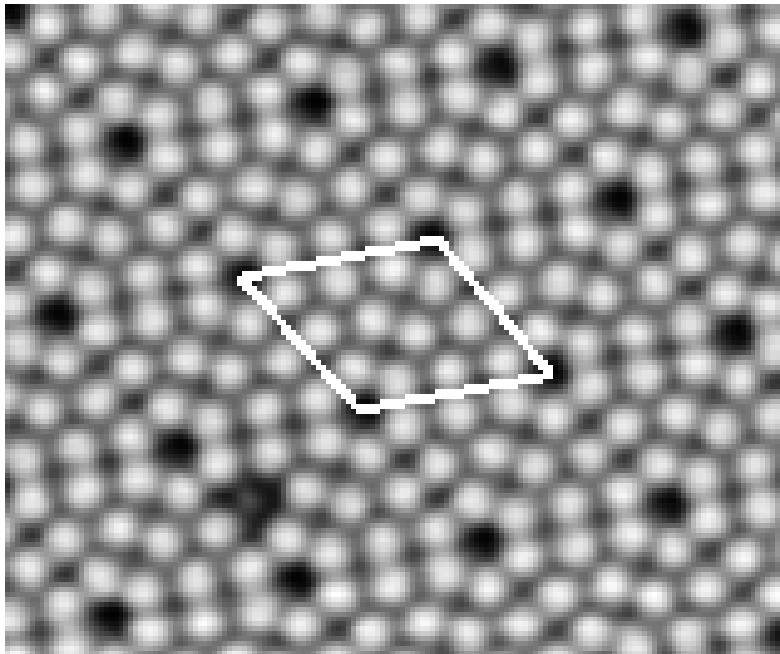
$$V = 1 \text{ mV} \sim 3 \text{ V}$$

$d$  decreases by  $1 \text{\AA}$ ,  $I_t$  increases by about one order of magnitude.

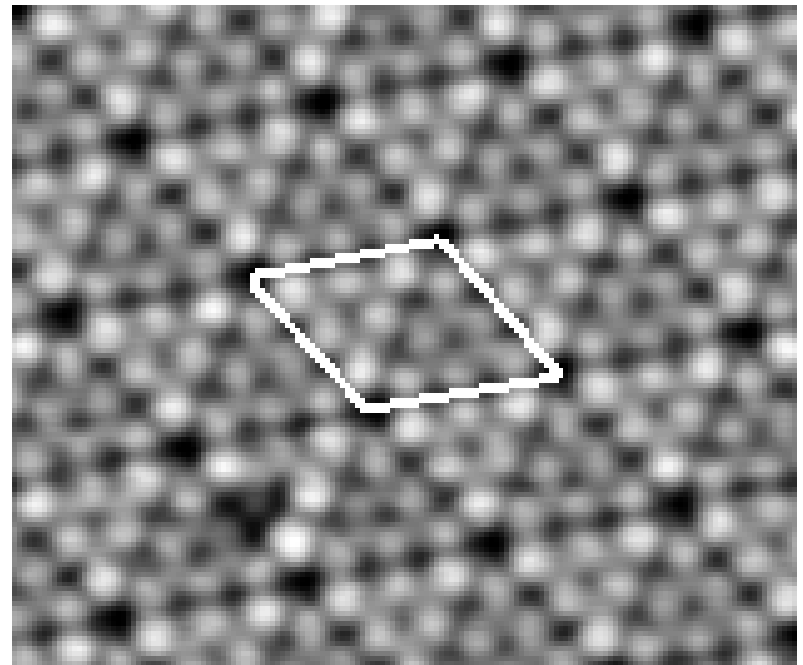
# Schematics of STM



## STM Images of Si(111)-(7×7)



Empty-state image

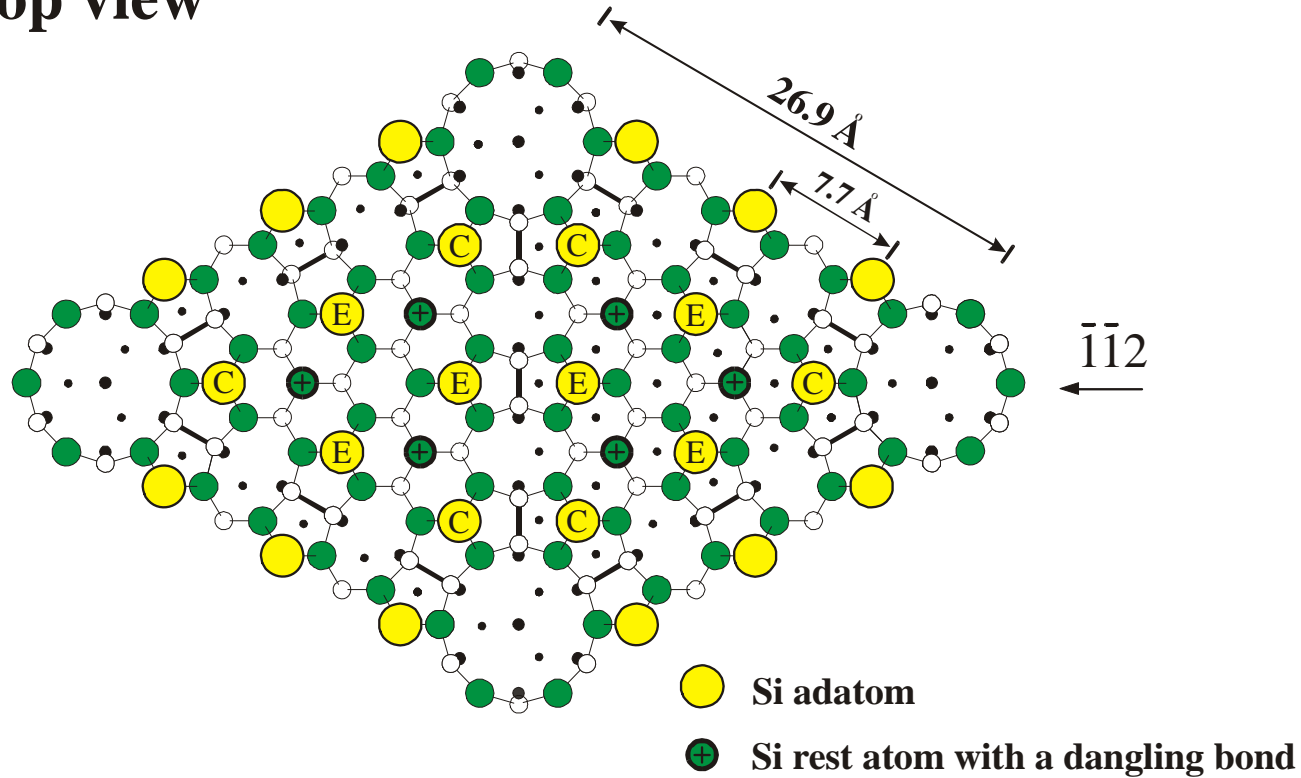


Filled-state image

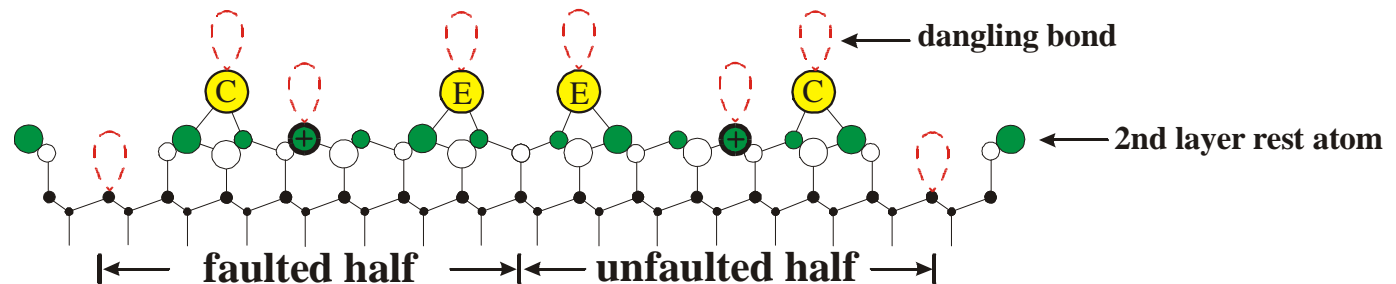


# Atomic Model of Si(111)-(7×7)

Top view

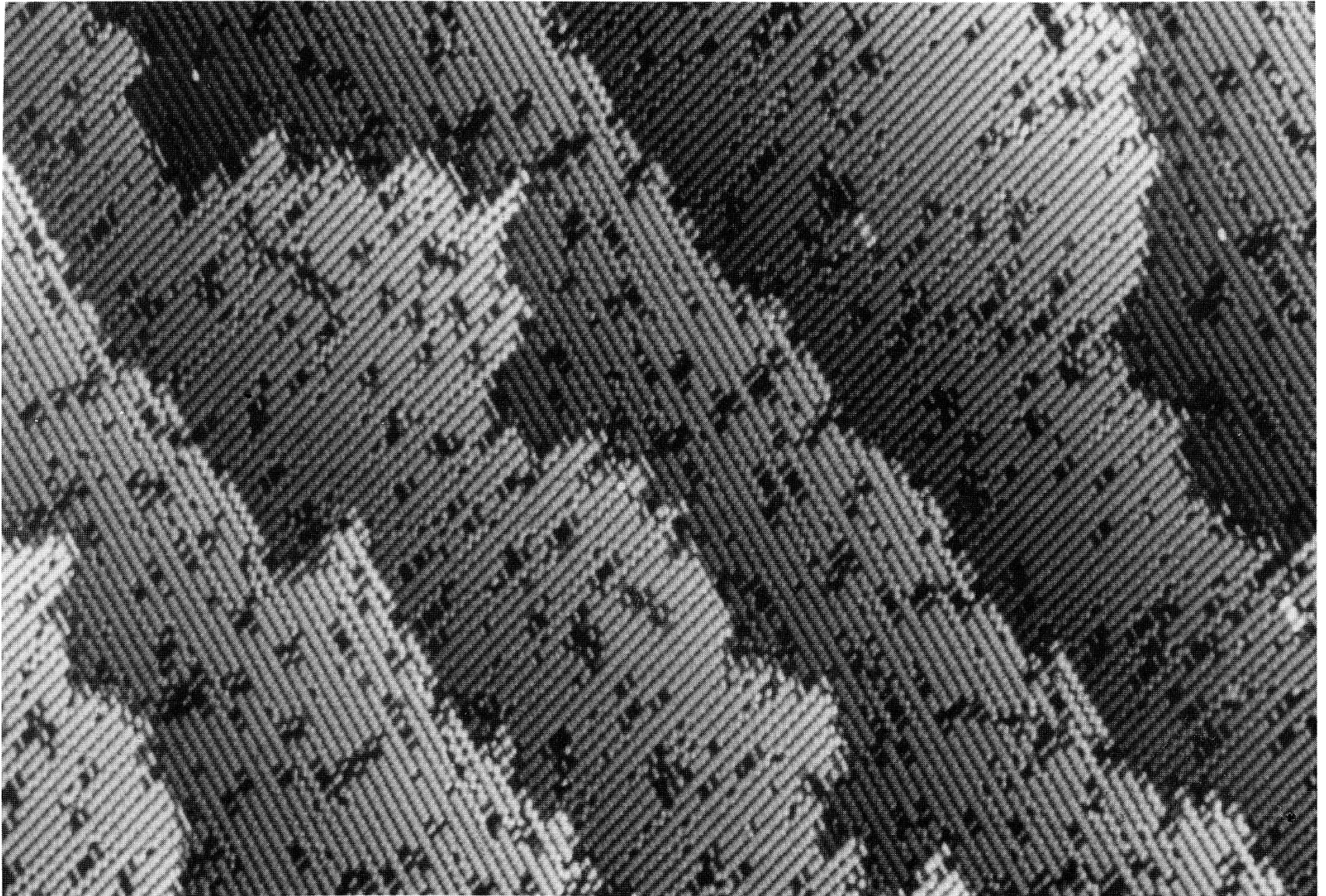


Side view



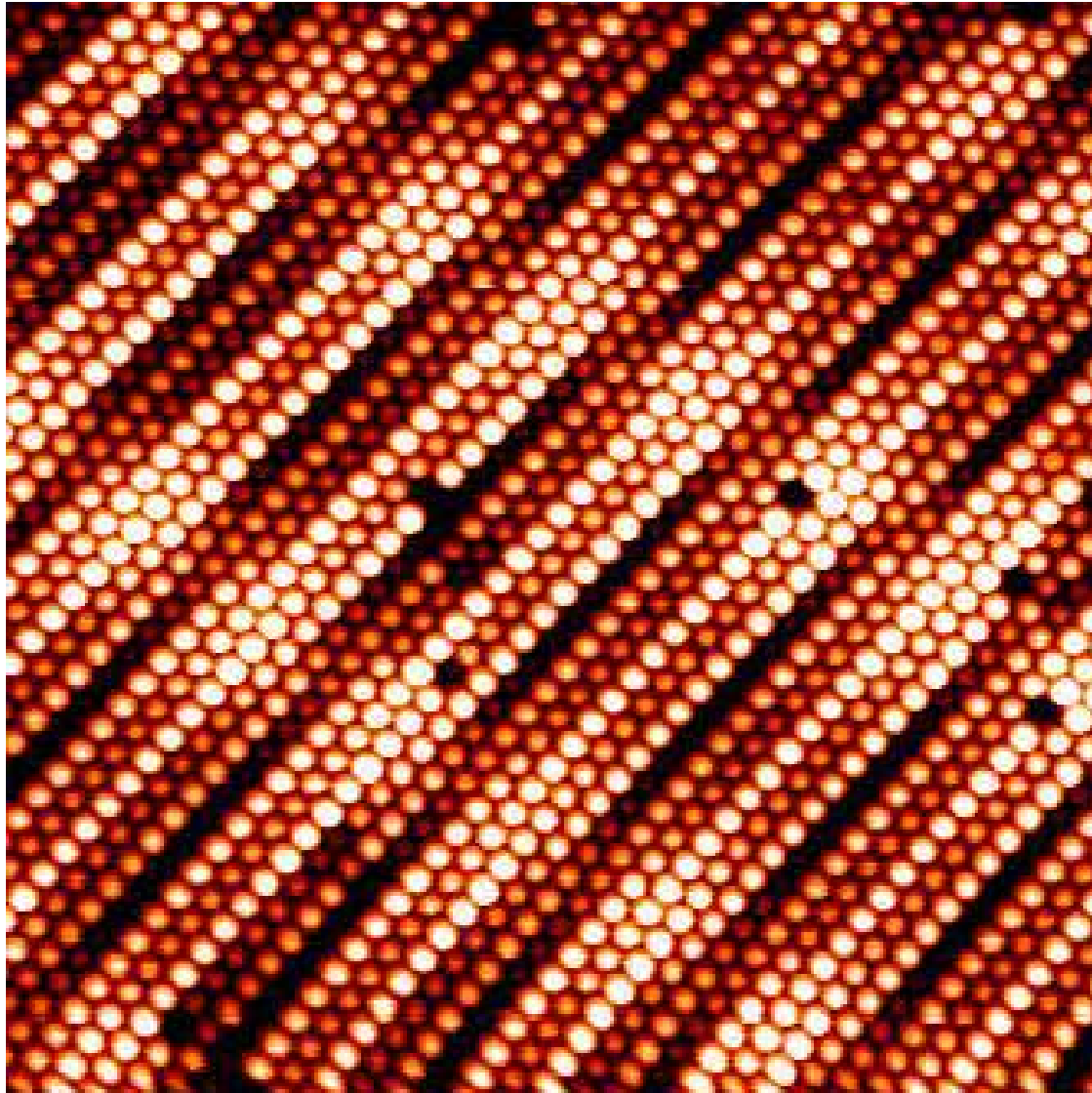


# Atomic Structure of the Si(001) Surface



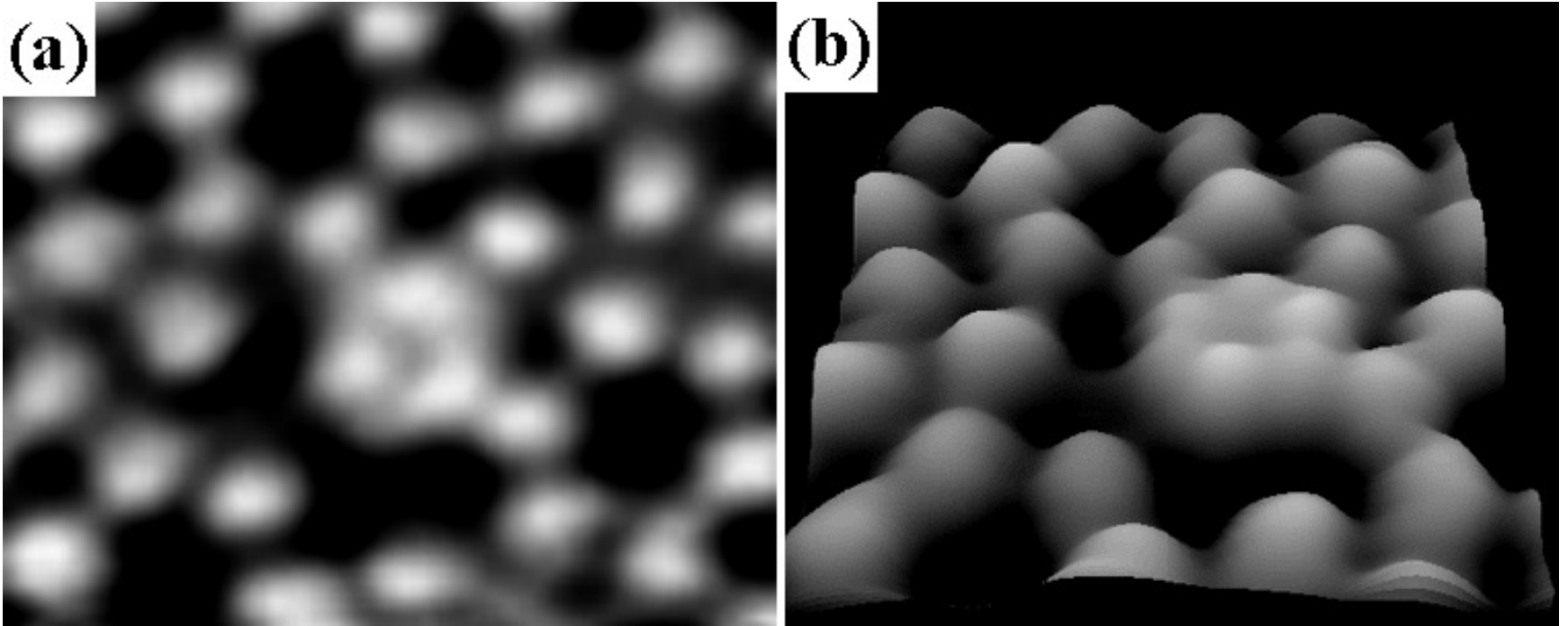


# Atomic Structure of the Pt(001) Surface



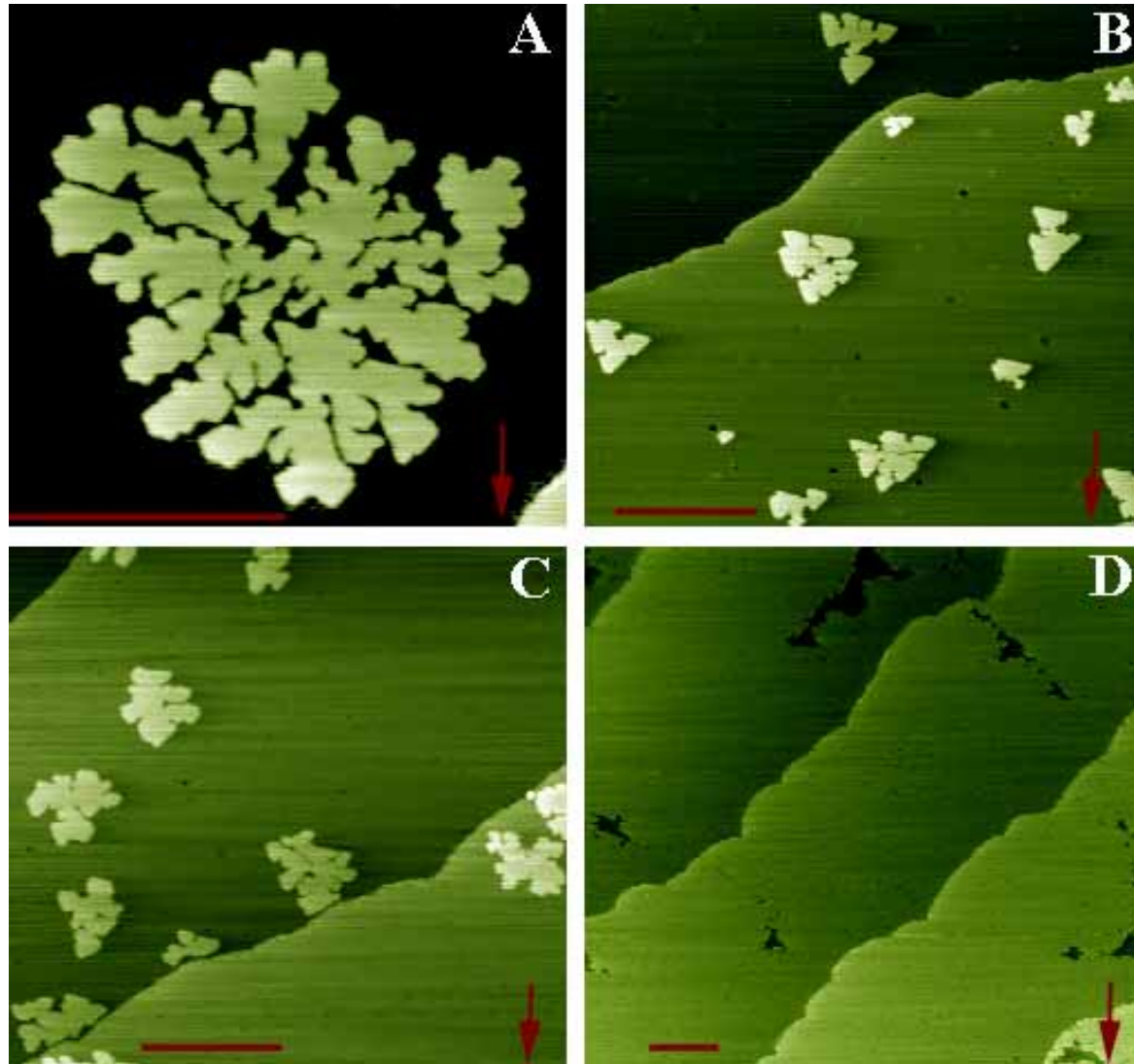
Surface Science **306**, 10 (1994).

# Si Magic Clusters



Physical Review Letters **83**, 120 (1999).

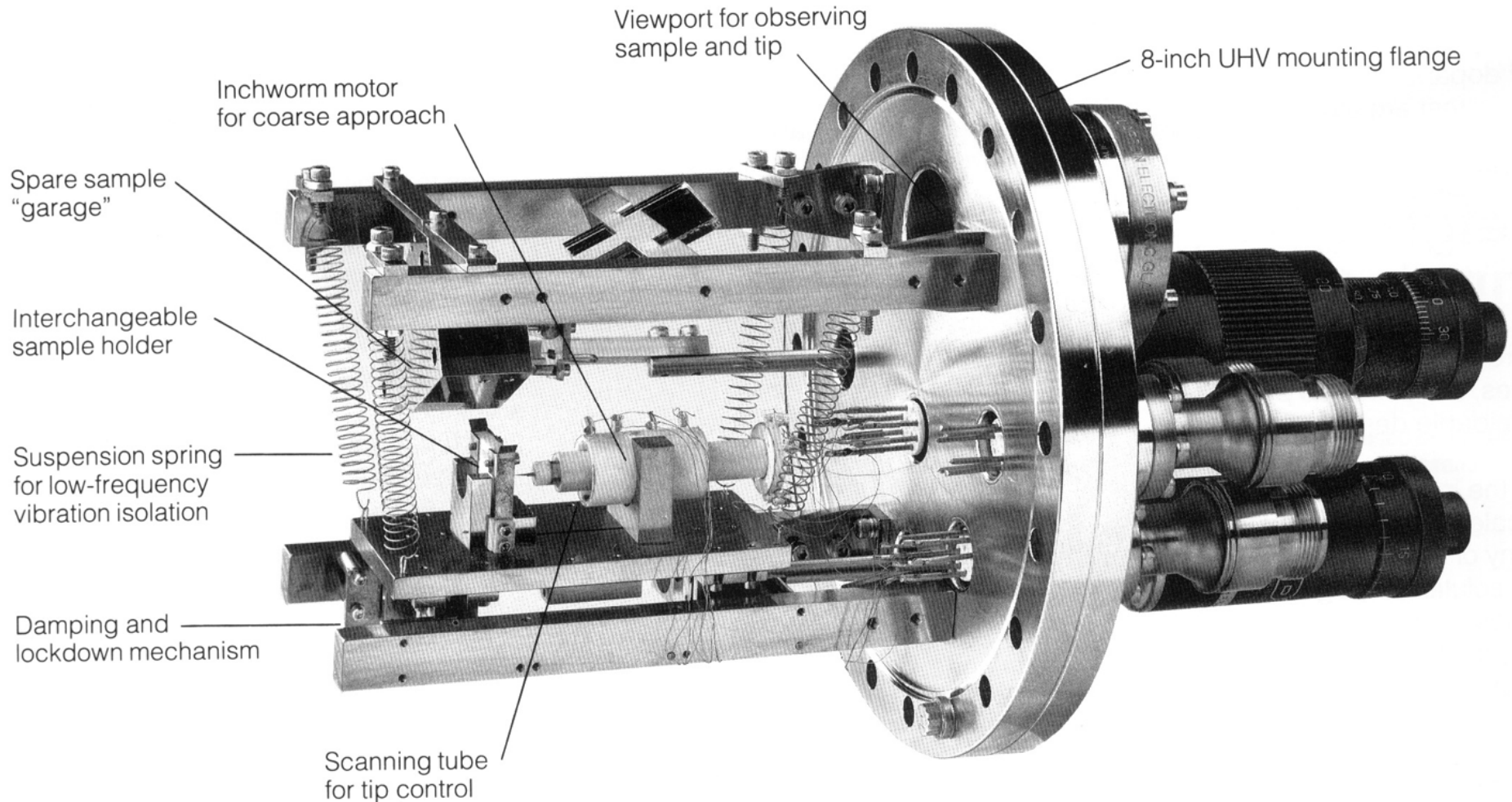
# Nucleation and Growth of Ge at Pb/Si(111)



Physical Review Letters **83**, 1191 (1999).

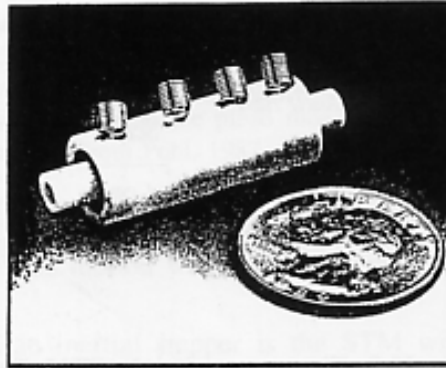
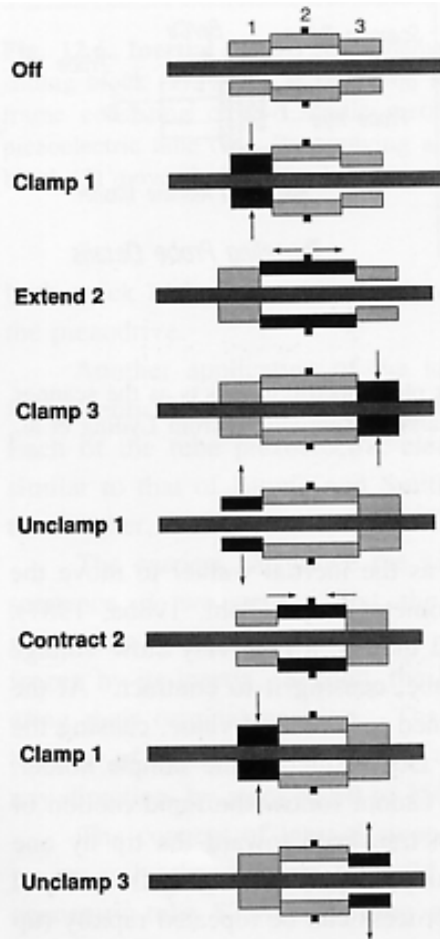
Japanese Journal of Applied Physics **39**, Part 1, No. 7A, 4100 (2000).

# Ultra-High Vacuum Scanning Tunneling Microscope

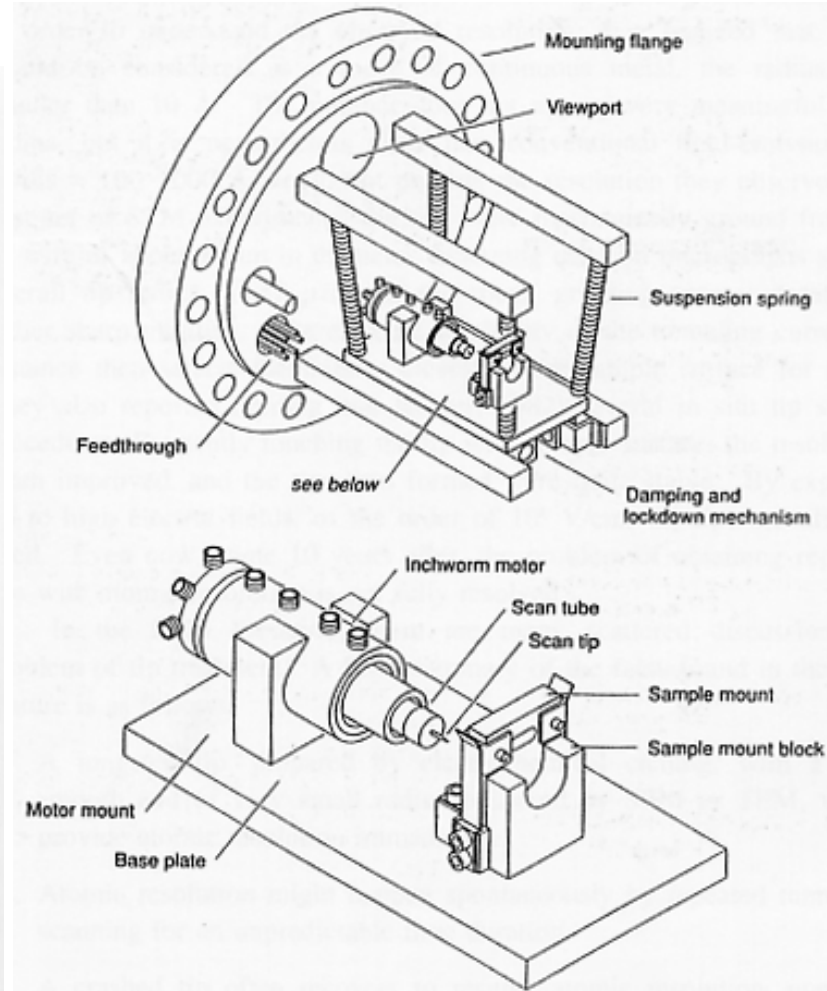




# Inchworm-Type Linear Motor

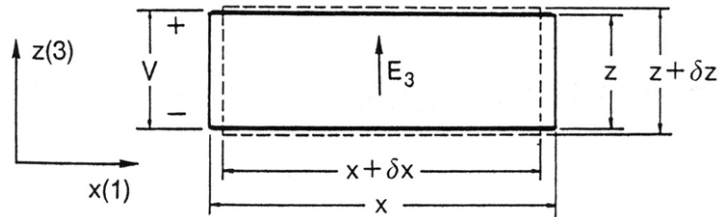


**Fig. 12.8. The Inchworm®.** It consists of an alumina shaft, slid inside a piezoelectric tube, which consists of three sections. Top, a photograph of the MicroInchworm® Motor, actual size. Right, walking mechanism: (1) Clamp the left-hand side by applying a voltage to section 1. (2) Extend section 2. (3) Clamp the right-hand end. (4) Unclamp section 1. (5) Contract the center section. (6) Clamp section 1. (7) Unclamp section 3. (Courtesy of Burleigh Instruments, Inc.)





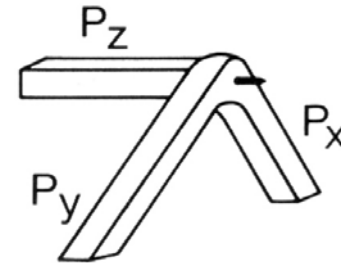
# Piezoelectric Scanners



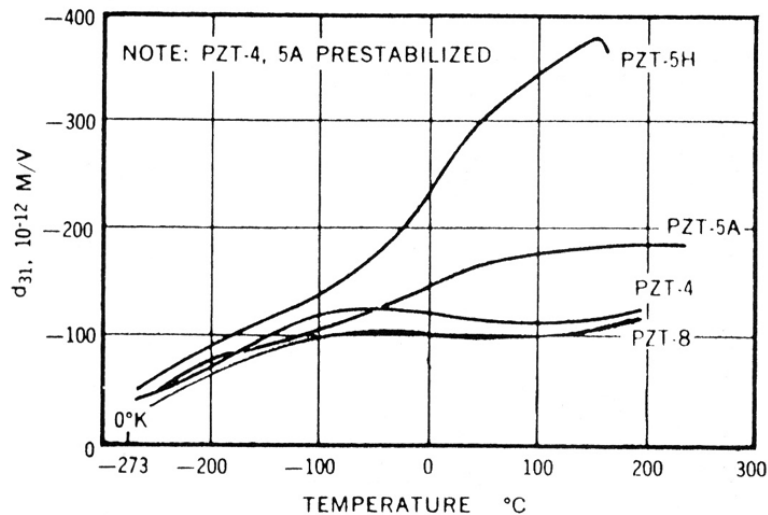
$$d_{31} = S_1/E_3, S_1 = \delta x/x, E_3 = V/z$$

$$d_{33} = S_3/E_3, S_3 = \delta z/z$$

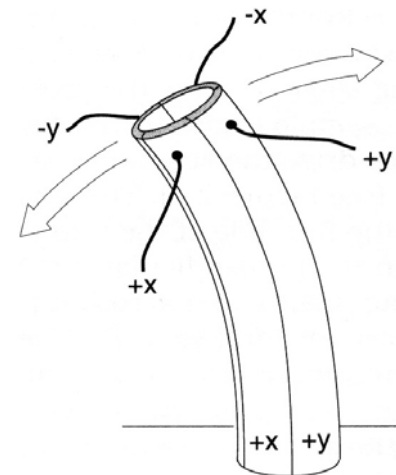
## Tripod scanner



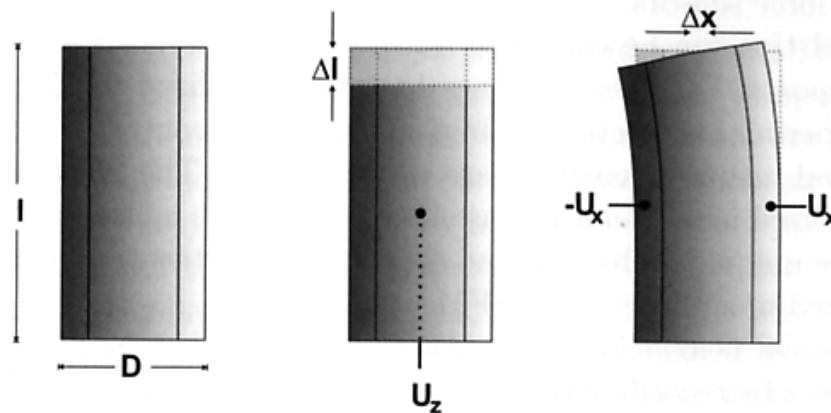
Variation of piezoelectric coefficient with temperature.



## Tube scanner



# Tube Scanners



**Fig. 1.4.** Schematic side view of tube scanning. The outside electrode is divided into four parts. When a voltage  $U_z$  is applied to the inner electrode, the length of the tube is changed. When a pair of voltages  $U_x$  and  $-U_x$  is applied to opposite electrodes outside the tube, the tube is bent and a lateral movement is realized. Note that the bending of the tube is largely exaggerated in order to visualize the effect. However, one should keep in mind that lateral displacements by tube scanners are always accompanied by height changes

$$\Delta l = \frac{d_{31} l U_z}{h} \qquad \Delta x = \frac{2\sqrt{2} d_{31} l^2 U_x}{\pi D h}$$

where  $l$  is the length of the tube.

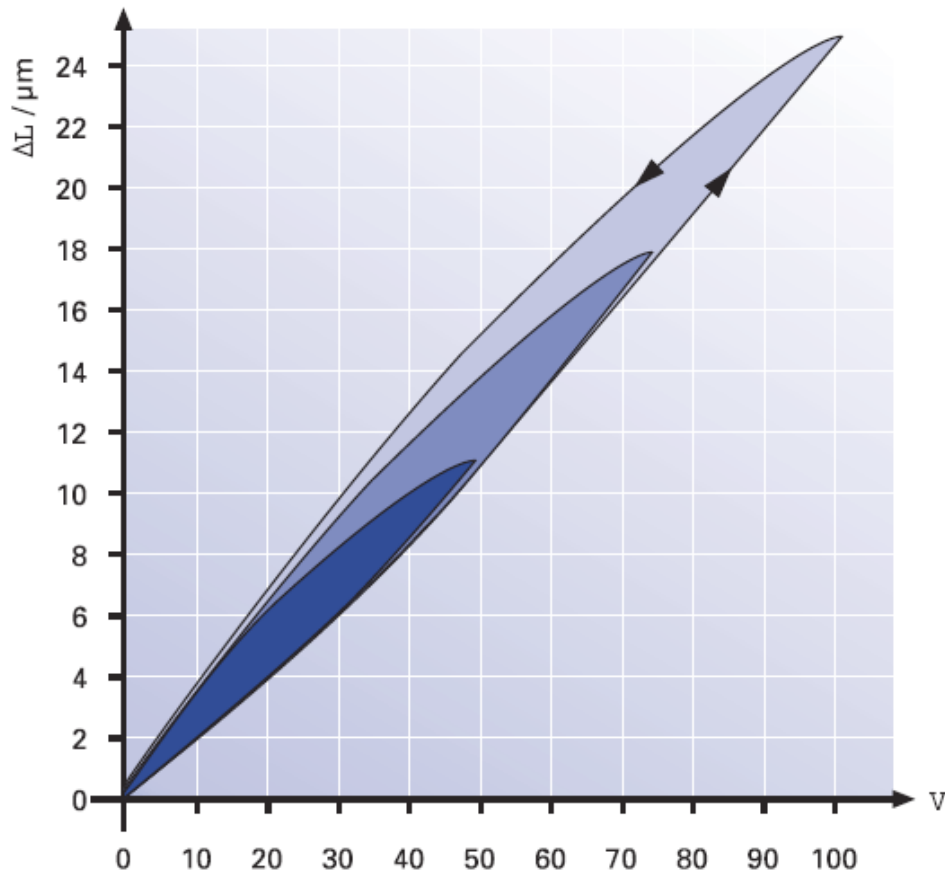
and  $h$  the wall thickness of the tube.

# PZT Materials

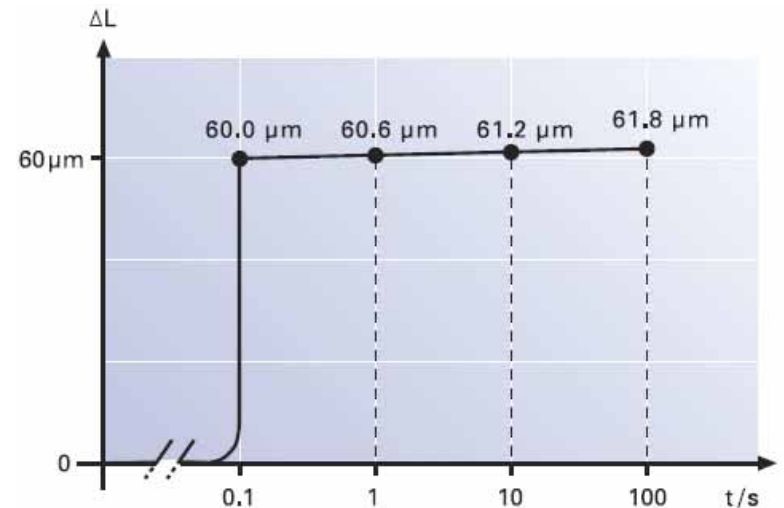
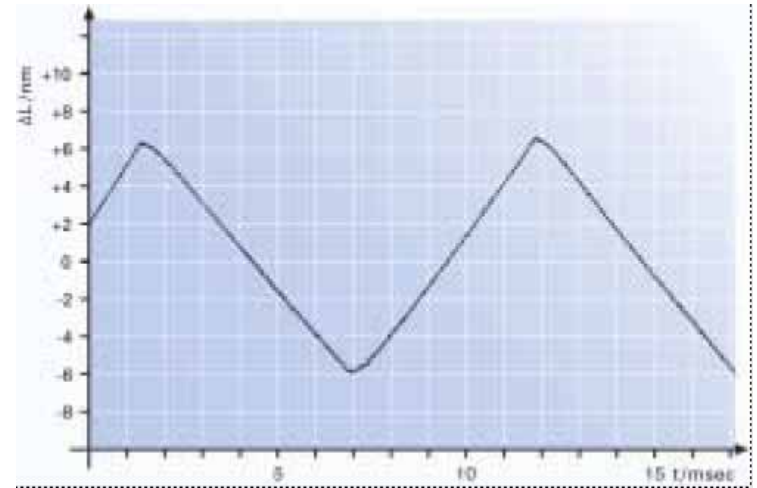
1. The piezoelectric effect was discovered by Pierre Curie and Jacques Curie in 1880.
2. The piezo materials used in STM are various kinds of lead zirconate titanate ceramics (PZT) --- a mixture of  $\text{PbZrO}_3$  and  $\text{PbTiO}_3$ . It consists of small ferroelectric crystals in random orientations.
3. An advantage for PZT ceramics over single crystal materials is that it can be shaped easily and poled at a desired direction.
4. PZT scanners are widely used in SPM because they have excellent resolution in displacement, high stiffness, and fast response. A major drawback of PZT materials is its lack of accuracy due to many nonlinear characteristics, such as hysteresis, creep, and recoil-generated ringing, which often cause distortion in SPM images. The positioning error of a PZT scanner can be as much as 10-15% of the full scanning range.
5. The piezoelectric constants vary with temperature in a complicated manner, and also with the particular batch of materials by the manufacturer and time (the aging effect).
6. Displacement calibration or compensation is needed for accurate measurement of length or size.

# Hysteresis of a PZT Actuator

Hysteresis curves of an open-loop piezo actuator for various peak voltages



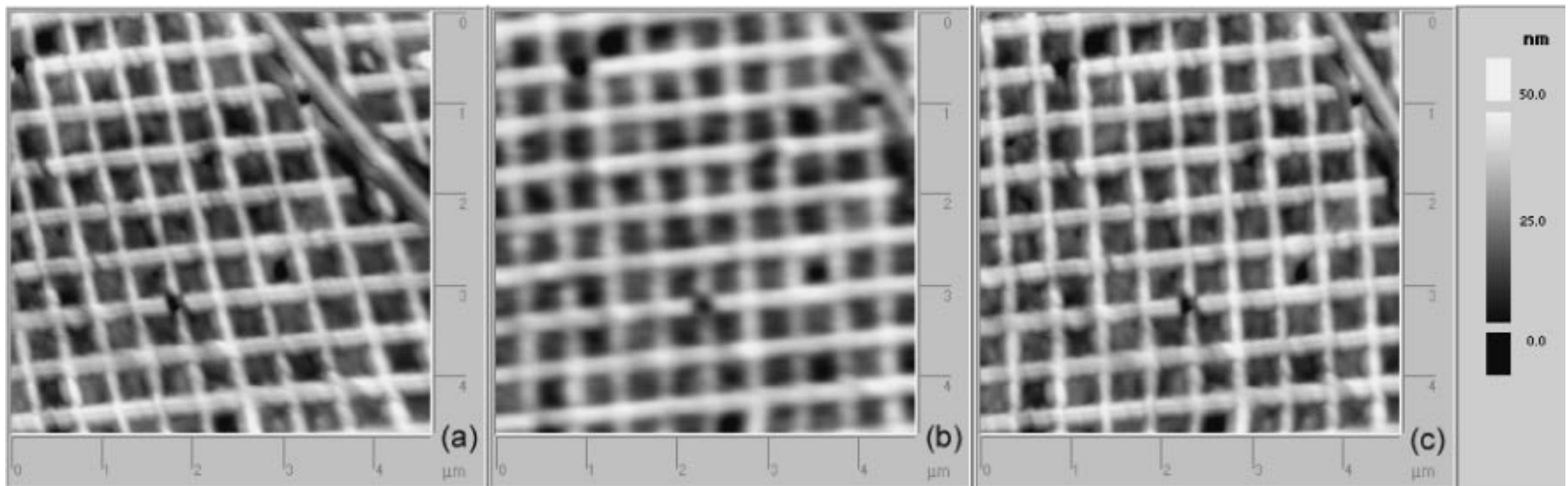
Response of a PZT translator to a 1 V, 200 Hz triangular drive signal



Creep of open-loop PZT motion

# Topographic Images of AFM Square Grating

Without correction

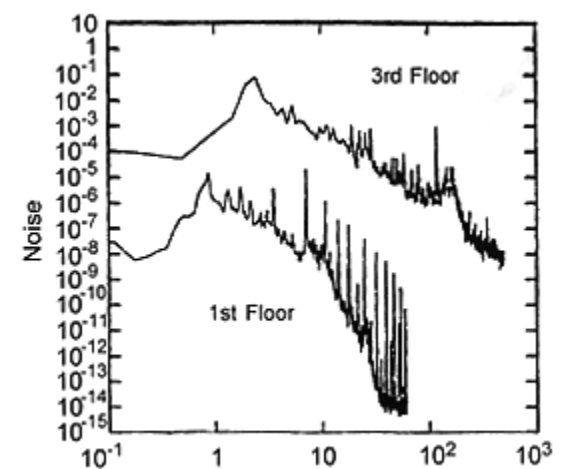
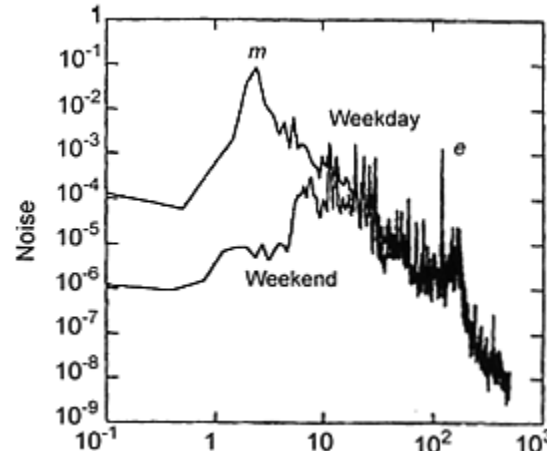
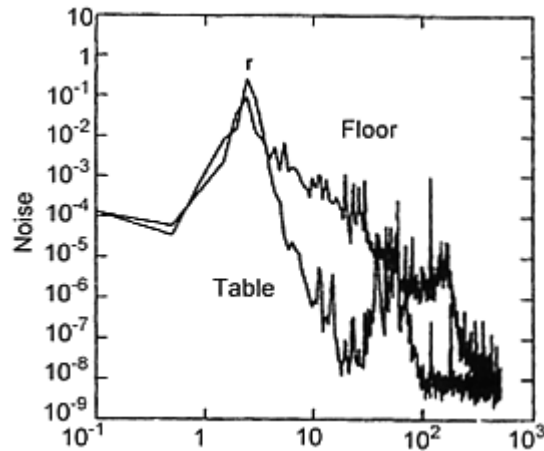


With correction in the x-direction

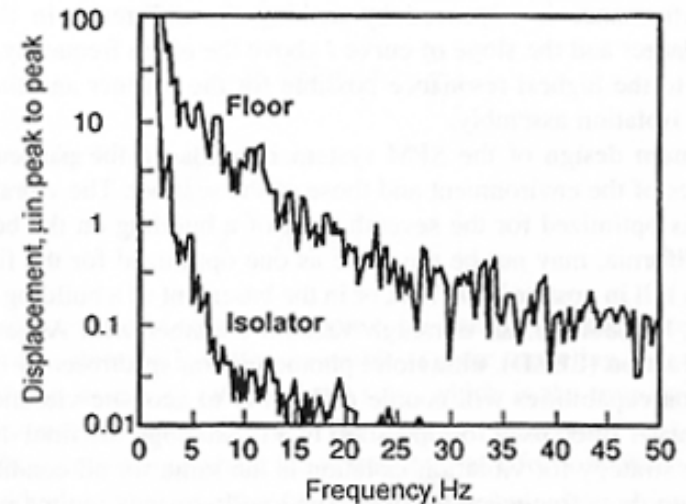
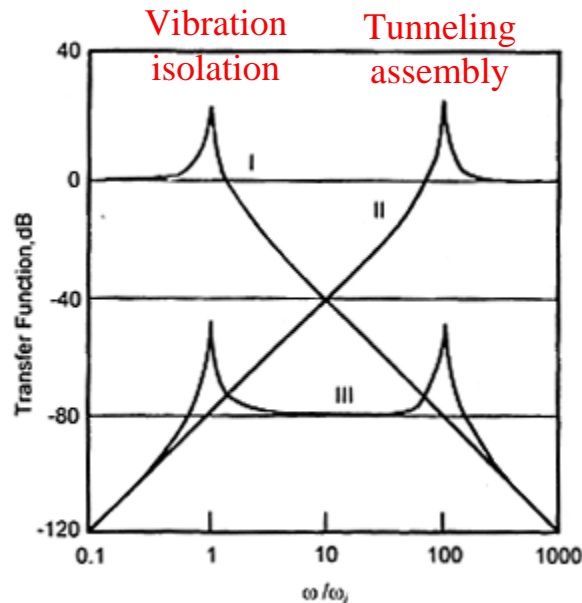
Jap. J. of Appl. Phys. **45**, 3B, 1917-1921.

# Vibration Isolation

## Power spectra of a tunneling signal



Calculated  
transfer  
function



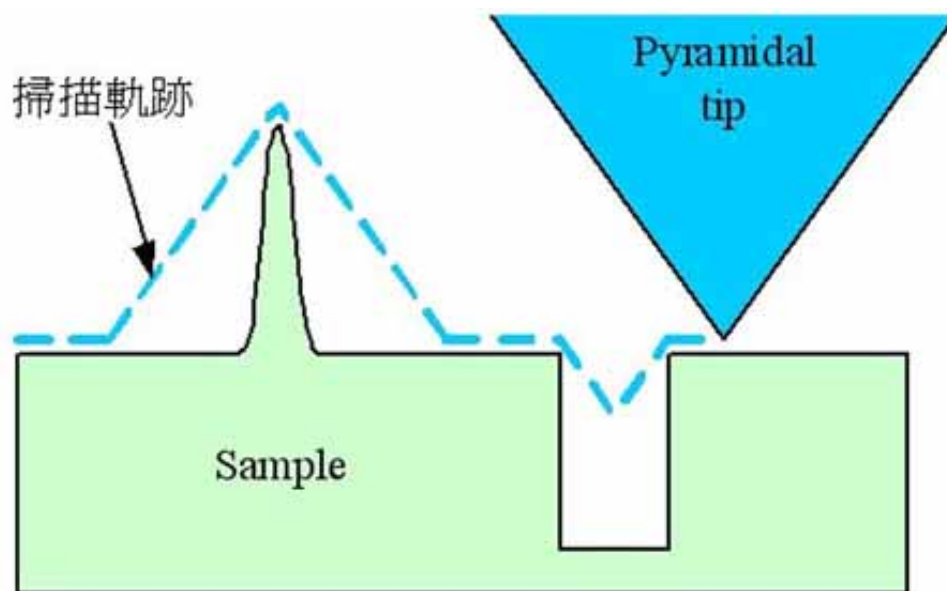
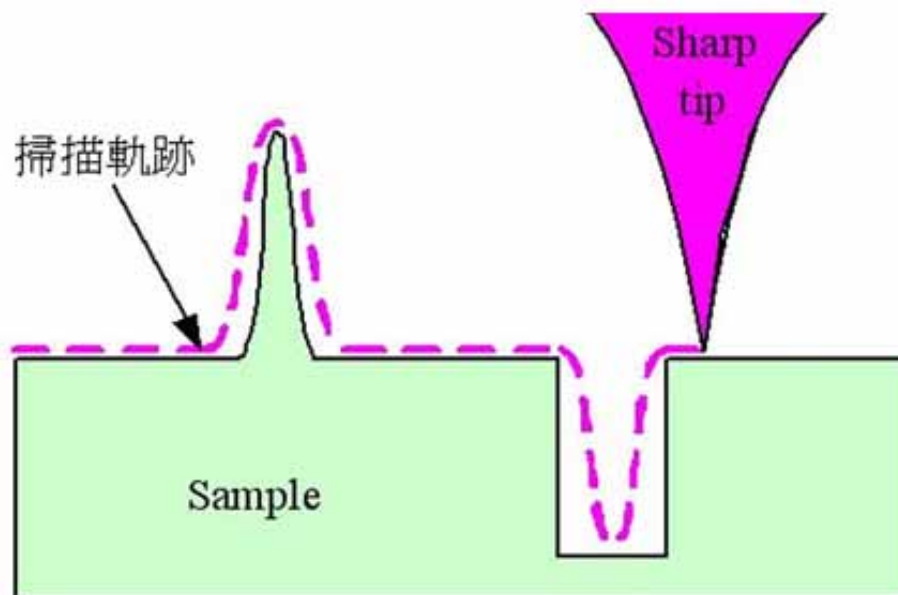
# Vibration Isolation

Requirement in vibrational noise:  $< 0.01\text{\AA}$  in z, and  $< 0.1\text{\AA}$  in x and y.

1. Building vibrations 5-100 Hz.
2. Acoustic noise 10-10k Hz
3. Table/chamber resonances 30-100 Hz
4. The design strategy is to reduce the resonance frequency of the vibration isolation system as low as possible, increase the resonance frequency of the tunneling assembly.
5. An effective way to damp the low-frequency vibrations is to suspend the microscope on long tension wires or levitate the table/chamber system on air legs. The performance can further be improved by increasing the mass of the system.
6. The microscope itself can be suspended with tension spring.
7. Vibrations in the medium-frequency can be damped by mounting the scanner assembly on a stack of materials of different elastic moduli or to suspend the scanner on tension springs with eddy current damping.

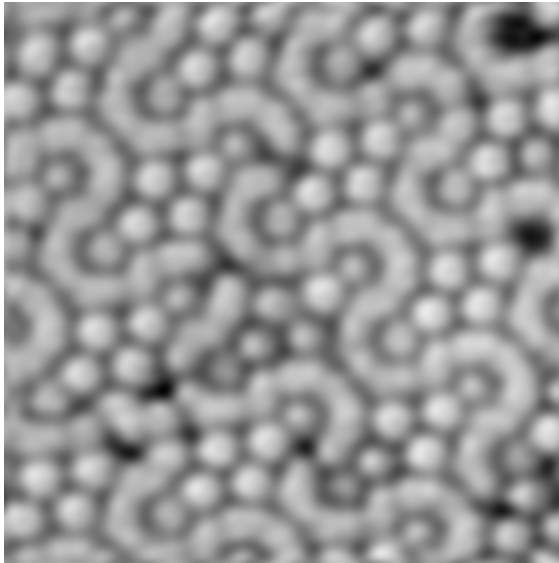


# Tip Shape Effects

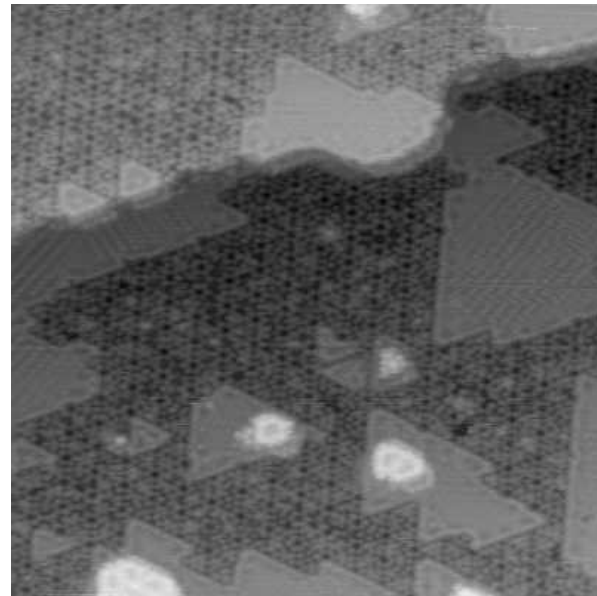
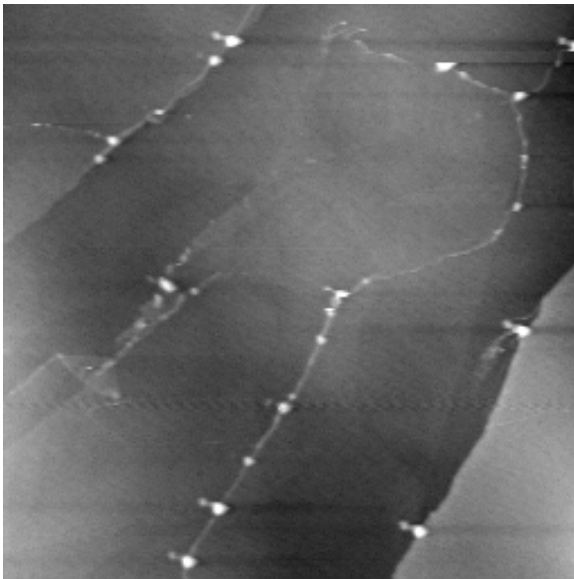
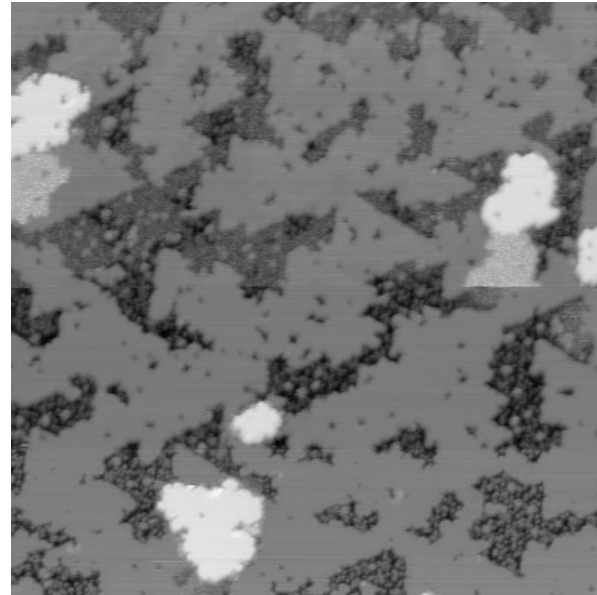


# Artifacts of the Tip

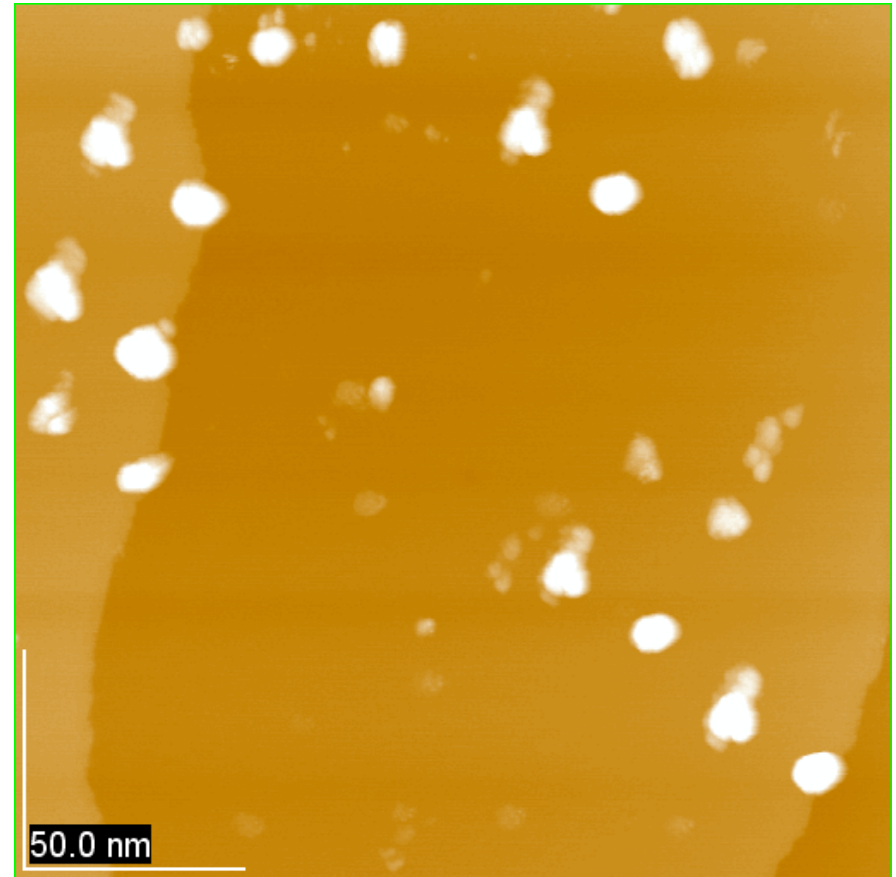
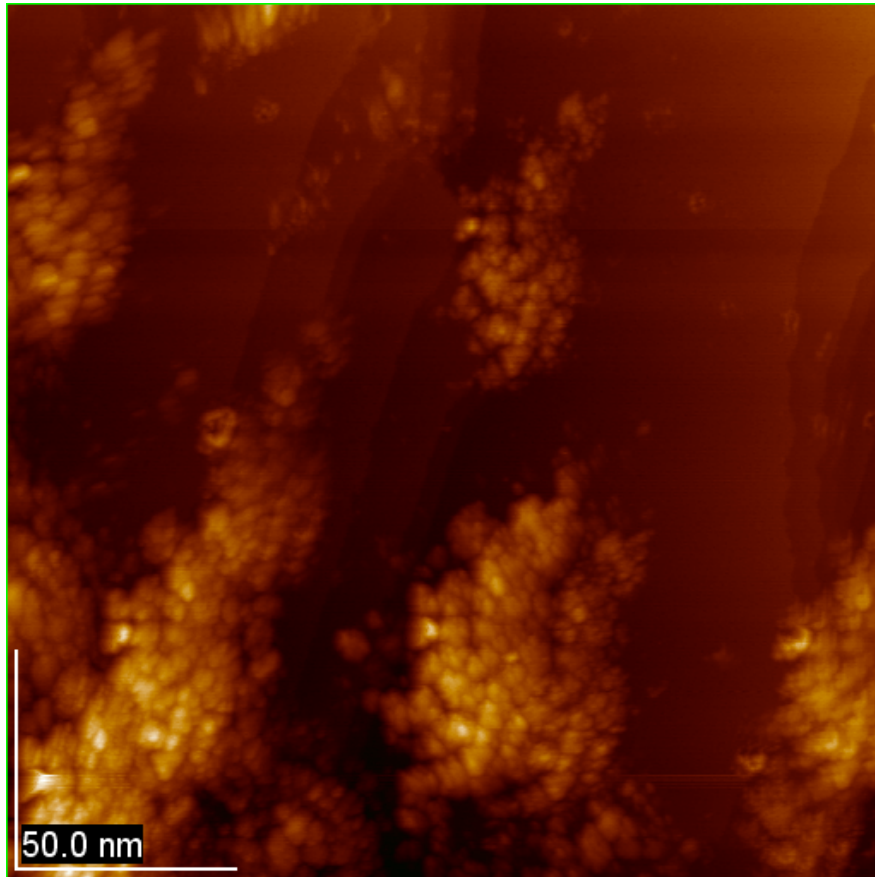
Si(111)-(7x7)



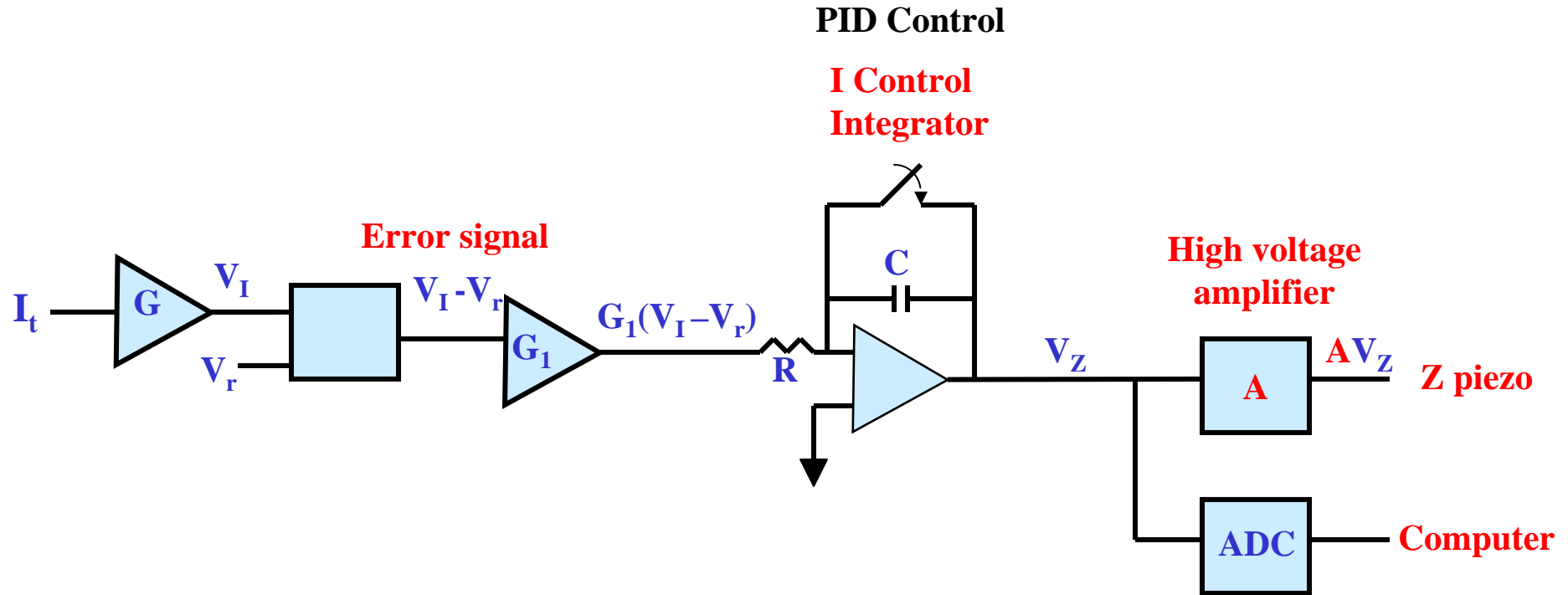
Pb/Si(111)



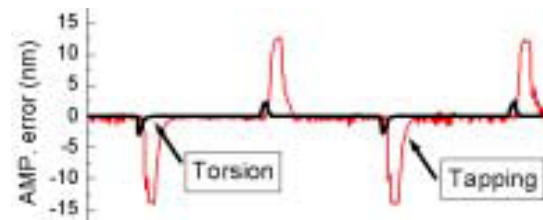
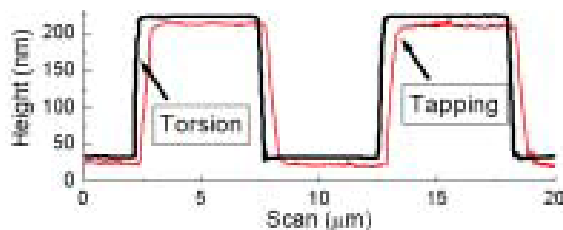
## Artifacts of the Tip



# STM Feedback Control



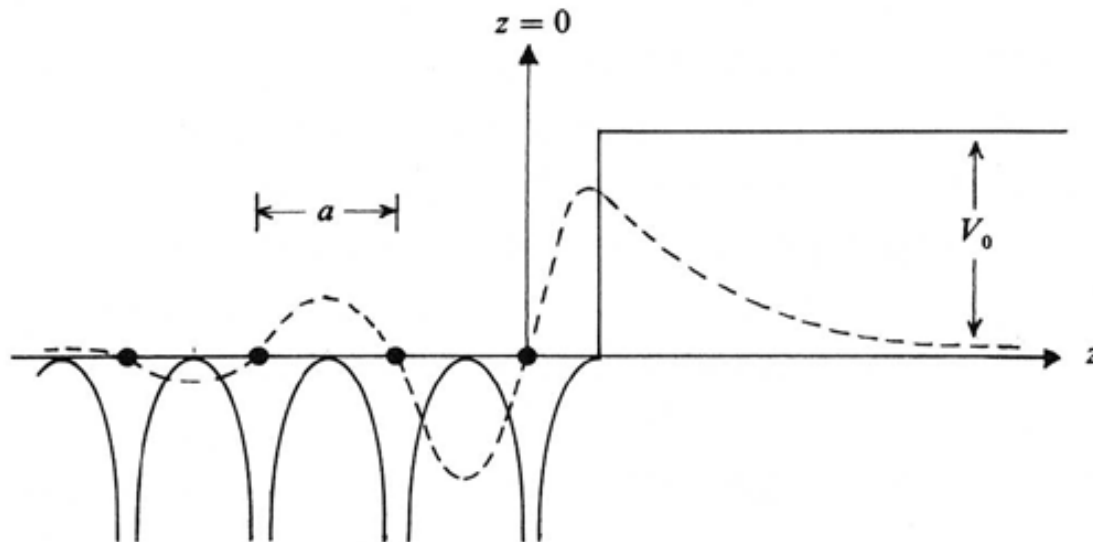
1. When values of the gain are too high, feedback oscillations may occur; when values are too low, details can be lost due to slow reaction of the feedback.
2. Use of high integral and proportional gains can reduce the error signal, but it increases the noise level in the feedback loop and in the height data.



# Electronic Surface States

- \* Many macroscopic effects and phenomena on surfaces are related to the change in electronic structure.
  - \* The electronic structure near to the surface is markedly different from that in the bulk.
1. An ideal surface with its atoms at bulk-like positions (called truncated bulk) displays new electronic levels --- the periodicity perpendicular to the surface breaks down.
  2. Surface relaxations and reconstructions frequently occur.

One-dimensional semi-infinite lattice model potential (solid curve) and an associated surface state (dashed curve).

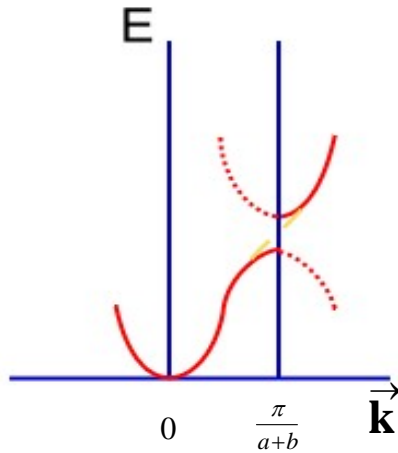


- A. Electrons in surface states are localized within a few  $\text{\AA}$  of the surface plane.
- B. Some electronic surface states may be located somewhere in the gap of the bulk states.

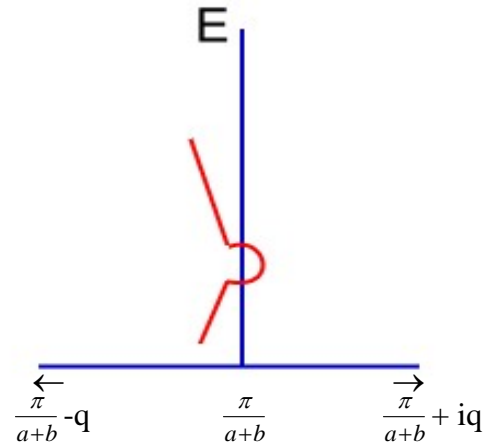
# Surface States

1. Impurities, defects, etc.
2. Termination of periodic arrangement

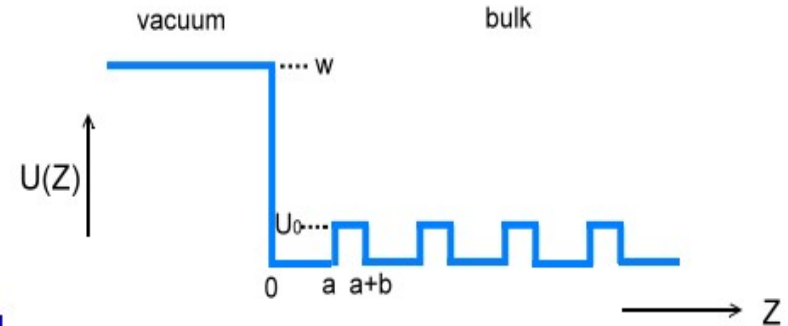
Tamm's model --- modified Kronig-Penney model



One-dimensional periodic potential of lattice constant  $a+b$  (Kronig-Penney)



Tamm's model

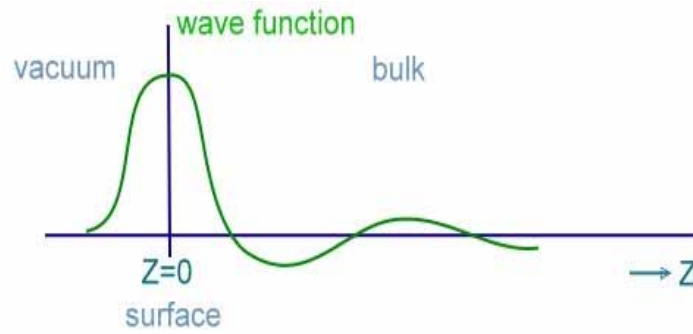


Bloch form  $\varphi(z) = e^{ikz} u(z) = e^{i\frac{\pi}{a+b}z} e^{-qz} u(z)$

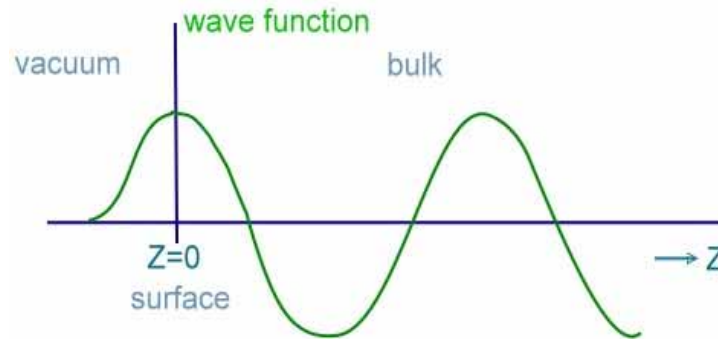
The surface states are localized near the surface ( $z=0$ ).

# Coupling between Surface States and Bulk states

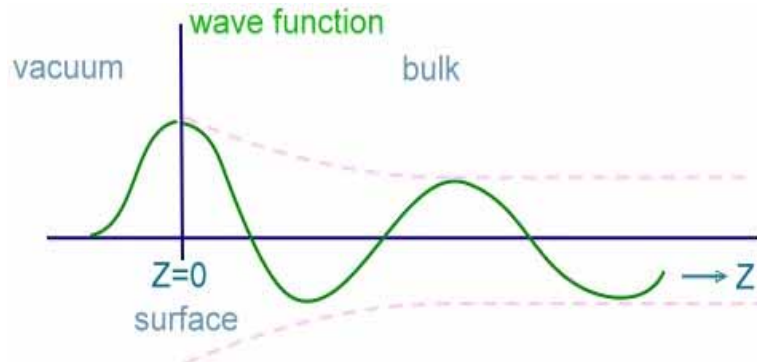
## 1. A surface state



## 2. A bulk state

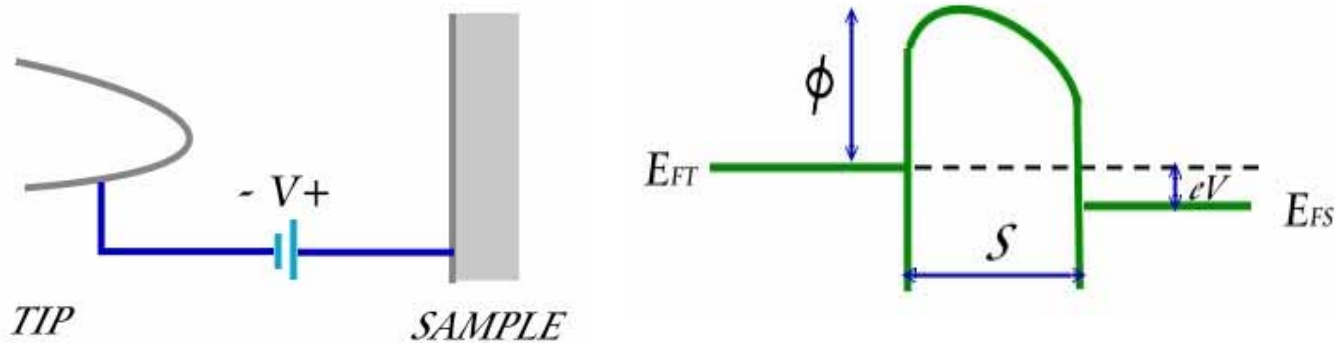


## 3. A quasi-stationary surface which resonates with the bulk continuum





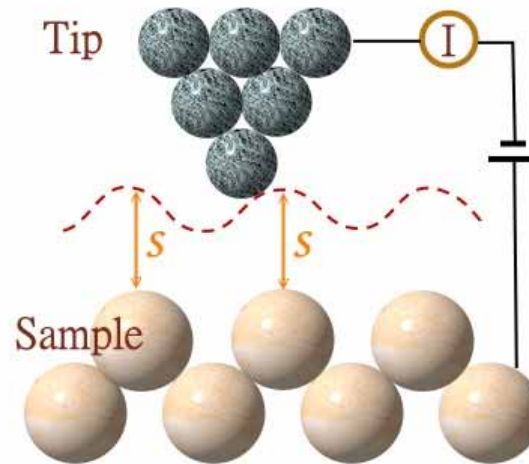
# Theory of STM



From one-dimensional tunneling problem  
tunneling current ( $eV \ll \phi$ )

$$I \propto \frac{V}{S} \exp\left(-A\phi^{\frac{1}{2}}S\right)$$

$$A = 1.025(eV)^{-\frac{1}{2}} \text{ \AA}^{-1}$$



*Constant Current Mode*

# Tunneling Current

$$I_{T \rightarrow S} = \frac{2\pi e}{\hbar} \sum_{\mu\nu} f(E_\mu) [1 - f(E_\nu + eV)] |M_{\mu\nu}|^2 \delta(E_\mu - E_\nu - eV)$$

where  $f(E)$  is Fermi function

$E_\mu$  is the energy of state  $\mu$ , where  $\mu$  and  $\nu$  run over all the states of the tip and surface, respectively.

$M_{\mu\nu}$  is tunneling matrix element

$$M_{\mu\nu} \equiv \frac{\hbar^2}{2m} \int d\vec{s} (\psi_\mu^* \nabla \psi_\nu - \psi_\nu \nabla \psi_\mu^*)$$

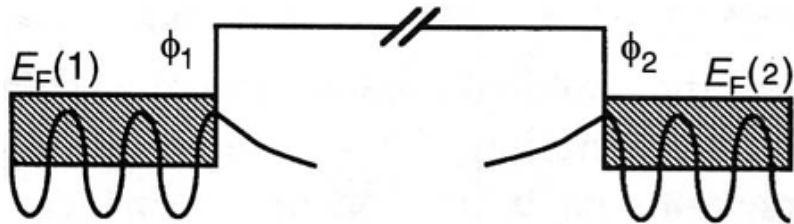
where  $\psi_\mu$  is the wave function, and the integral is over any plane in the barrier region.

$$\begin{aligned} I &= I_{T \rightarrow S} - I_{S \rightarrow T} \\ &= A' \int_{-\infty}^{\infty} \rho_T(E) \rho_S(E + eV) |M(E)|^2 [f(E) - f(E + eV)] dE \end{aligned}$$

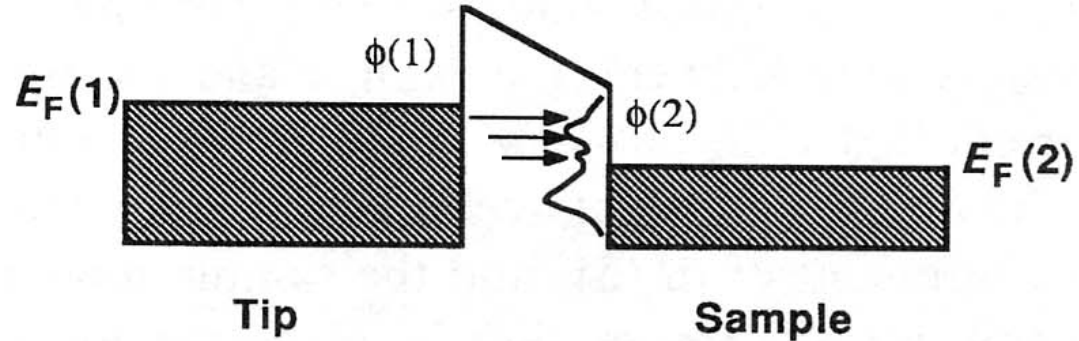
where  $\rho_S$  and  $\rho_T$  are the densities of states in the sample and the tip, respectively.

# Electronic Structures at Surfaces

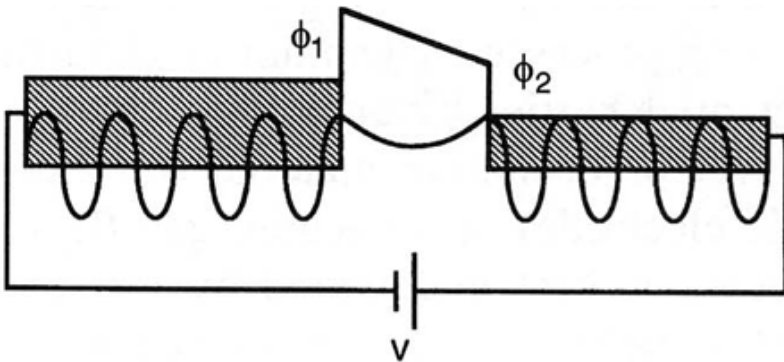
Not Tunneling



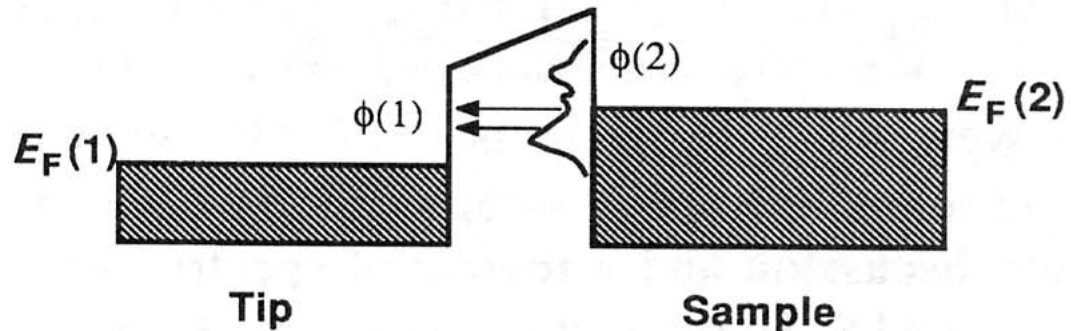
Empty-State Imaging



Tunneling



Filled-State Imaging



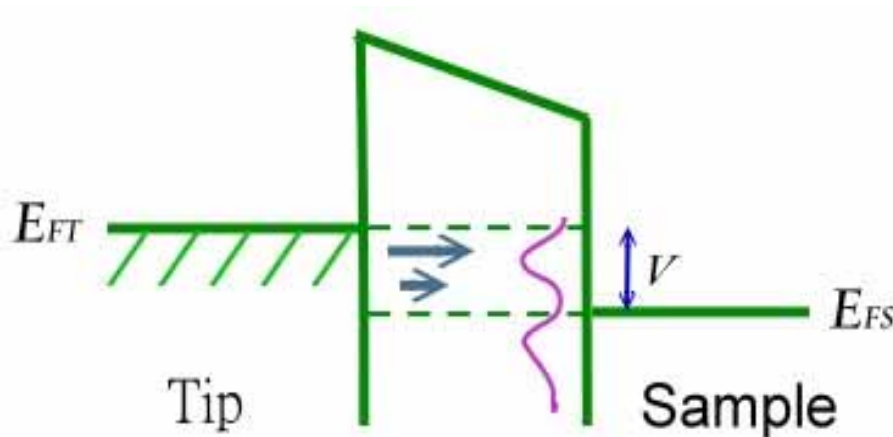
# Tunneling Current

$$I \equiv A' \int_{-\infty}^{\infty} \rho_T(E) \rho_S(E + eV) |M(E)|^2 [f(E) - f(E + eV)] dE$$

Transmission probability of the electron

$$M(E) = \exp \left[ - A \phi^{\frac{1}{2}} S \right]$$

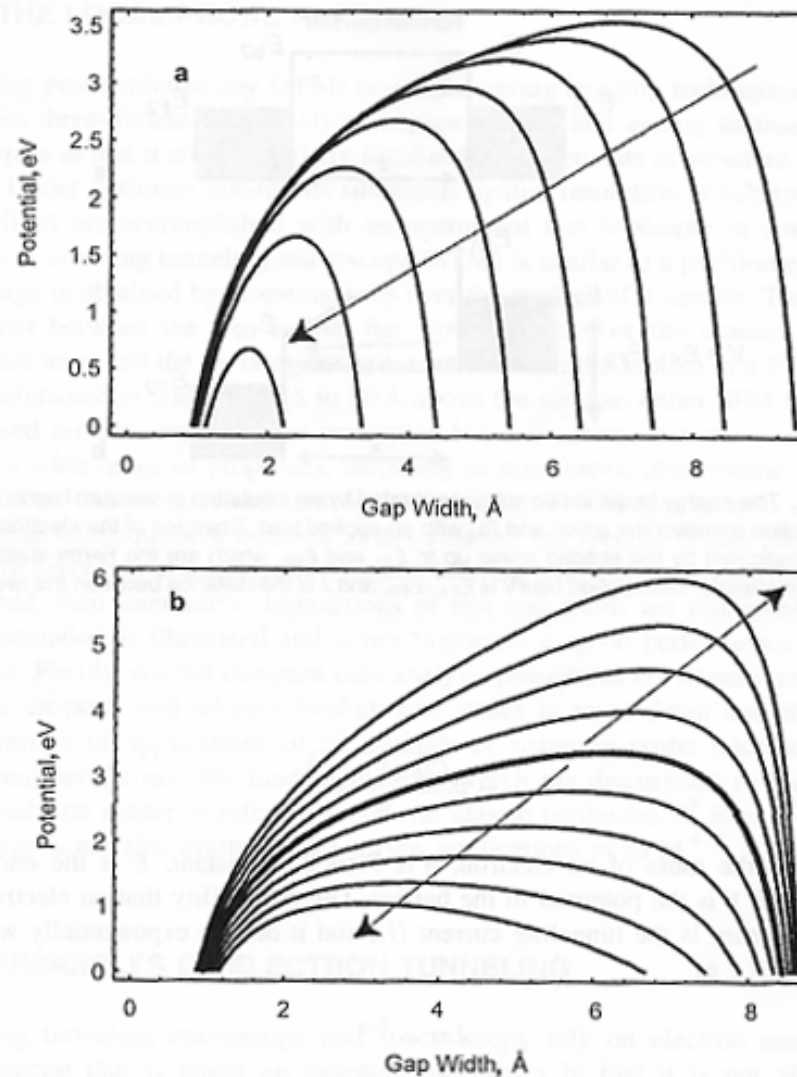
Usually, we assume  $\rho_T$  is featureless (ie.  $\rho_T \approx \text{const.}$ ), and the sample electronic states dominate the tunnel spectra.



However, the tips might have effect on the tunnel spectra, if

1. we have atomically sharp tips ,or
2. the tip has picked up a foreign atom.

# Tunneling Barrier



**Figure 2.2.** A more realistic depiction of the tunneling barrier, including the effect of image charge on the shape of the barrier. **a**, As the distance between the solids is decreased (arrow), the size and shape of the barrier change. **b**, The barrier also changes when a voltage is applied, the arrows show the response to opposite signs of bias.<sup>25</sup>

## Case I -----metals

In the low-voltage limit

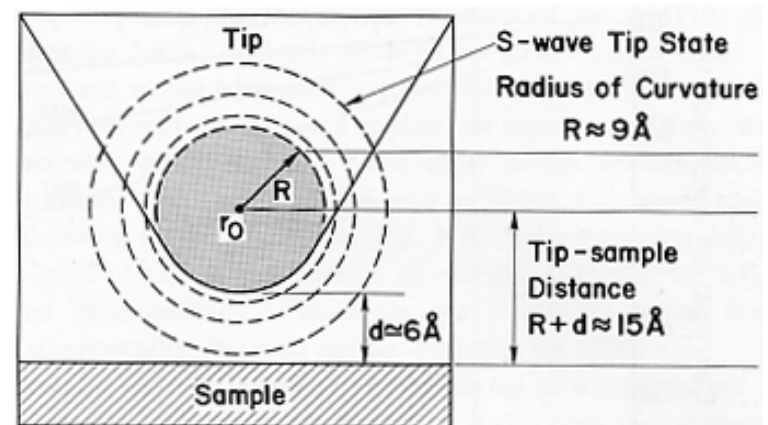
$$I \propto V \rho_S(\tilde{r}_t; E_F) \rho_t(E_F)$$

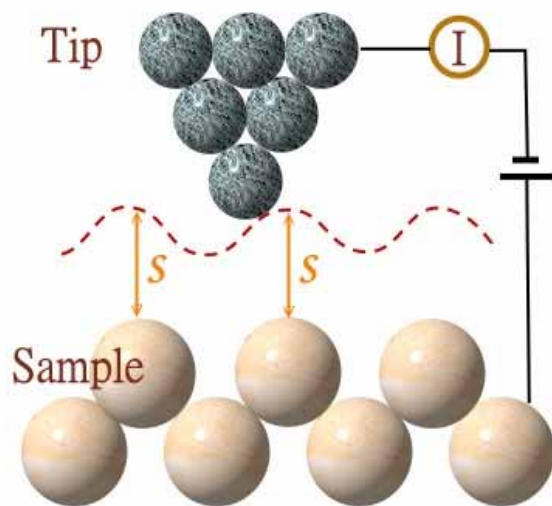
where  $\rho_S(\tilde{r}_t; E_F)$  is the surface density of states of the sample at the center of the tip( $\tilde{r}_t$ ),

$$\rho_S(\tilde{r}; E) \equiv \sum_v |\psi_v(\tilde{r})|^2 \delta(E_v - E)$$

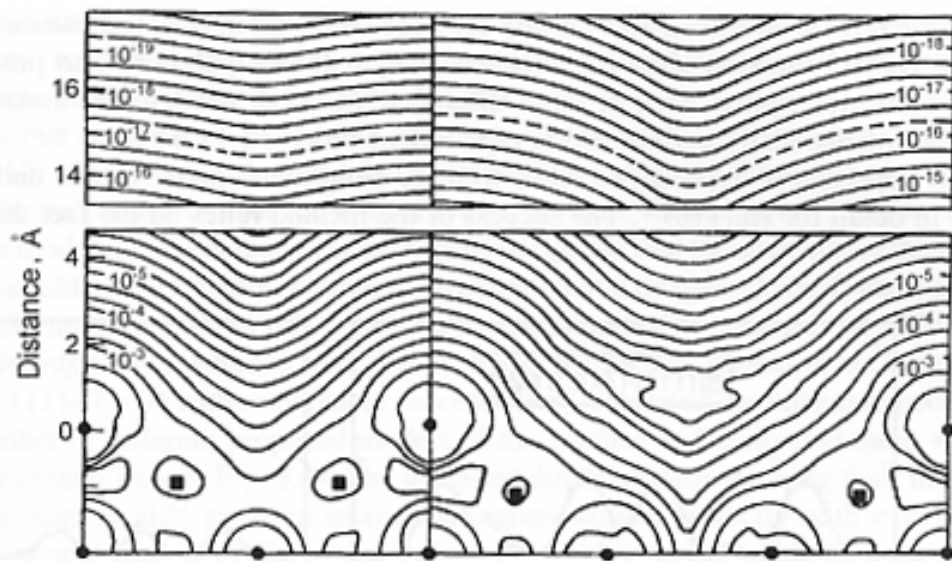
$\rho_t(E_F)$  is the density of states of the tip at the Fermi level and is often regarded as a constant.

The contour followed by the tip is a contour of constant Fermi-level density of states of the sample, measured at the center of curvature of the tip.





*Constant Current Mode*

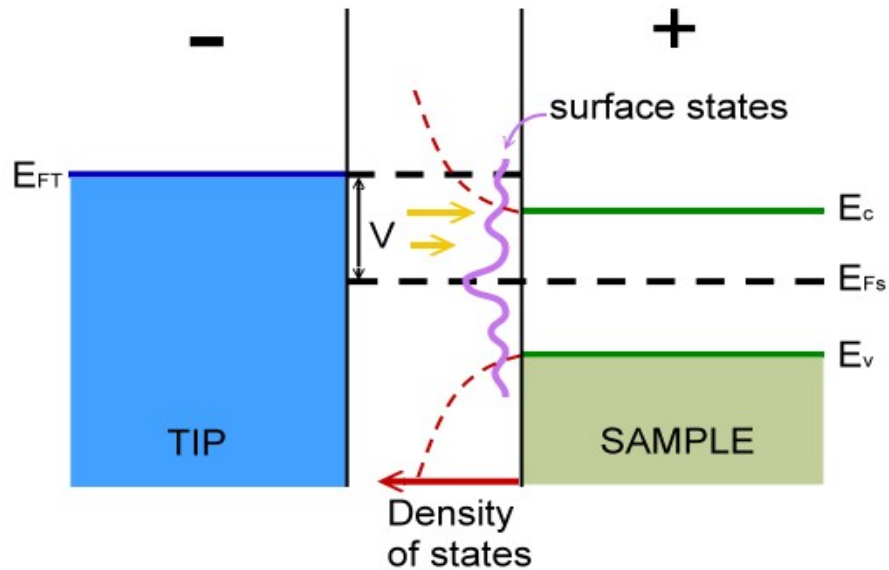


**Figure 3.3.** Calculated  $\rho(r, E_F)$  for Au (110)-(2  $\times$  1) (left) and (3  $\times$  1) (right) surfaces. The figure shows the (110) plane through outermost atoms. Positions of nuclei are indicated by *solid circles* (in plane) and *solid squares* (out of plane). Contours of constant  $\rho$  are labeled in units of  $\text{a.u.}^{-3} \text{eV}^{-1}$ . Note the break in the vertical distance scale. Assuming a 0.9-nm tip radius in the *s*-wave tip model, the center of curvature of the tip is calculated to follow the dashed line. (Reprinted with

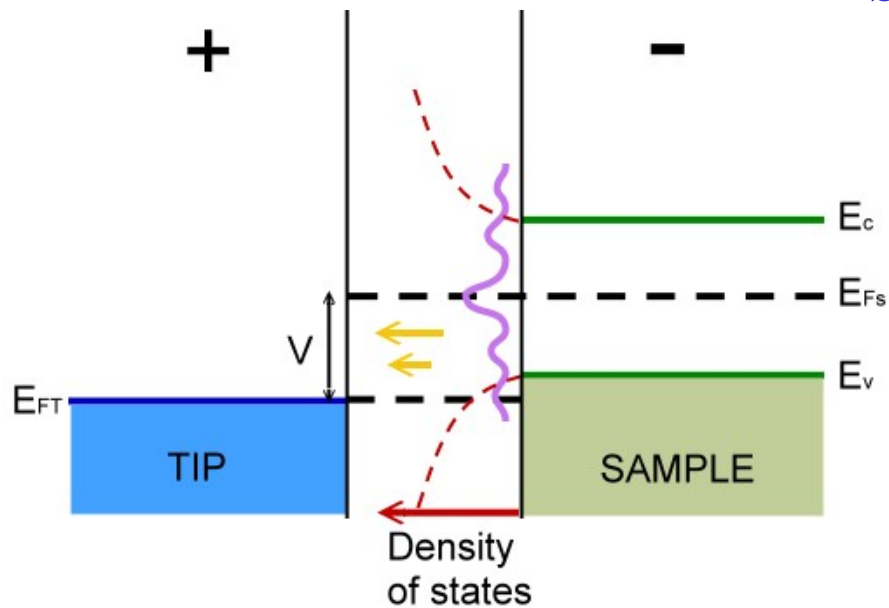


# Example -----Semiconductor

## 1. Tip-negative



## 2. Tip -positive



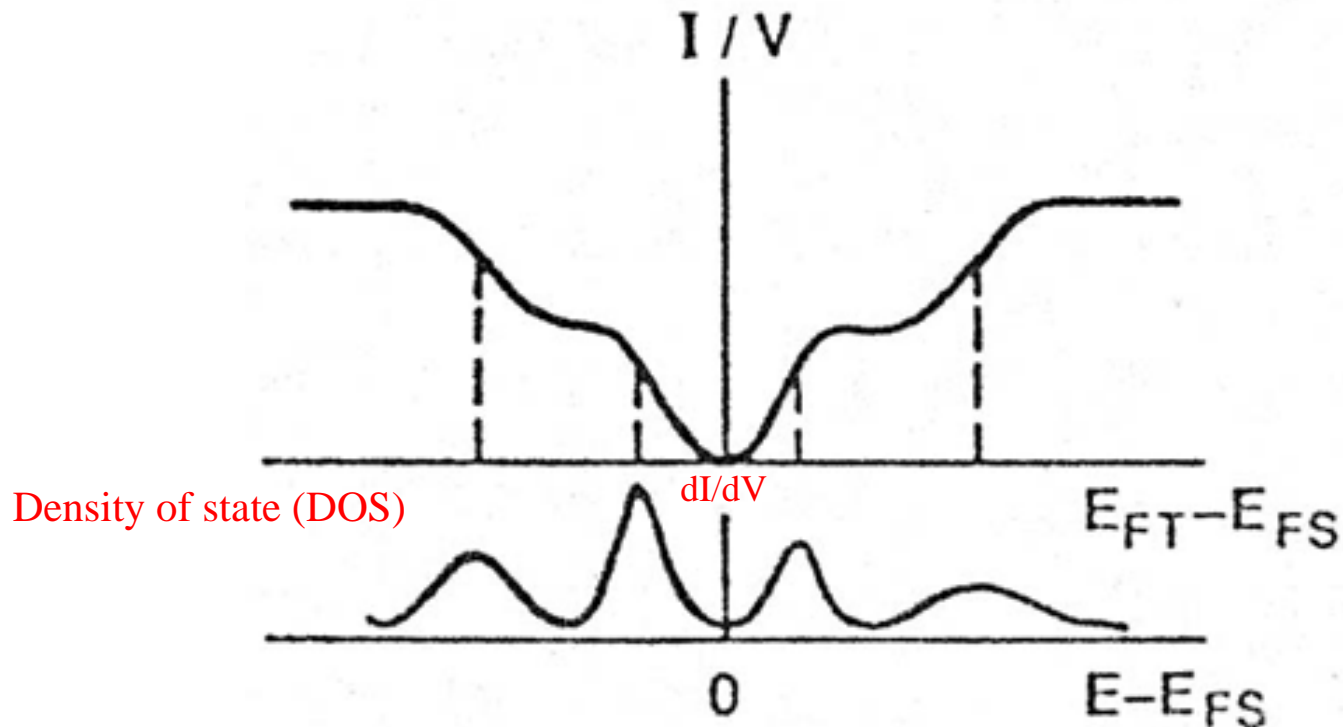
Science **234**, 304 (1986).

# Scanning Tunneling Spectroscopy

STM provides atomic-scale topographic information, and atomic-scale electronic information. However, the mixture of geometric and electronic structure information often complicates interpretation of observed feature.

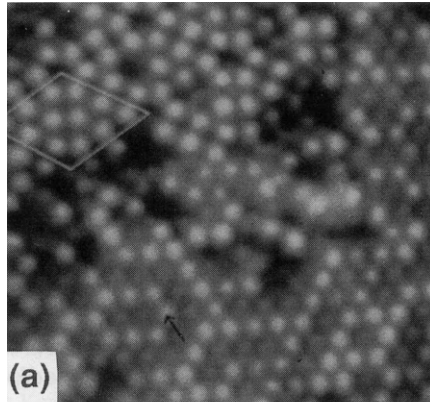
**Several spectroscopic modes:**

1. Voltage-dependent STM imaging.
2. Tunneling I-V curves,  $dI/dV$ .

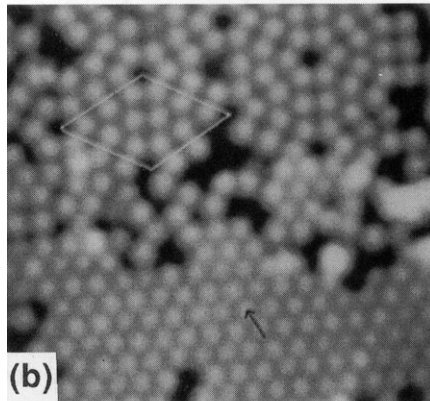


# Pb/Si(111)

+1.8 V

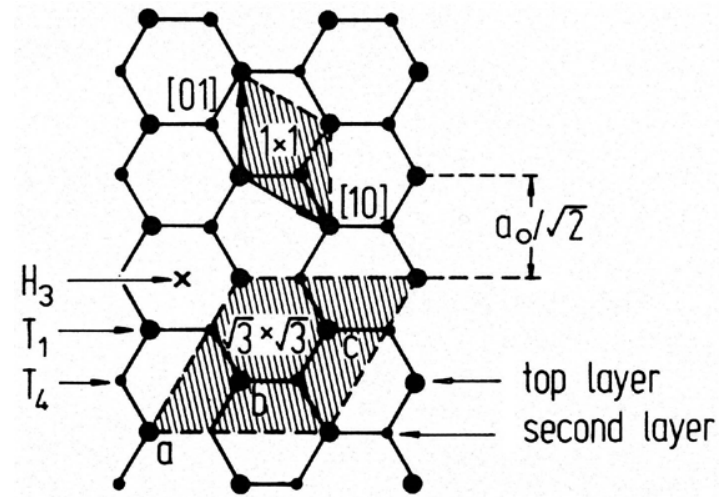
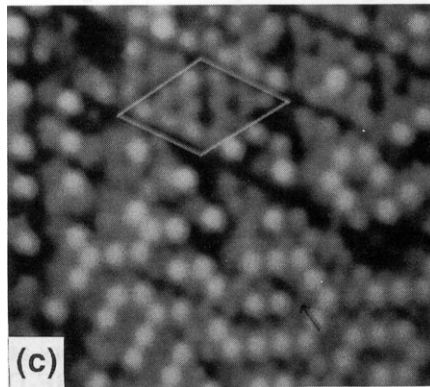


+2.4 V

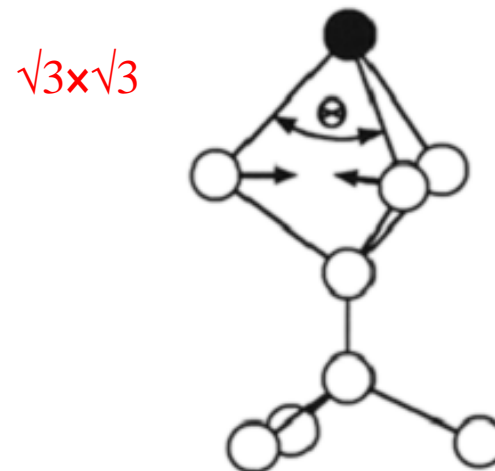


-1.8 V

Filled-state



$T_4$  site

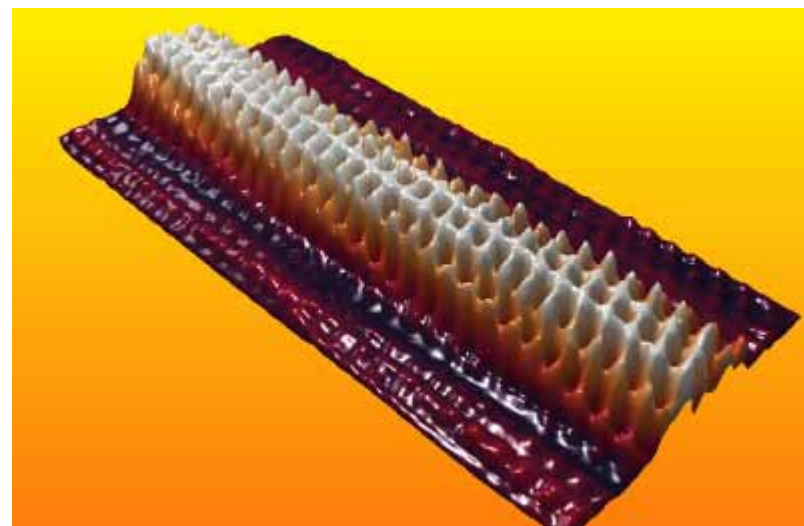
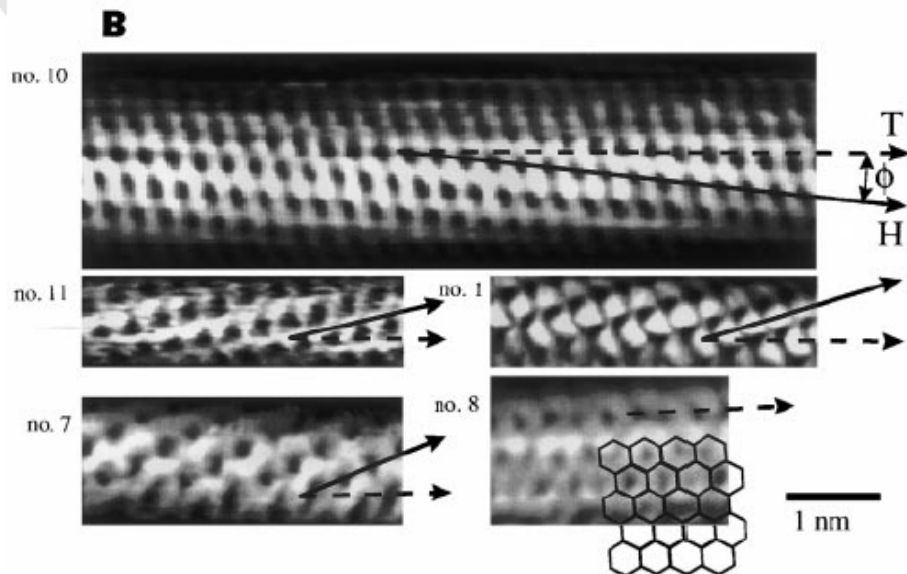
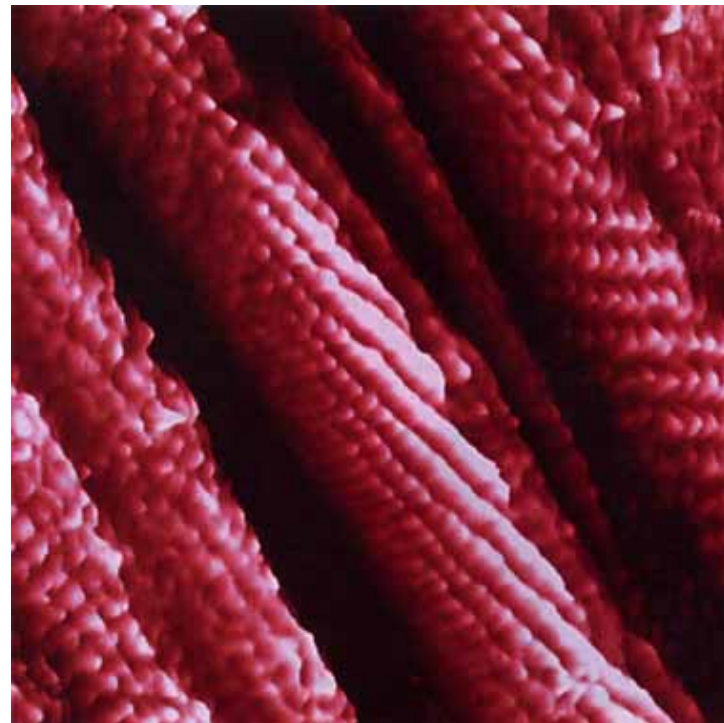
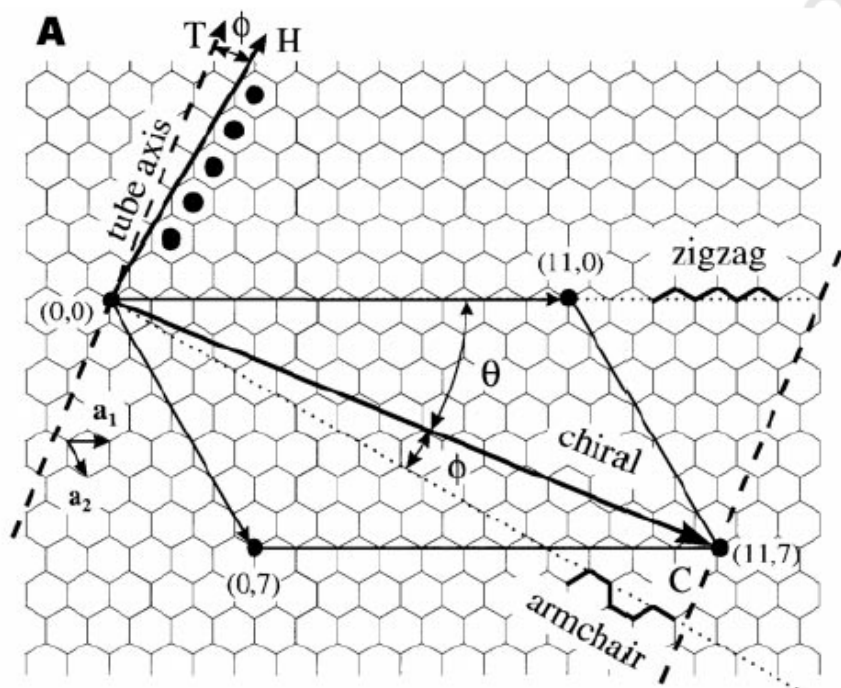


# Scanning Tunneling Spectroscopy (STS)

$$\frac{dI}{dV} = \rho_s(r, eV)\rho_t(r, 0)T(eV, eV, r) + \int_0^{eV} \rho_s(r, E)\rho_t(r, E - eV) \frac{dT(E, eV, r)}{dV} dE$$

1. The tunneling transmission probability  $T$  is a smooth, monotonically increasing function of  $V$ . Thus  $dT/dV$  contributes a smooth background. Therefore, structure in  $dI/dV$  can usually be assigned to changes in the state density.
2. Extracting quantitative information about the sample density of states is difficult because the density of states of the tip and the tunneling transmission probability  $T$  are almost unknown.
3. Normalization of  $dI/dV$  by  $I/V$  was proposed to minimize the distance dependence of the tunneling probability (or the voltage dependence of the tunneling barrier).

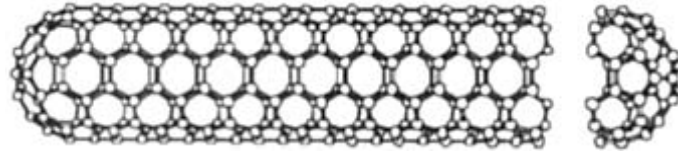
# Single-Wall Carbon Nanotubes



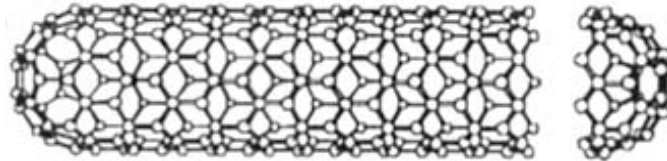


# Electronic Structure of Single-Wall Nanotubes

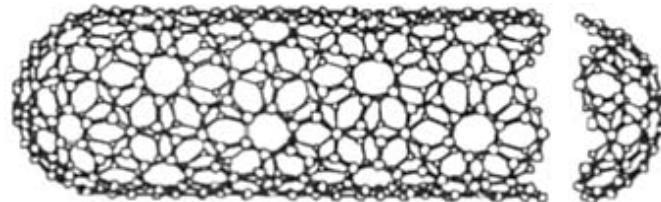
1. Armchair nanotubes  $(n,n) \rightarrow$  metallic



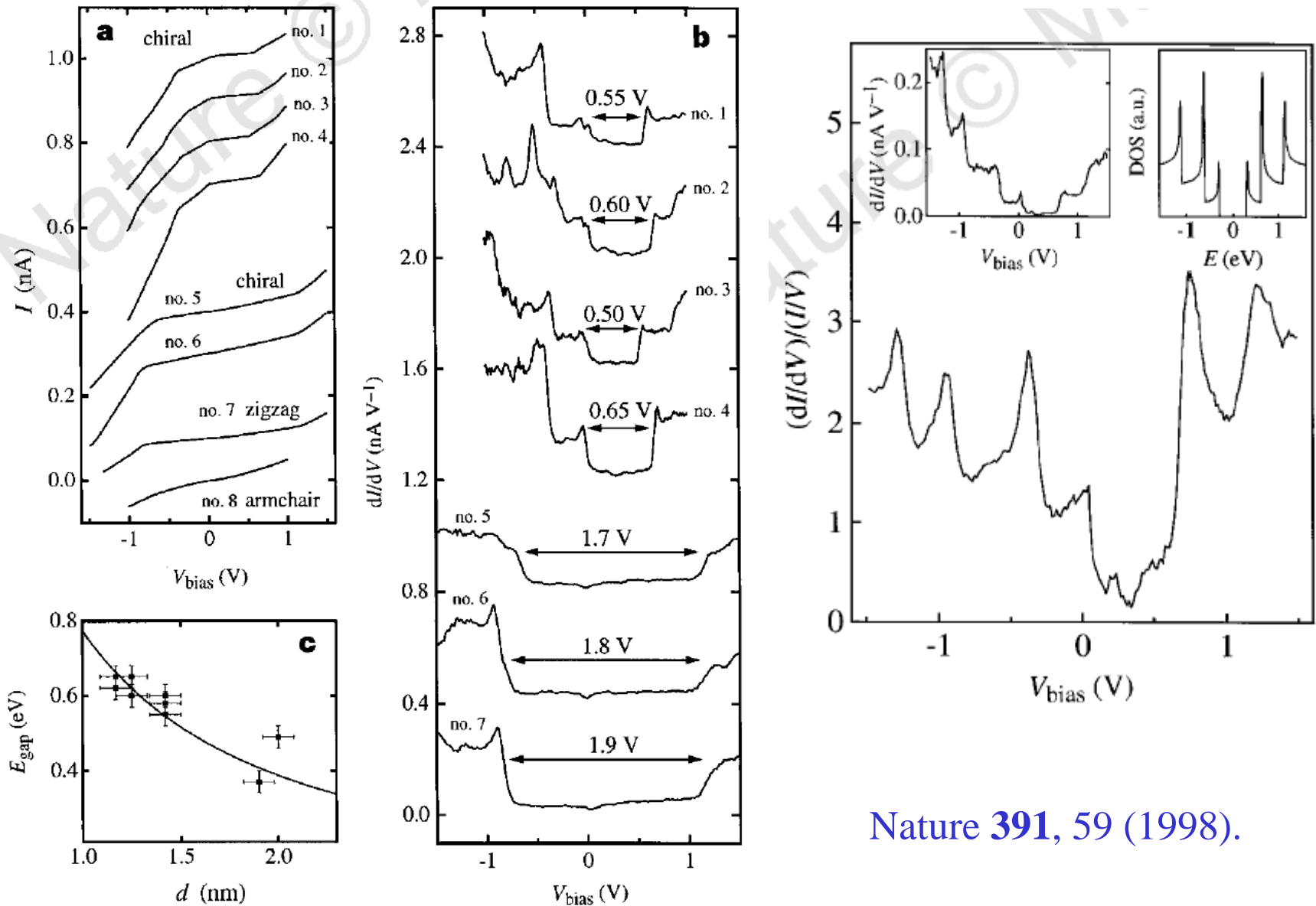
2. Zigzag nanotubes  $(n,0) \rightarrow$  metallic, when  $n=3q$   
 $\rightarrow$  semiconducting, otherwise



3. Chiral nanotubes  $(n,m) \rightarrow$  metallic, when  $m=n+3q$



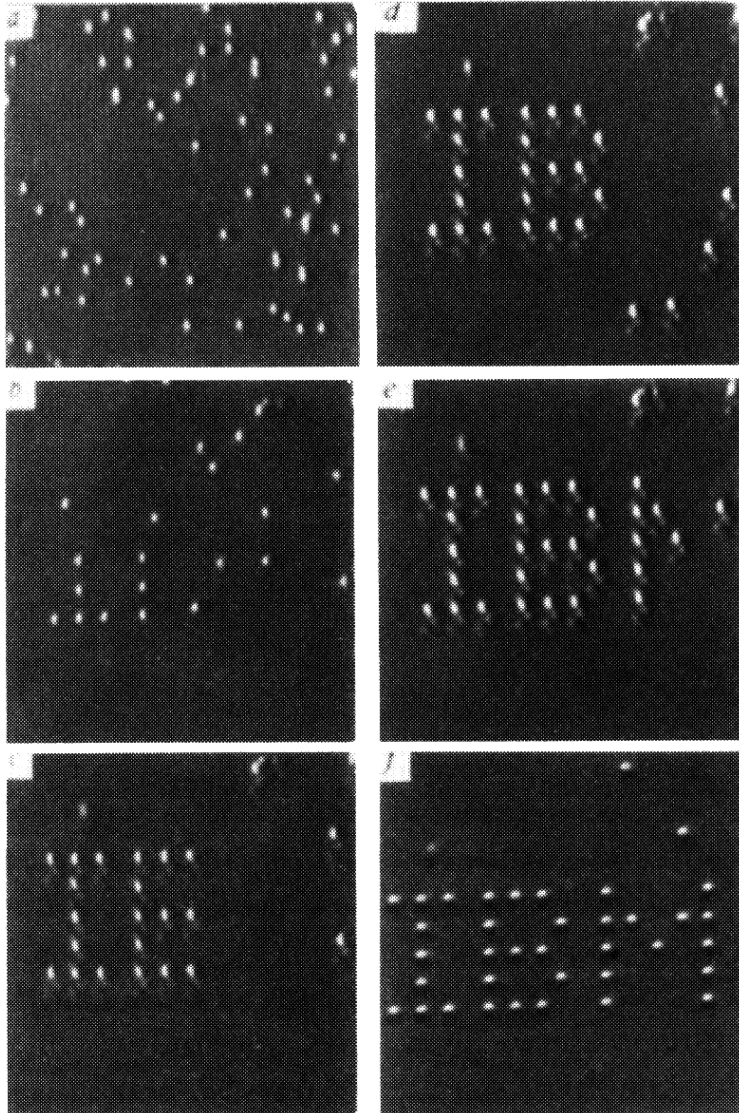
# Electronic Structure of Single-wall Nanotubes



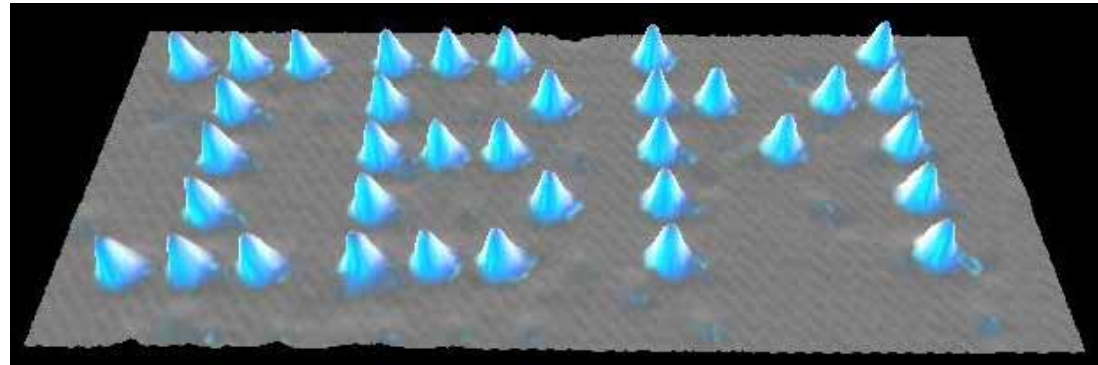
Nature **391**, 59 (1998).



# Atomic Manipulation with STM



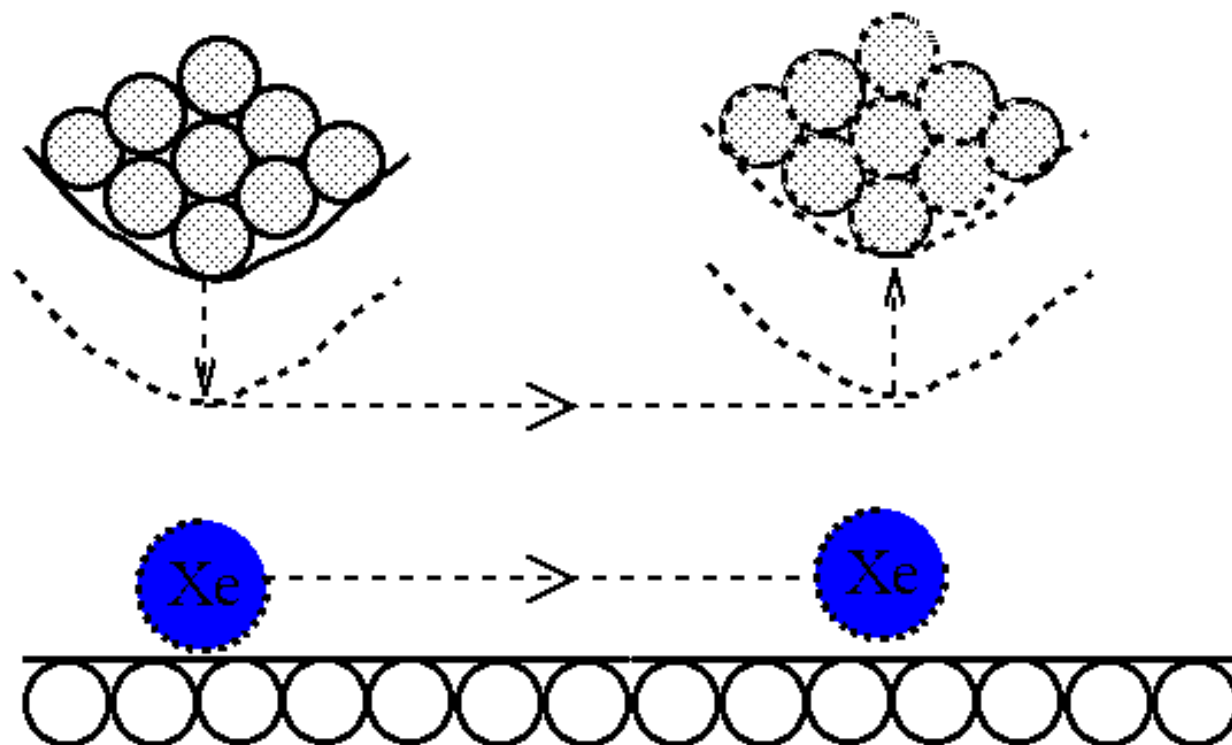
Nature **344**, 524 (1990)



Xe on a Ni surface

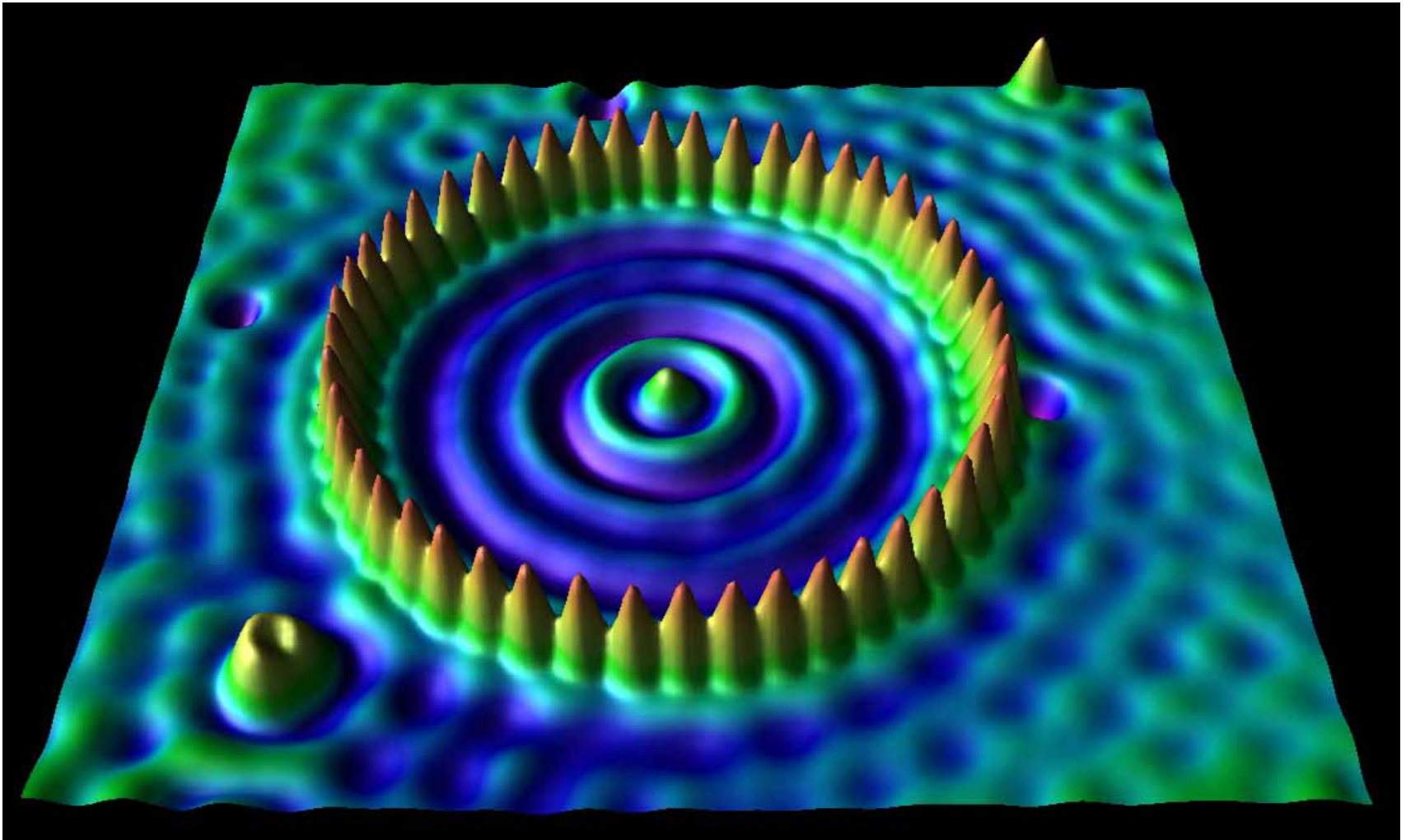
# Positioning Atoms with an STM

D.M. Eigler & E.K. Schweizer Nature **344** 524 (1990)



The STM tip is brought down near the atom, until the attraction is enough to hold it as the atom is dragged across the surface to a new position.

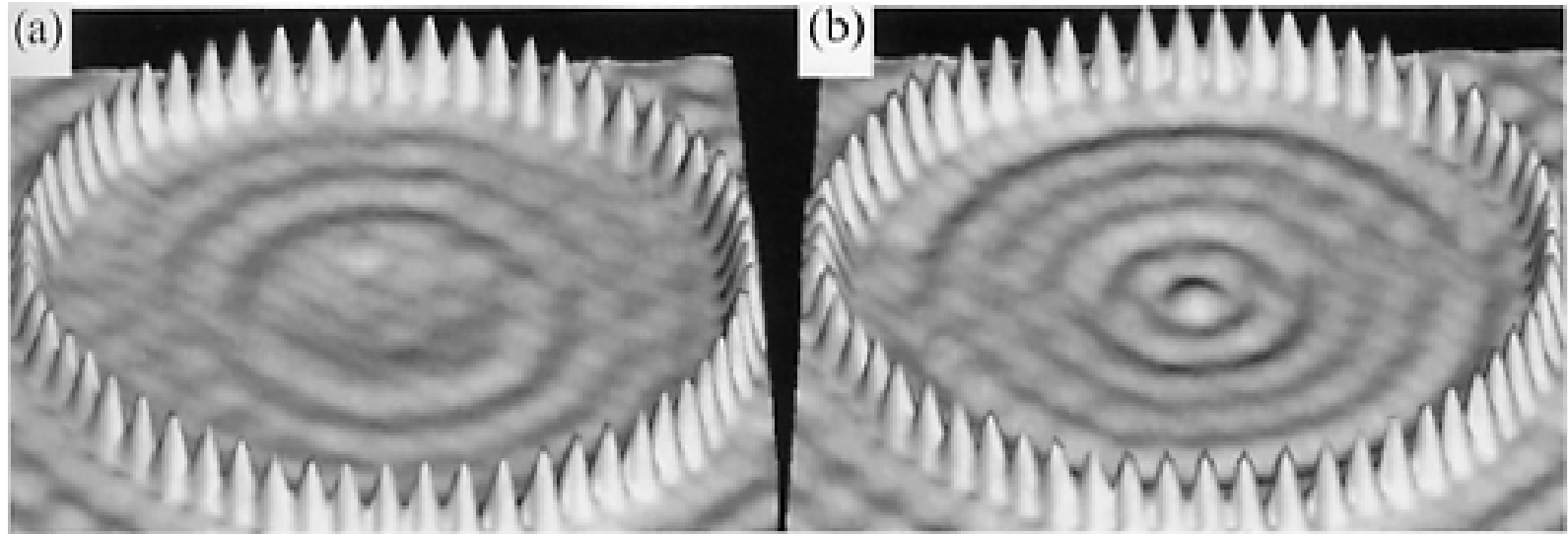
# Quantum Correl



M.F. Crommie *et al.*, *Science* 262, 218 (1993).

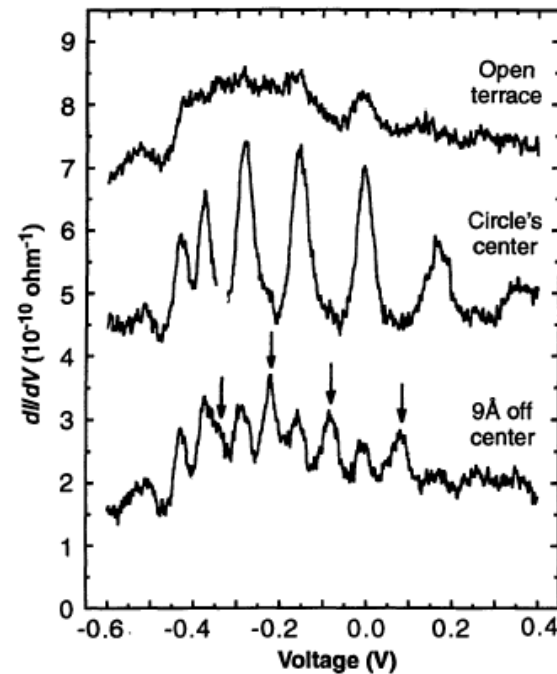


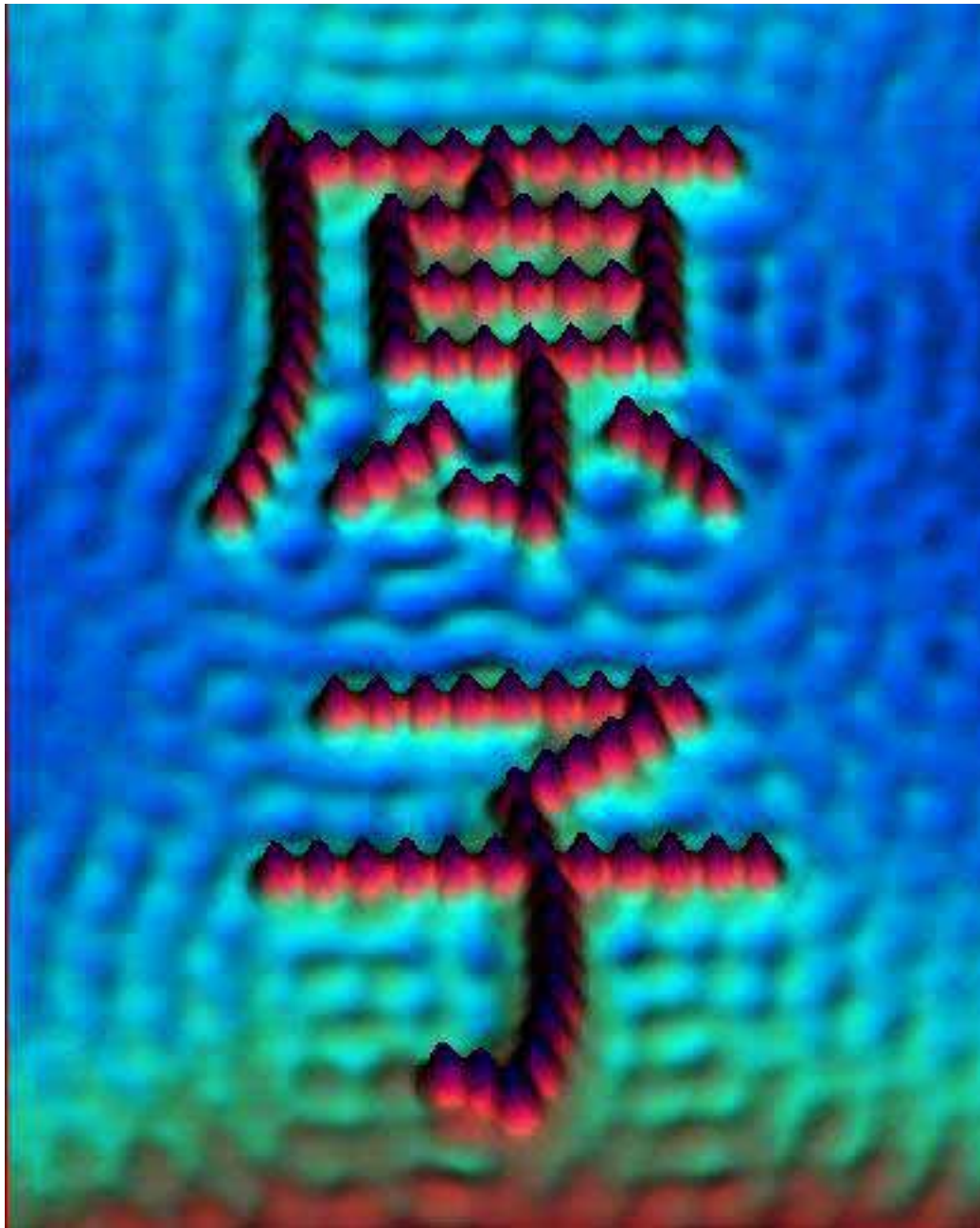
# Energy-Dependent Friedel Oscillations



$V_t = +10 \text{ mV}$

$V_t = -10 \text{ mV}$





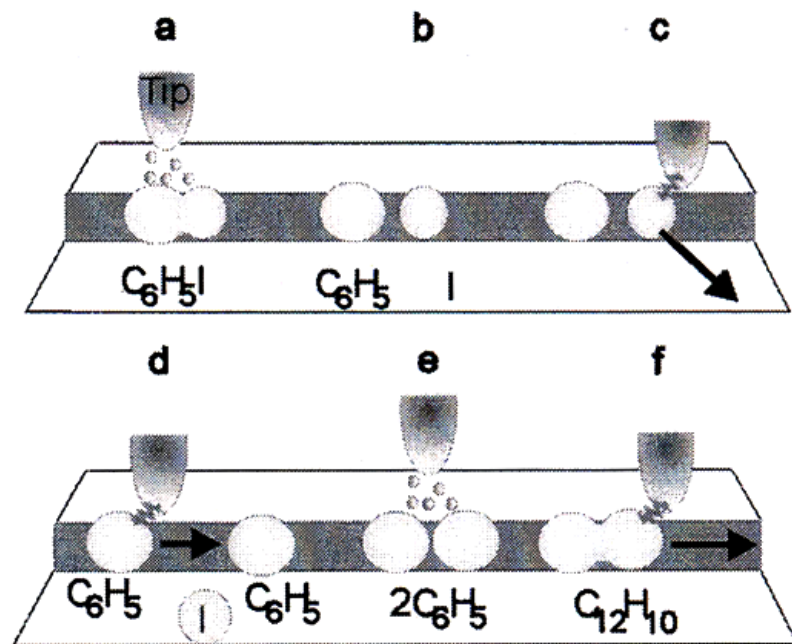
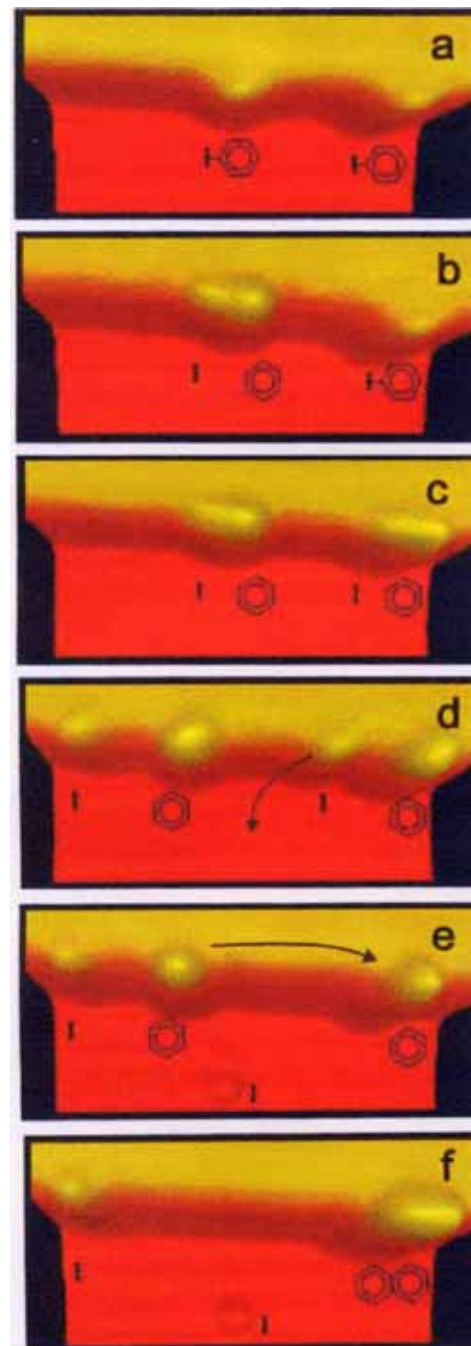
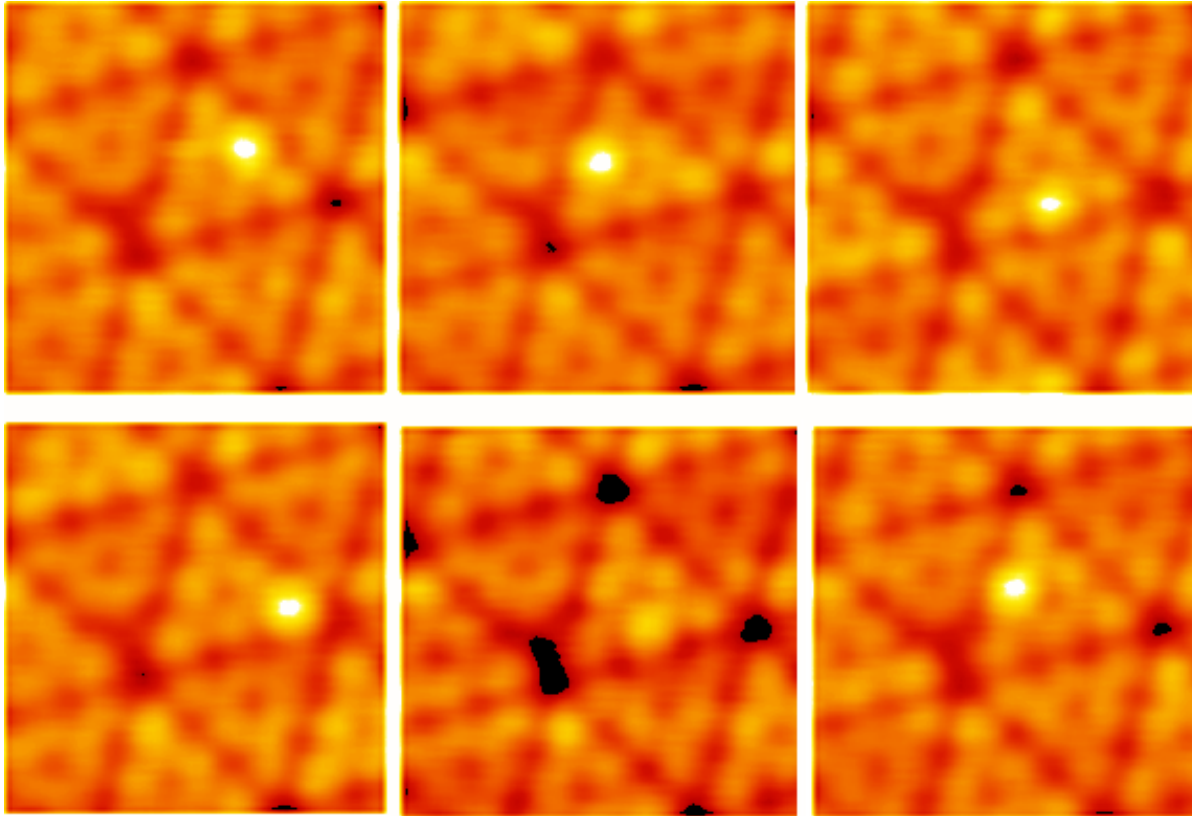


FIG. 1. Schematic illustration of the STM tip-induced synthesis steps of a biphenyl molecule. (a),(b) Electron-induced selective abstraction of iodine from iodobenzene. (c) Removal of the iodine atom to a terrace site by lateral manipulation. (d) Bringing together two phenyls by lateral manipulation. (e) Electron-induced chemical association of the phenyl couple to biphenyl. (f) Pulling the synthesized molecule by its front end with the STM tip to confirm the association.



Phys. Rev. Lett. 85, 2777 (2000)

## Site Hopping of O<sub>2</sub> on Si(111)-7x7



O<sub>2</sub> molecule starts to hop between neighboring adatom sites at temperature about 300°C.

1. I.-S. Hwang, R.-L. Lo, and T.T. Tsong, Physical Review Letters **78**, 4797 (1997).
2. I.-S. Hwang, R.-L. Lo, and T.T. Tsong, Surface Science **399**, 173 (1998).



# Arrhenius Plot for the Hopping from a Center Site to an Adjacent Center Site

Jumping rate  
 $R = N/t = R_0 \exp(-E_a/k_B T)$   
 Arrhenius relation

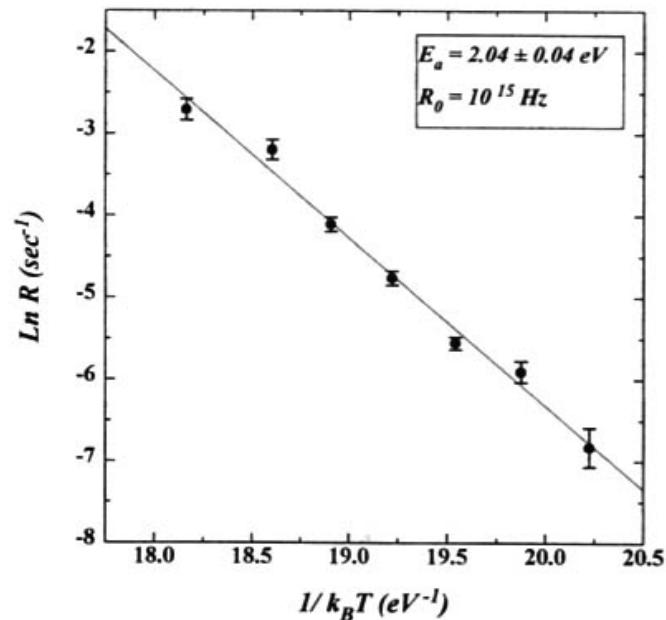
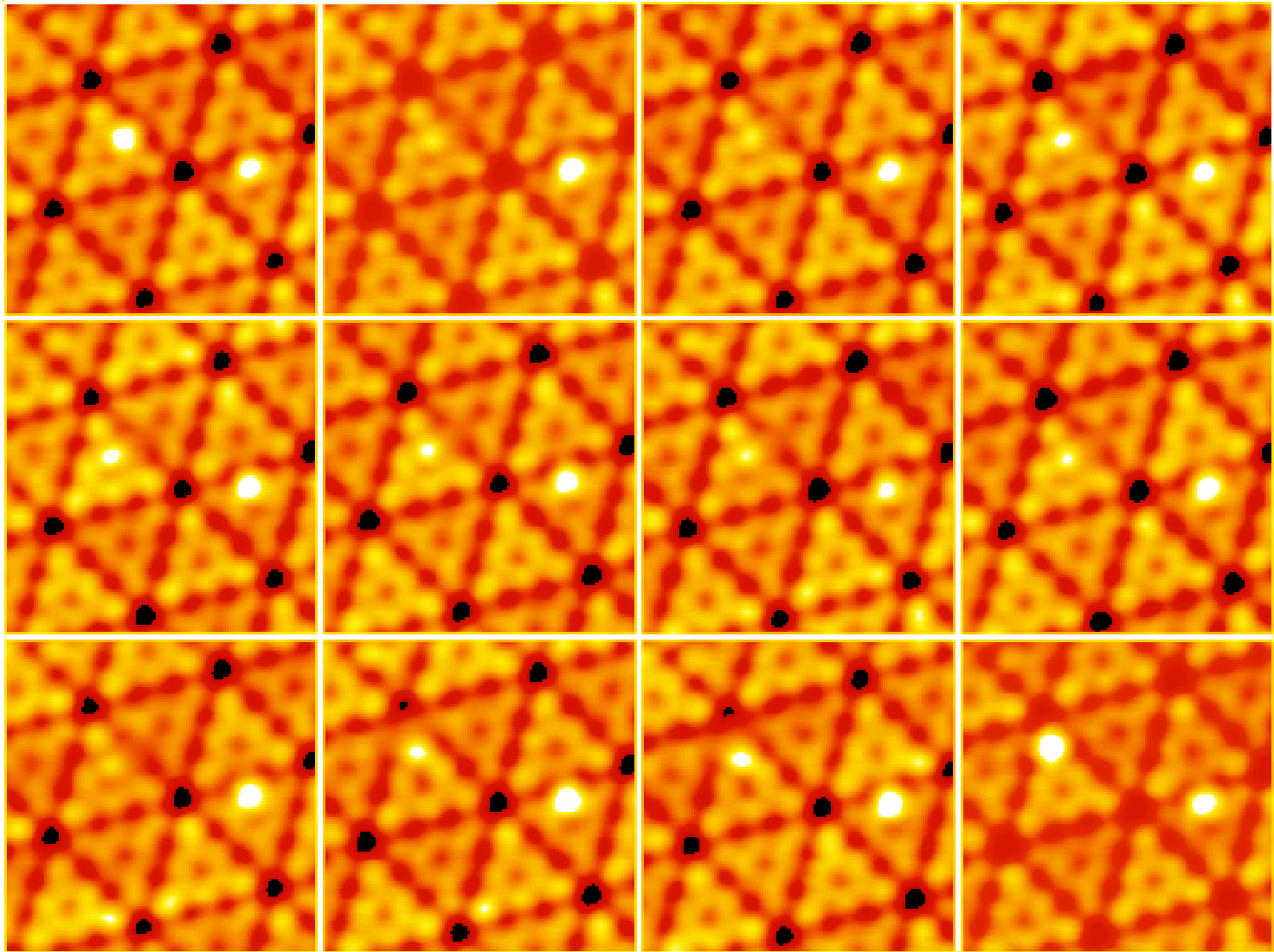


TABLE I. Parameters for site hopping of O<sub>2</sub> on Si(111)-(7 × 7).

Hopping	Activation energy	Frequency factors
FE to FE	2.04 ± 0.04 eV	10 <sup>15.0</sup> s <sup>-1</sup>
FE to FO	2.29 ± 0.06 eV	10 <sup>16.2</sup> s <sup>-1</sup>
FO to FE	2.13 ± 0.11 eV	10 <sup>15.6</sup> s <sup>-1</sup>
UE to UE	2.16 ± 0.04 eV	10 <sup>15.9</sup> s <sup>-1</sup>
UE to UO	2.01 ± 0.10 eV	10 <sup>14.6</sup> s <sup>-1</sup>
UO to UE	1.96 ± 0.13 eV	10 <sup>14.1</sup> s <sup>-1</sup>

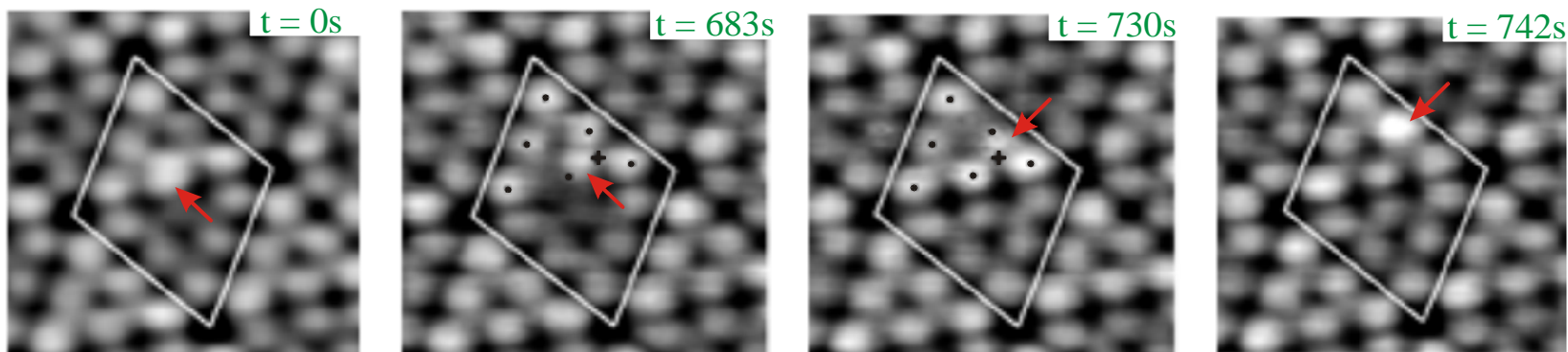
## Continuous-Time Scanning



300 C, 1V(filled-state), 0.2 nA, 2.4 sec per image

# Site Hopping of O<sub>2</sub> Molecule on Si(111)-(7x7)

STM  
images



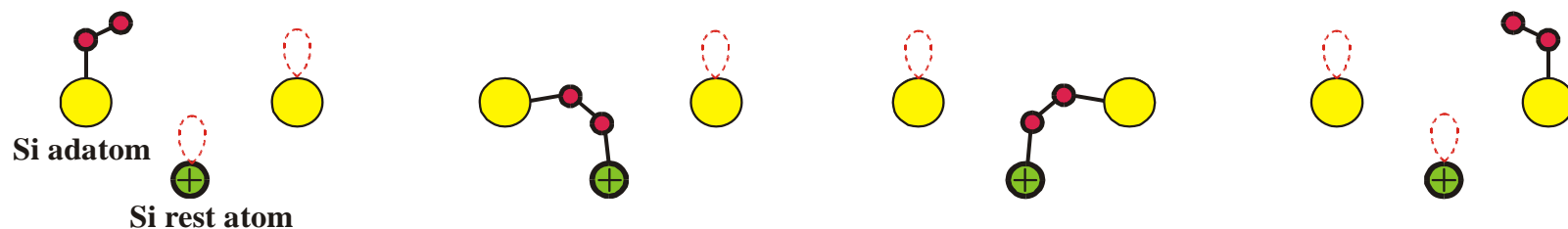
$B_i$

$I_i^*$

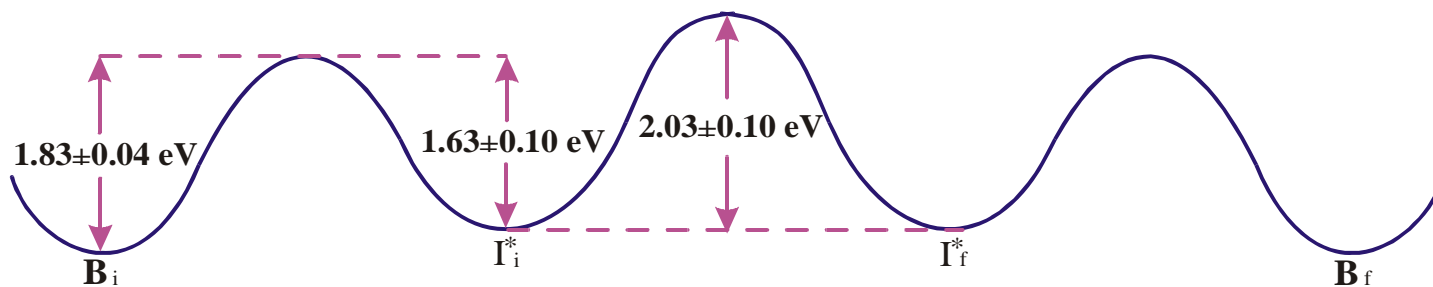
$I_f^*$

$B_f$

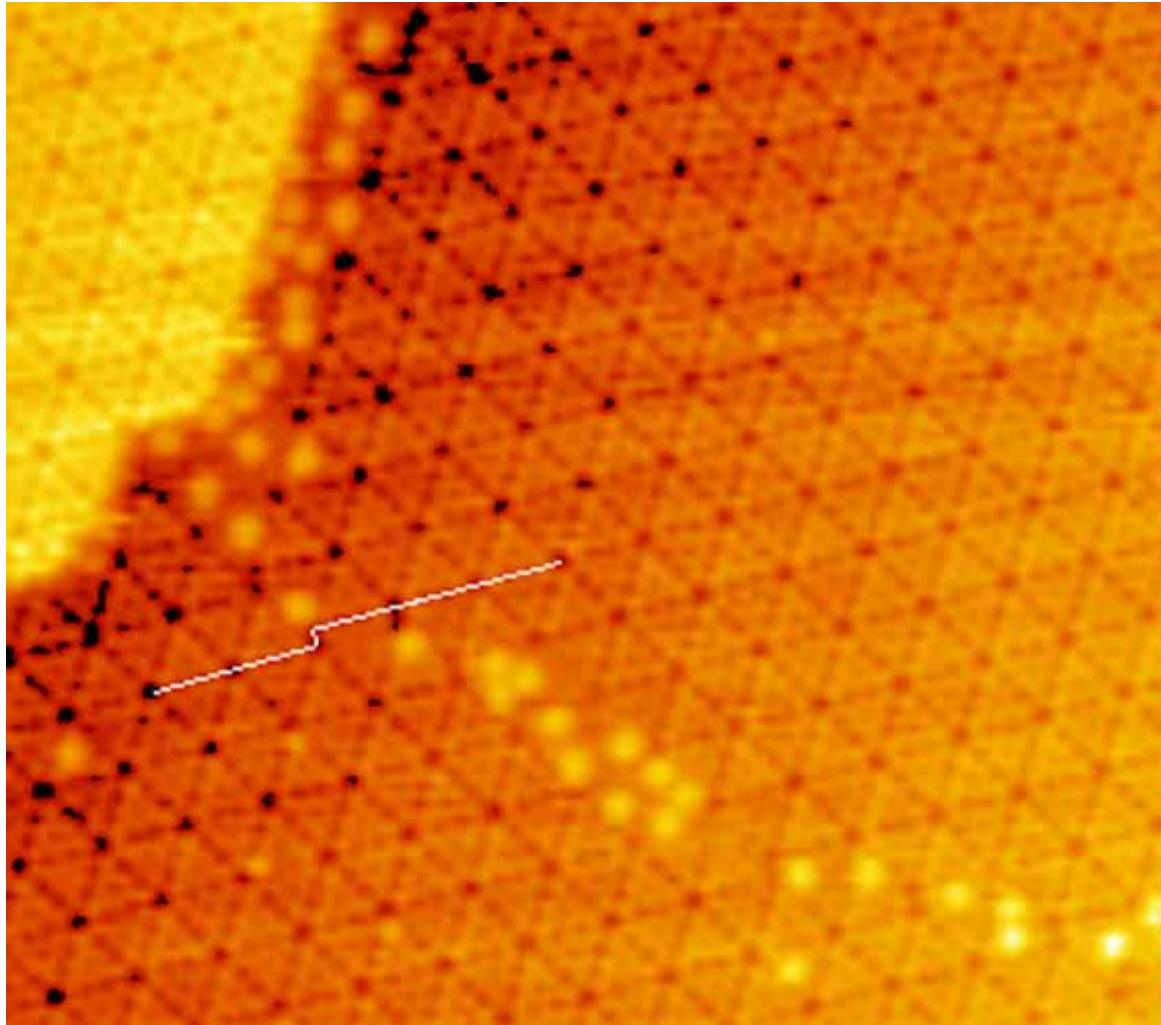
Atomic  
model



Potential  
diagram



# Silicon Magic Clusters on Si(111) Surfaces



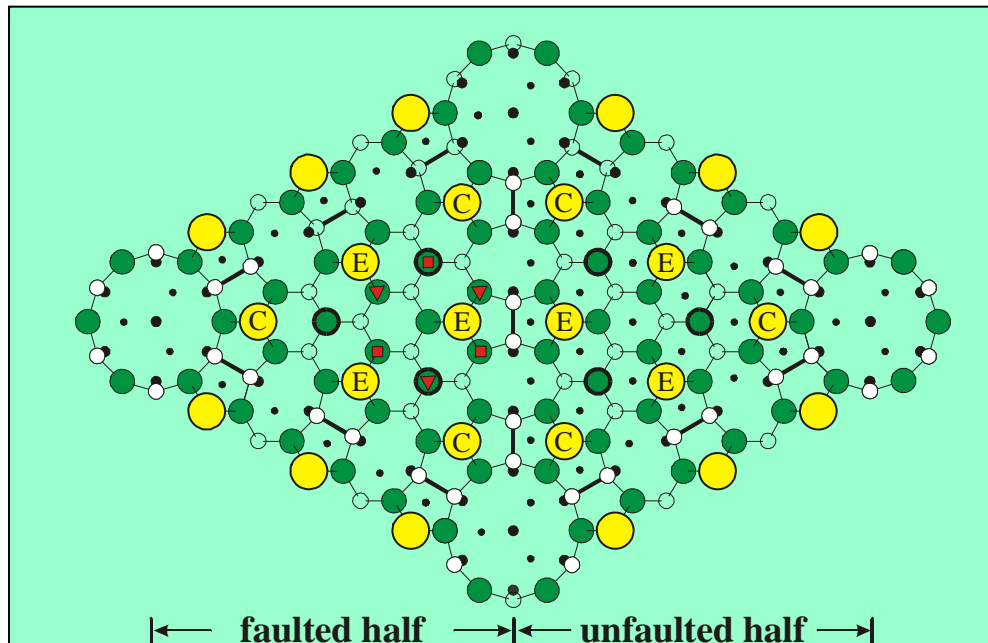
**480**

**Sample  
bias of  
-1.5V**

1. I. -S. Hwang, M. -S. Ho, and T. T. Tsong, Phys. Rev. Lett. **83**, 120 (1999).
2. M. -S. Ho, I. -S. Hwang, and T. T. Tsong, Phys. Rev. Lett. **84**, 5792 (2000).
3. I. -S. Hwang, M. -S. Ho, and T. T. Tsong, J. Phys. Chem. Solids **62**, 1655 (2001).

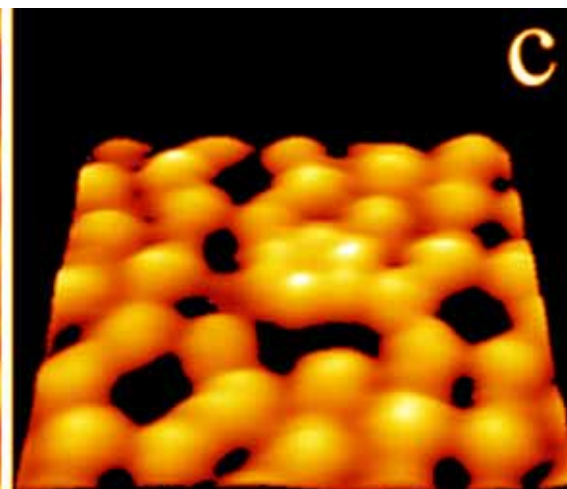
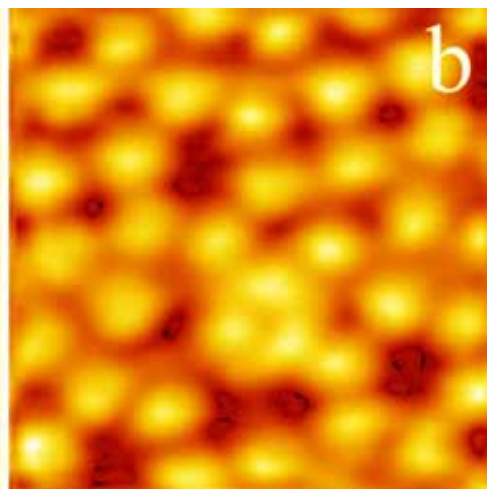
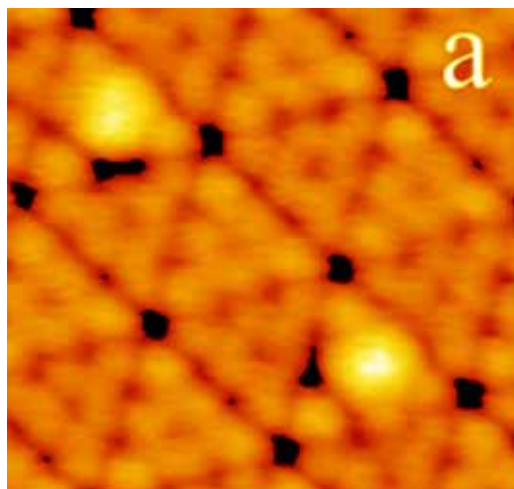
# Si Magic Clusters on Si(111)-(7×7)

1. The concentration of Si magic clusters is very low for samples cooled down slowly to room temperature.
2. The concentration increases with temperature,  $\sim 2 \times 10^{-7} \text{Å}^{-2}$  at 450 °C.
3. Deposition of Si atoms can increase the concentration of magic clusters.



The spacing between the protrusions is  $\sim 3.8 \text{Å}$ , which is much larger than the Si-Si bond length ( $2.3 \text{Å}$ ).

The magic number is estimated to be 9 to 15.

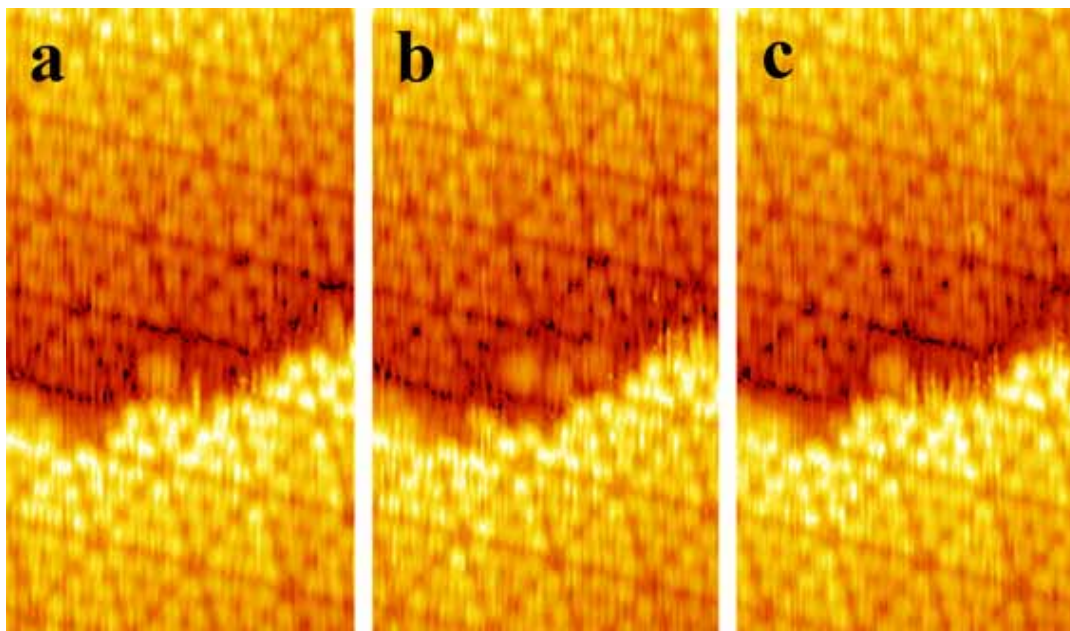


sample bias -1.5 V

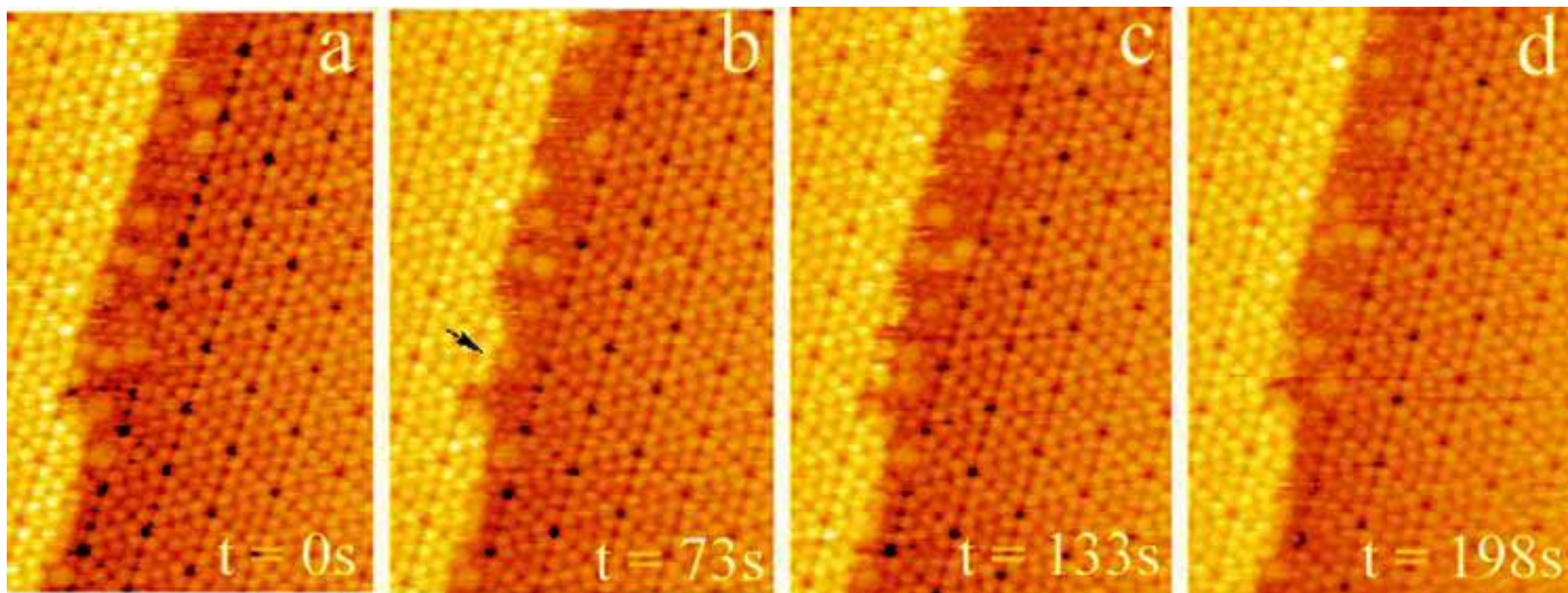
+1.8 V

+1.2 V

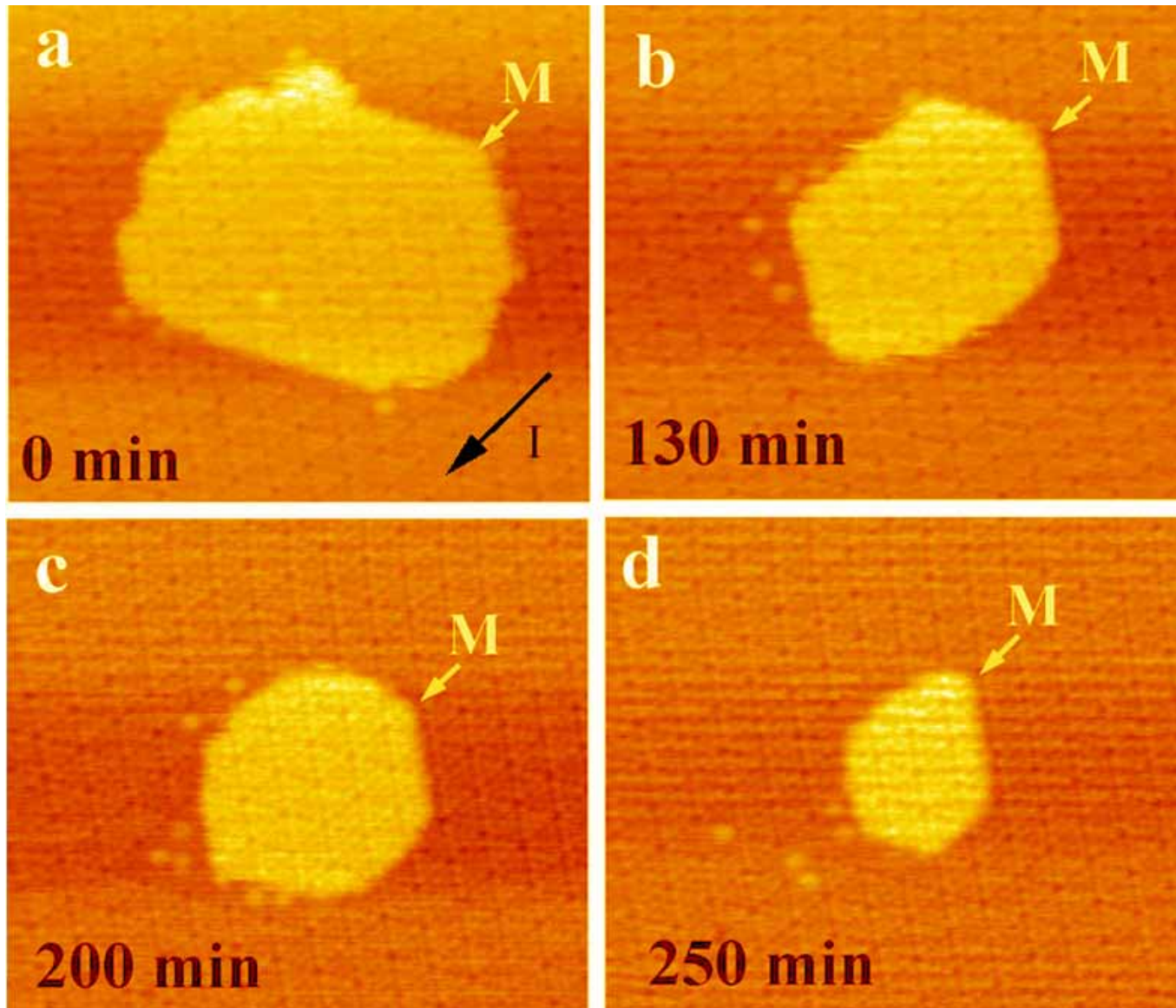




**Time interval 4.6 s**  
**Sample bias of  $-1.5\text{V}$**   
**450**



# The Decay Processes of 2D Islands



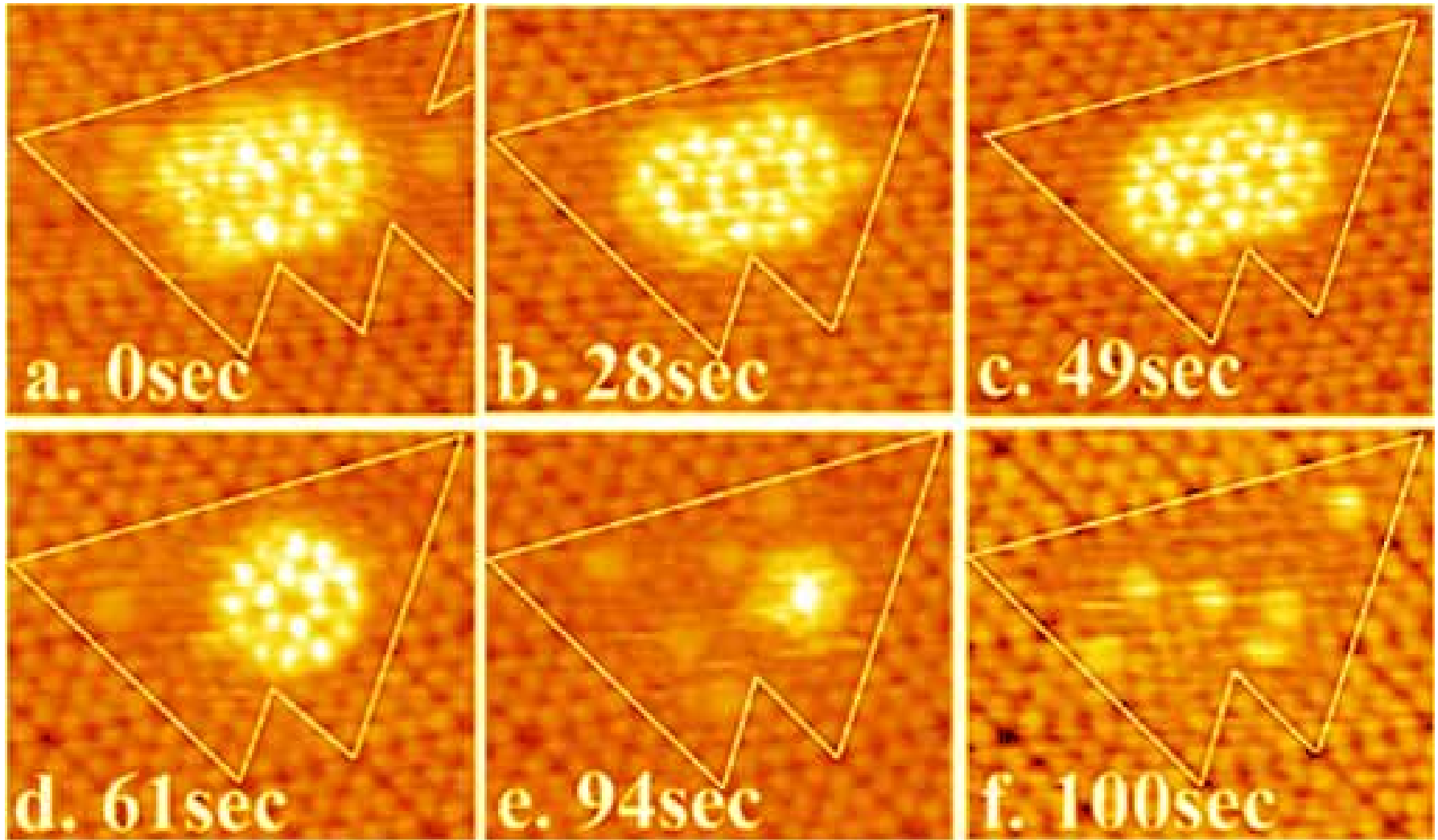
450Å × 380Å

Sample bias -2V

450

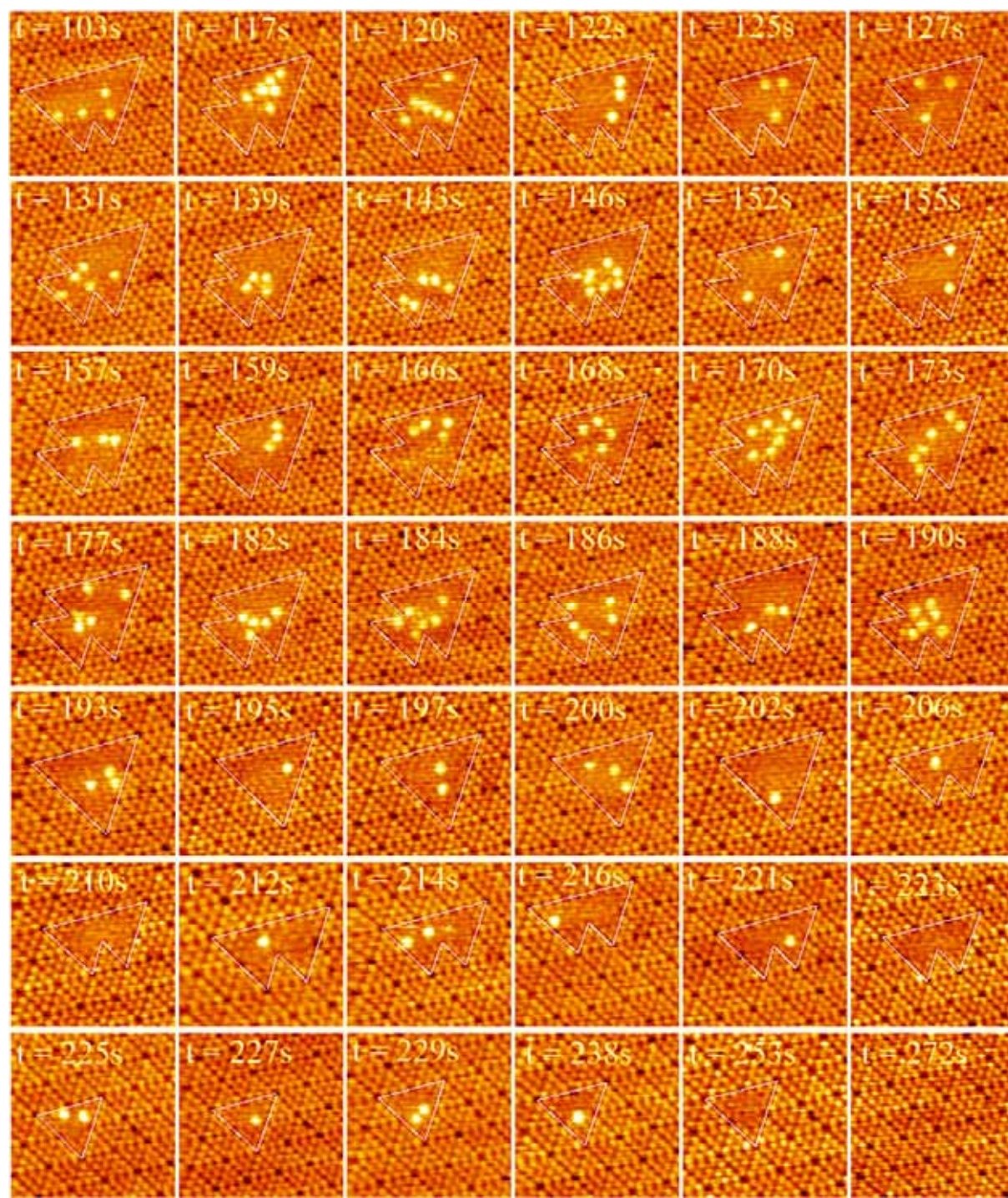


# Decomposition of a Si Island into Magic Clusters

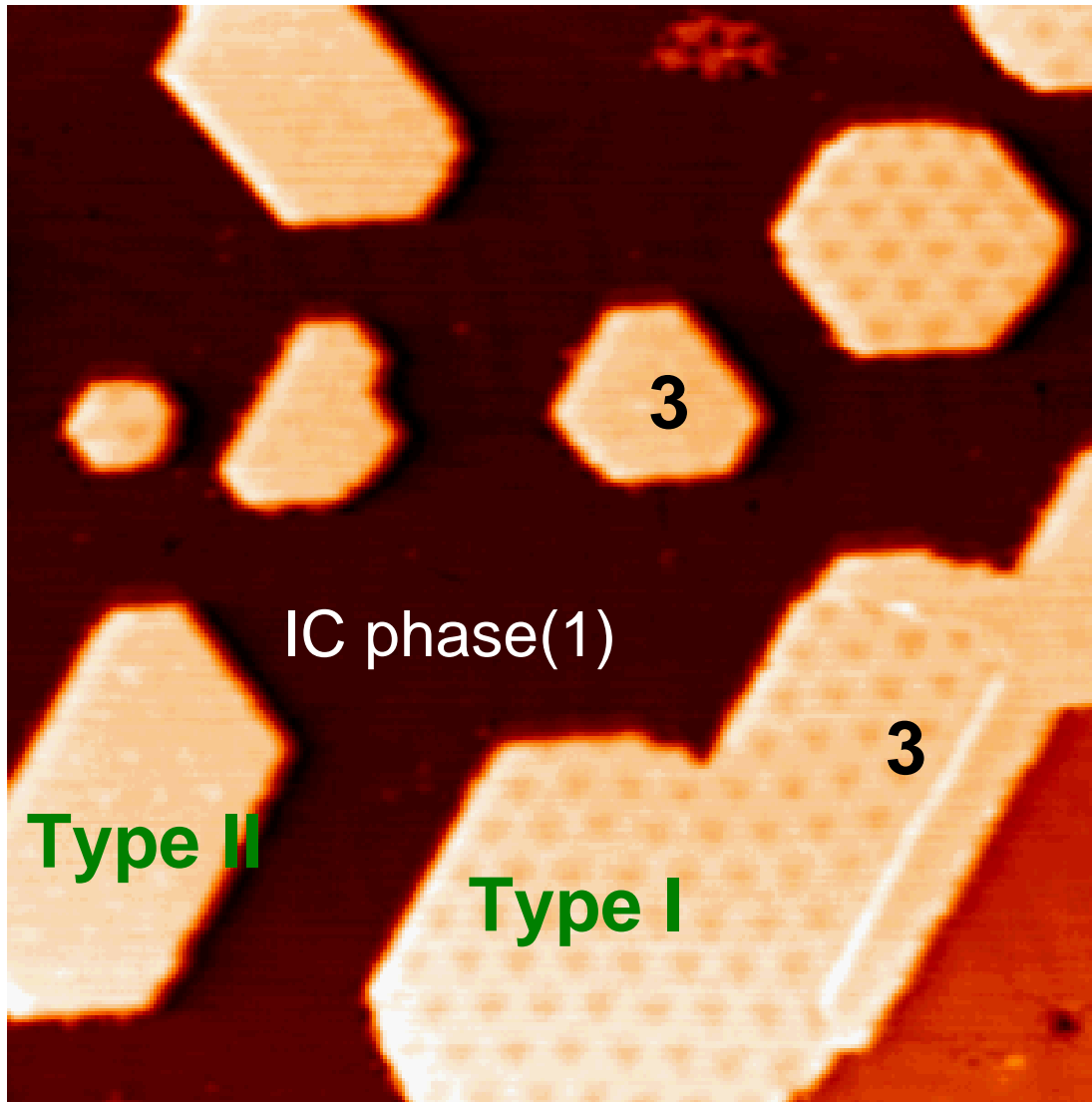


Sample bias  $-1.5\text{V}$

460



# Pb islands on Pb/Si(111)

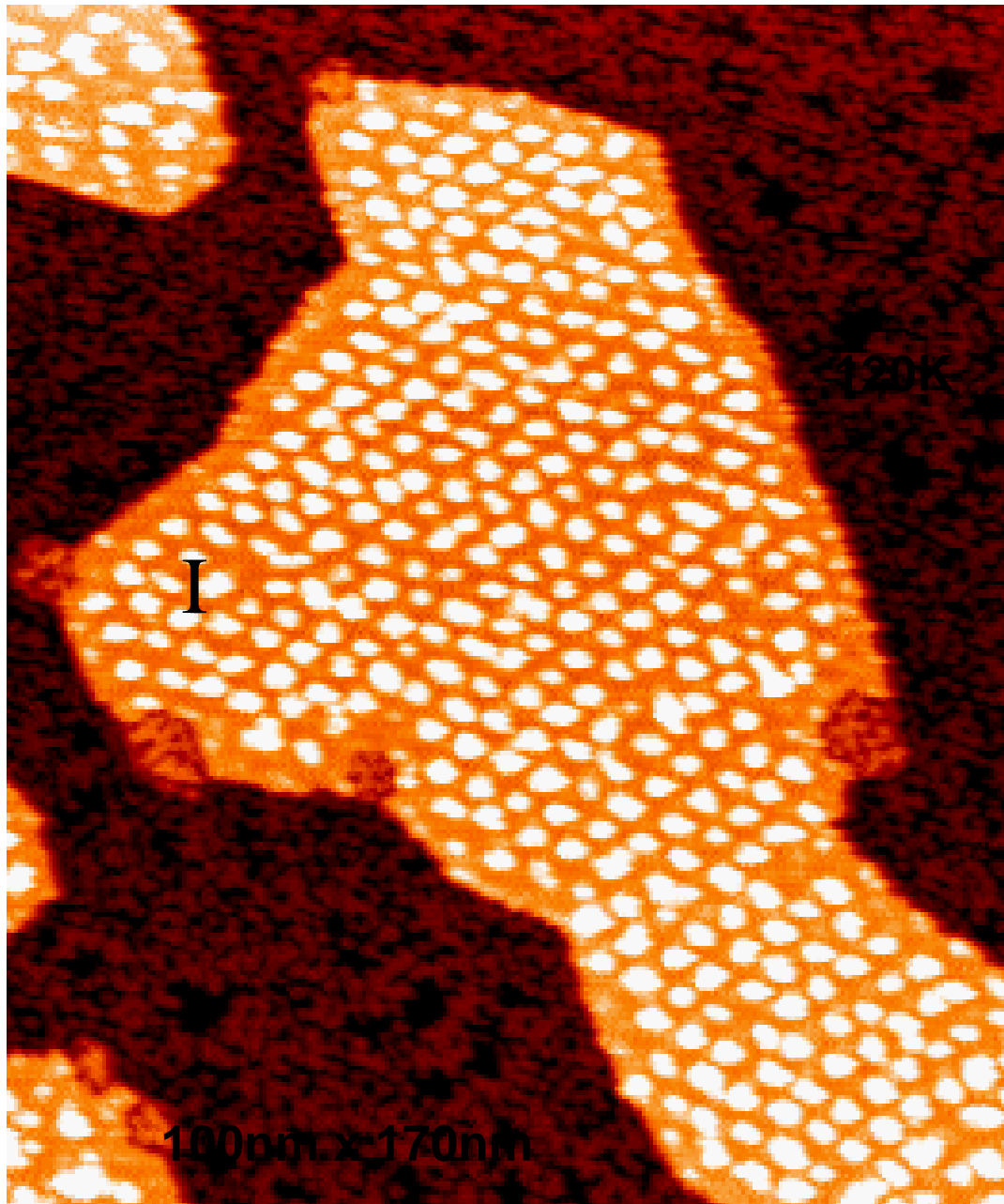


Deposit Pb on  
Pb/Si(111) at  
 $T \sim 200\text{K}$

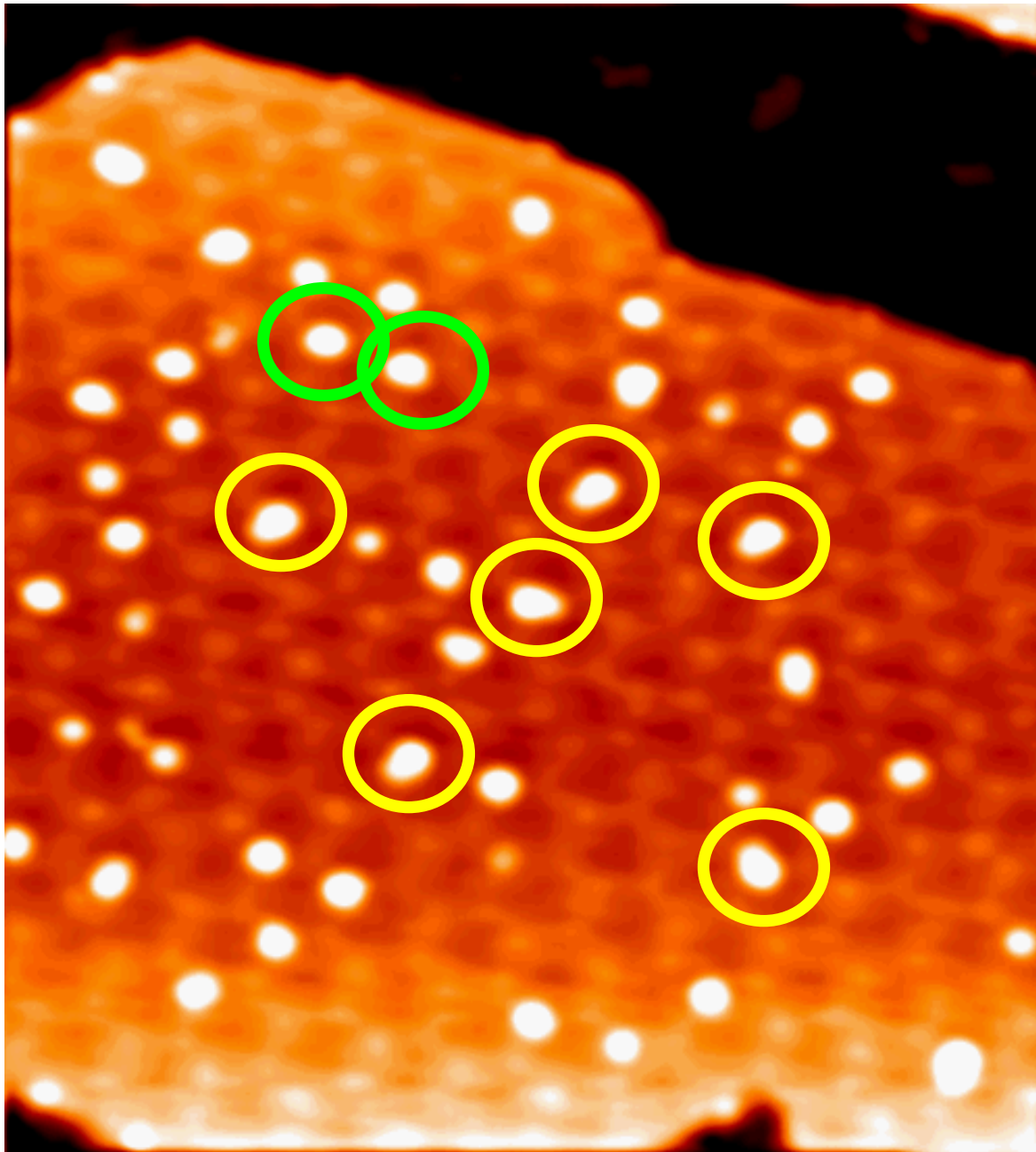
---Single  
thickness

Sample bias :  
+2V



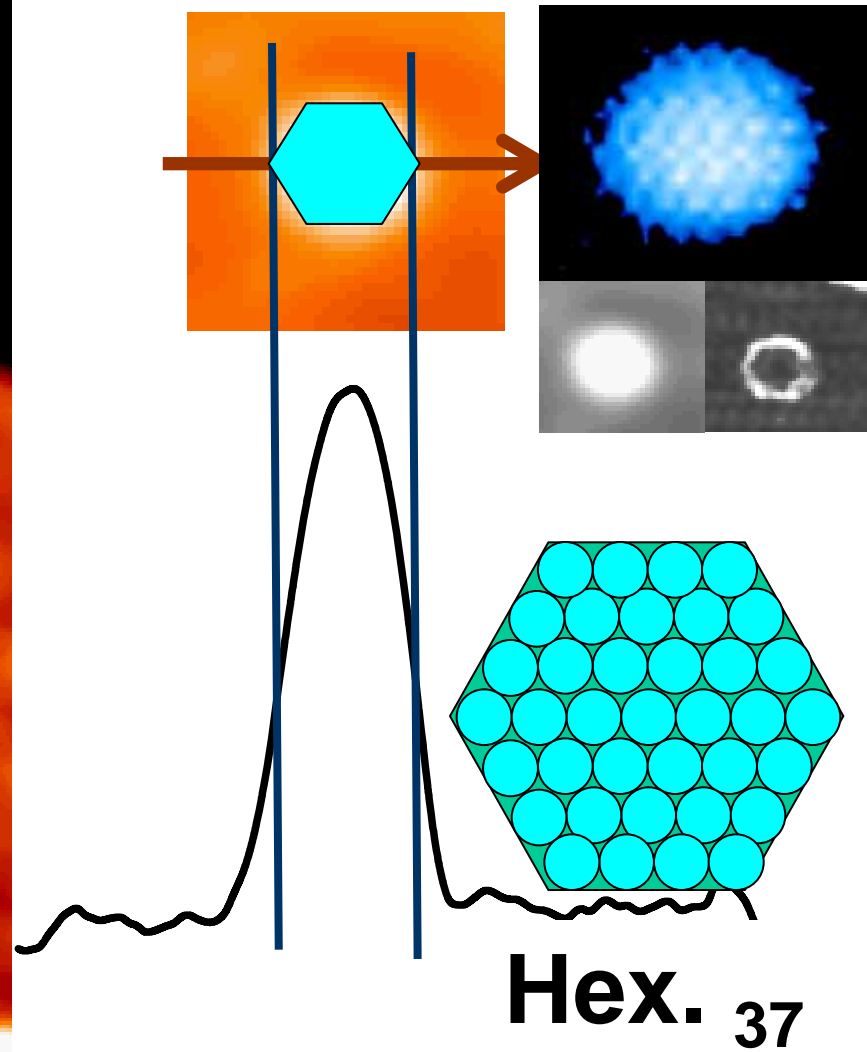
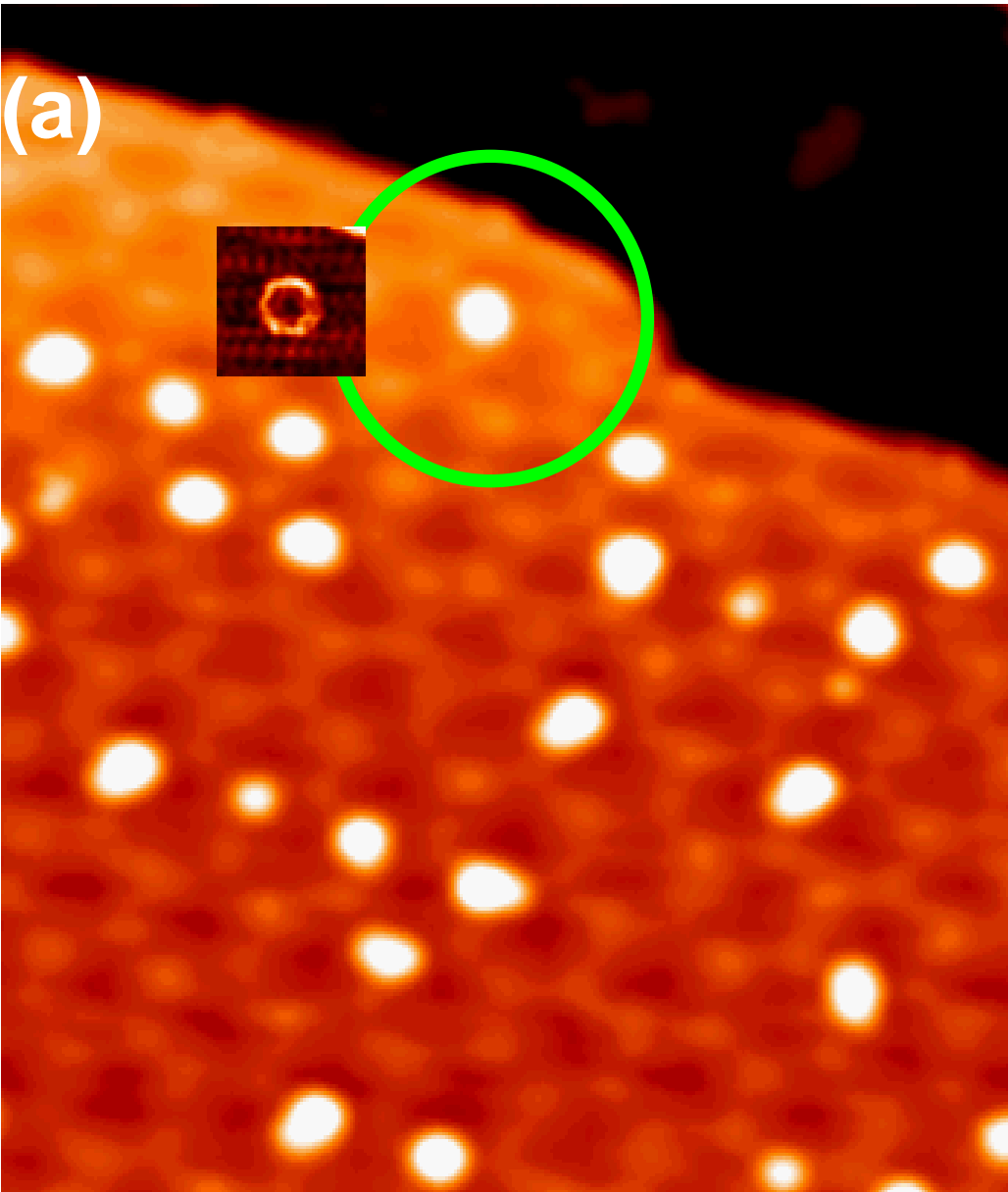


*Two-dimensional  
Ag cluster arrays*  
on quantum Pb  
islands

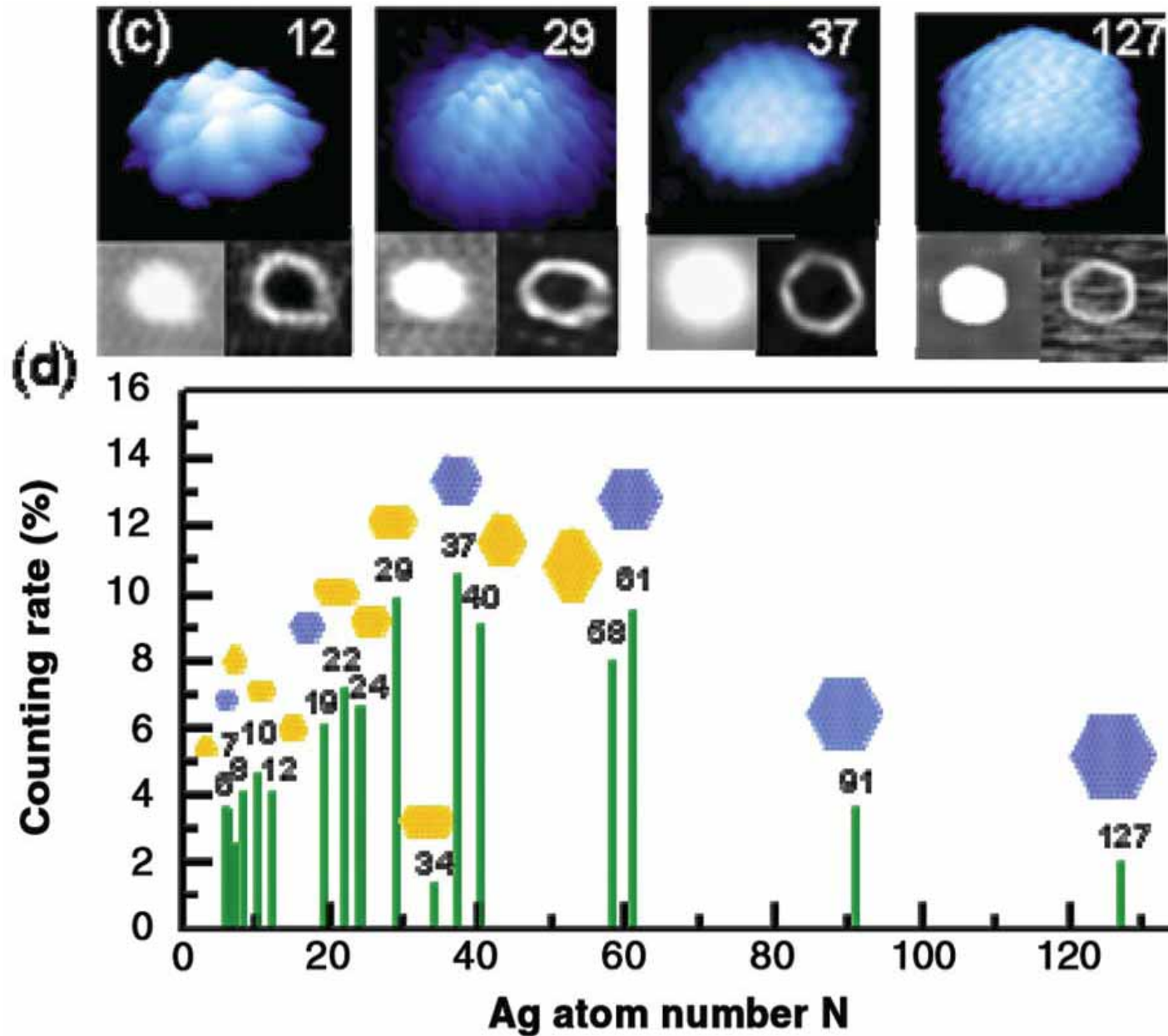


Deposit Ag  
on Pb islands  
at ***T~175K***

# The size of the nanopucks

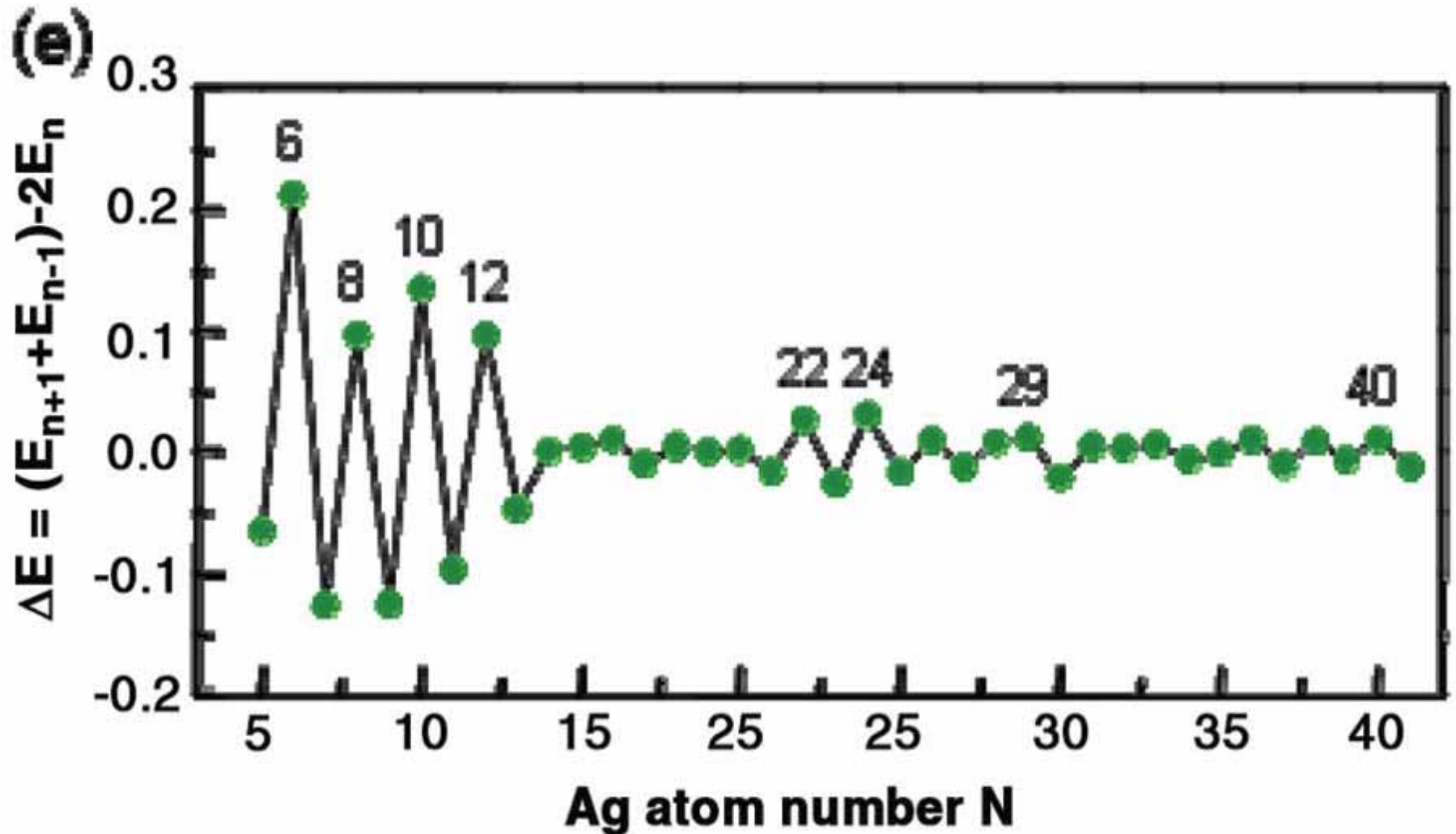


# Size distribution of Ag nanopucks



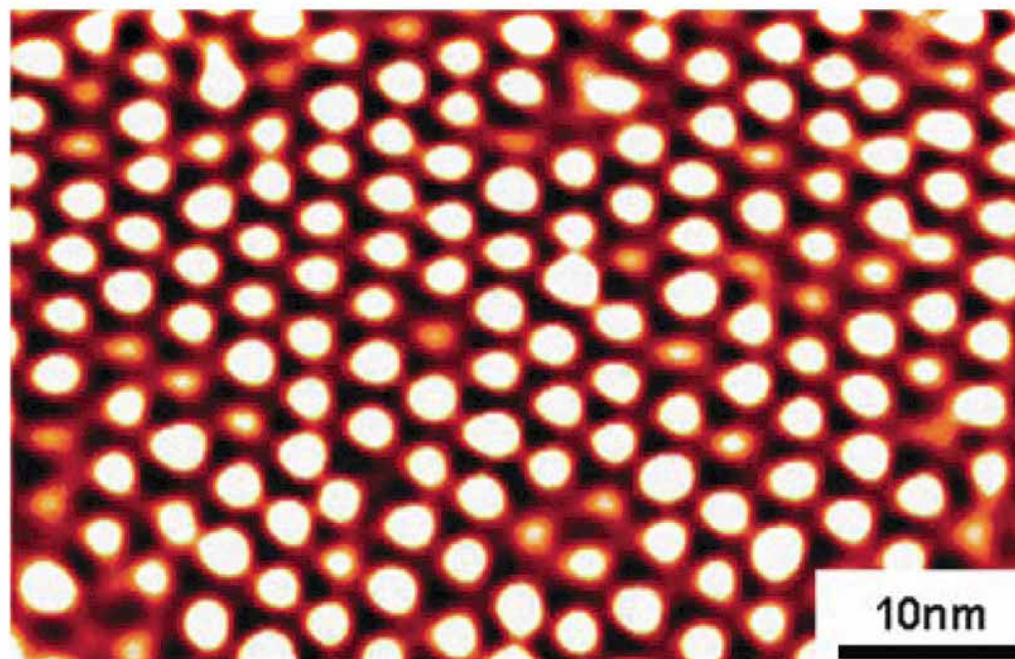
PRL 97,  
165504  
(2006)

# Stability of Ag nanopucks

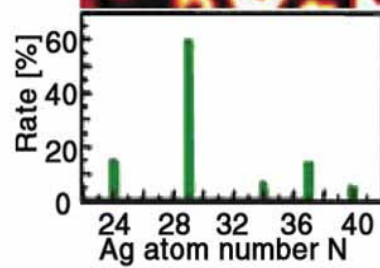
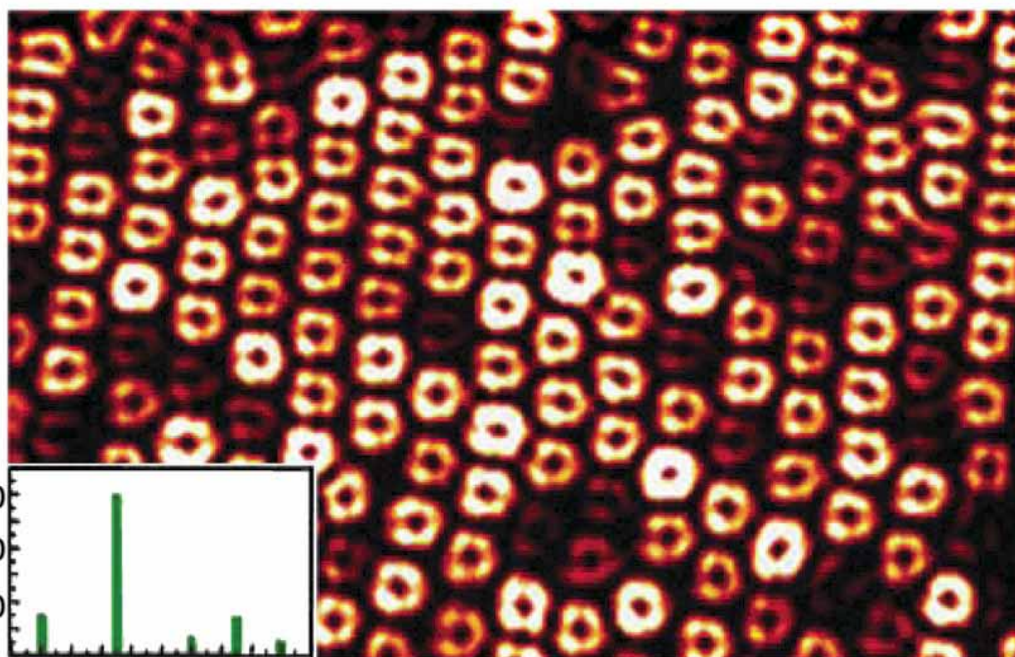




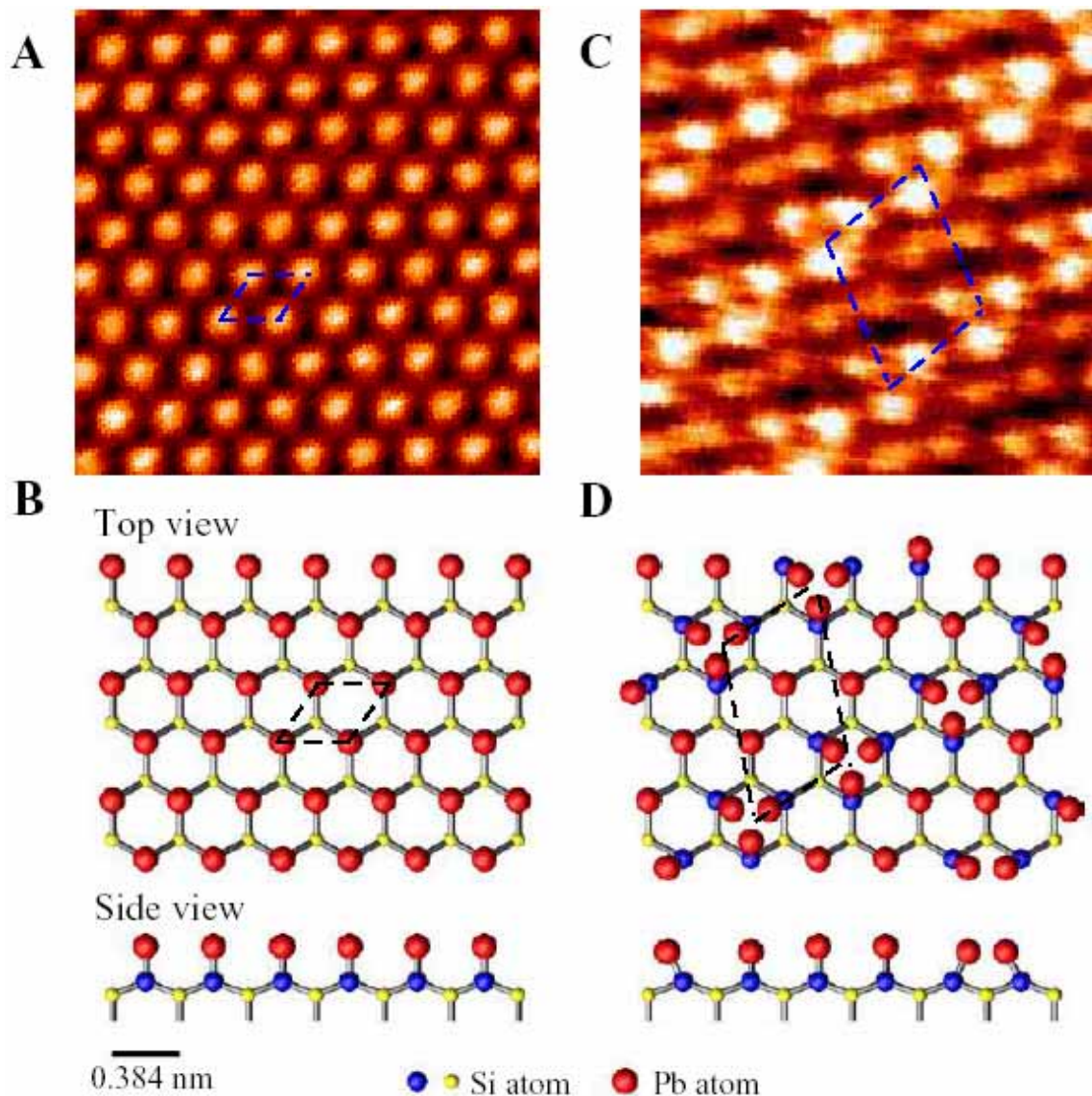
(a)



(b)

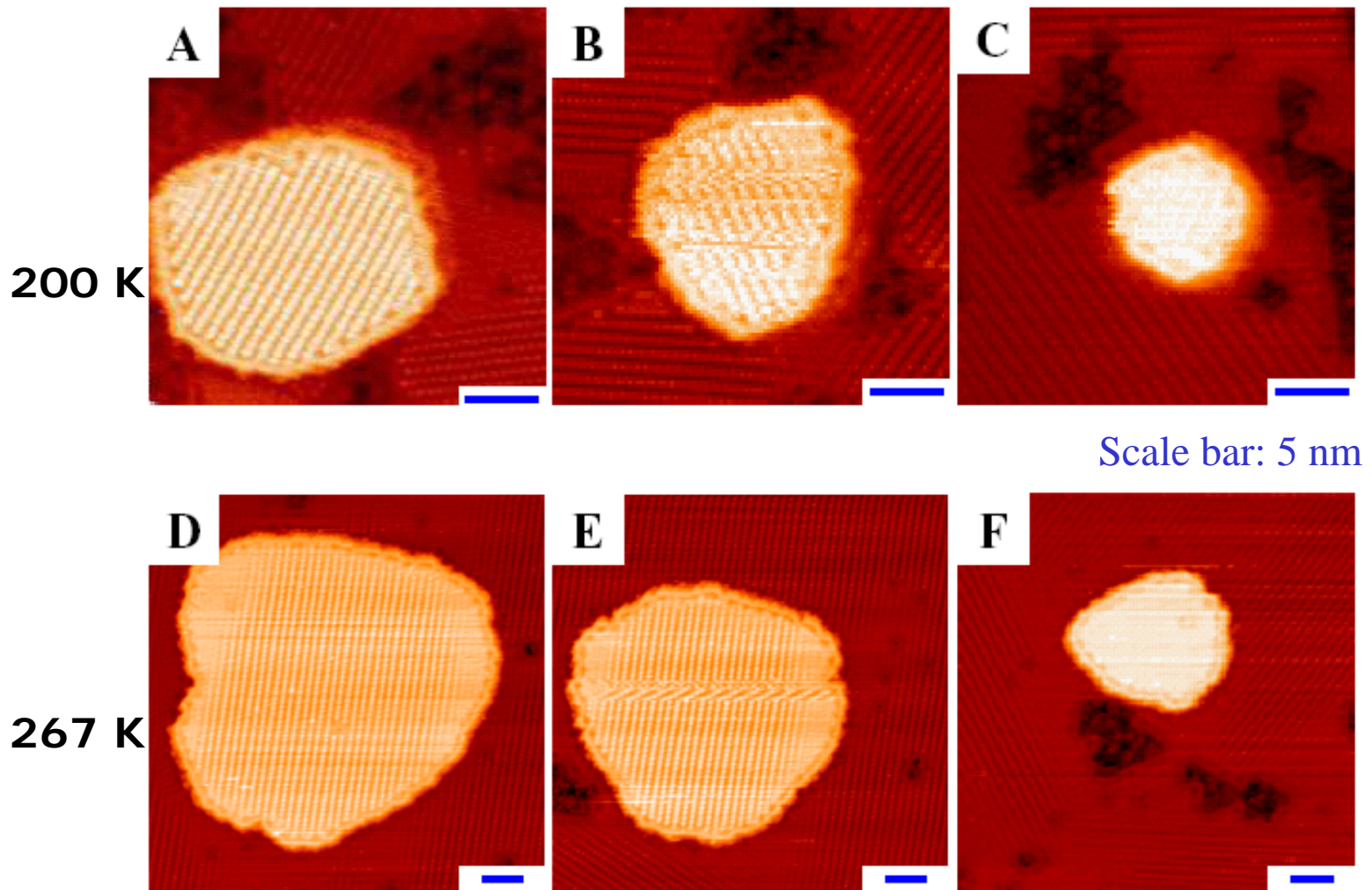


# Reversible Surface Phase Transition





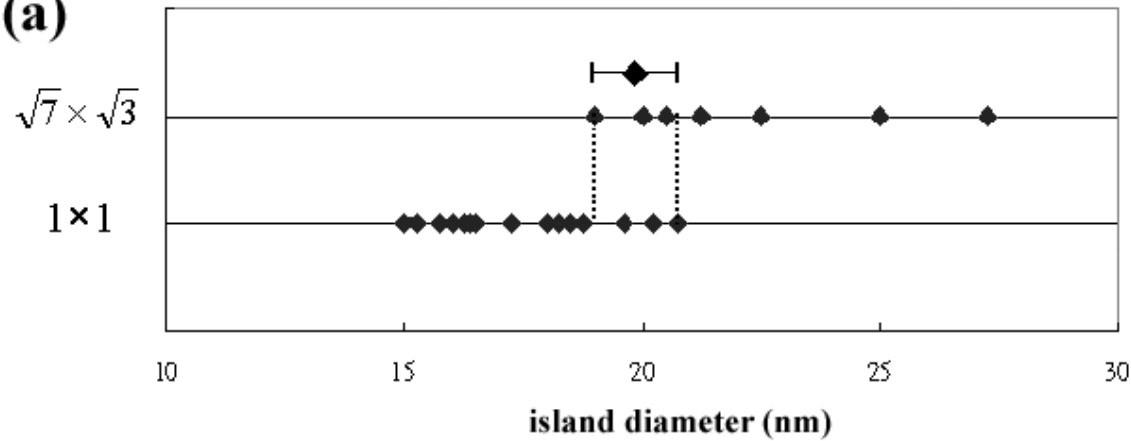
# Size Effects on the Pb-Covered Si Islands



I.S. Hwang, et al., Phys. Rev. Lett. **93**, 106101 (2004)

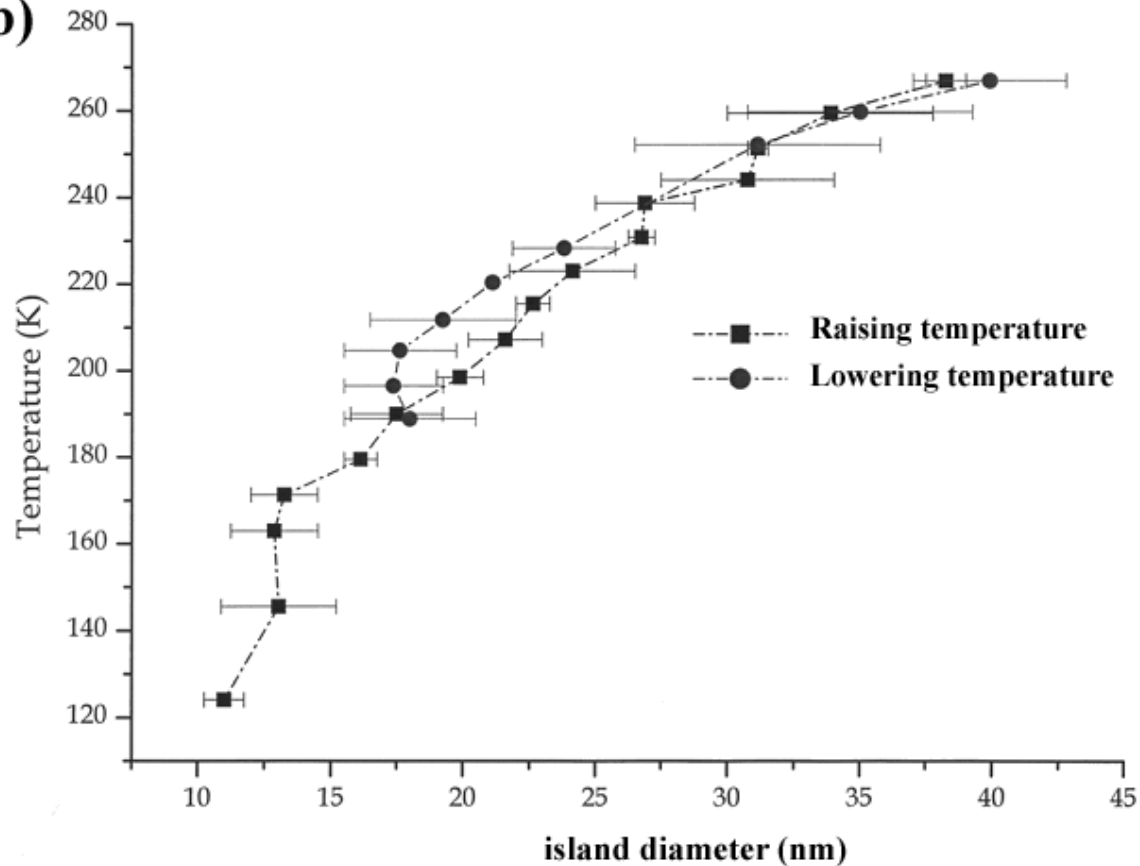
# Transition Temperature vs. Size

(a)



199 K

(b)



# Temporal Fluctuations Near the Transition Temperature

Slow scan direction

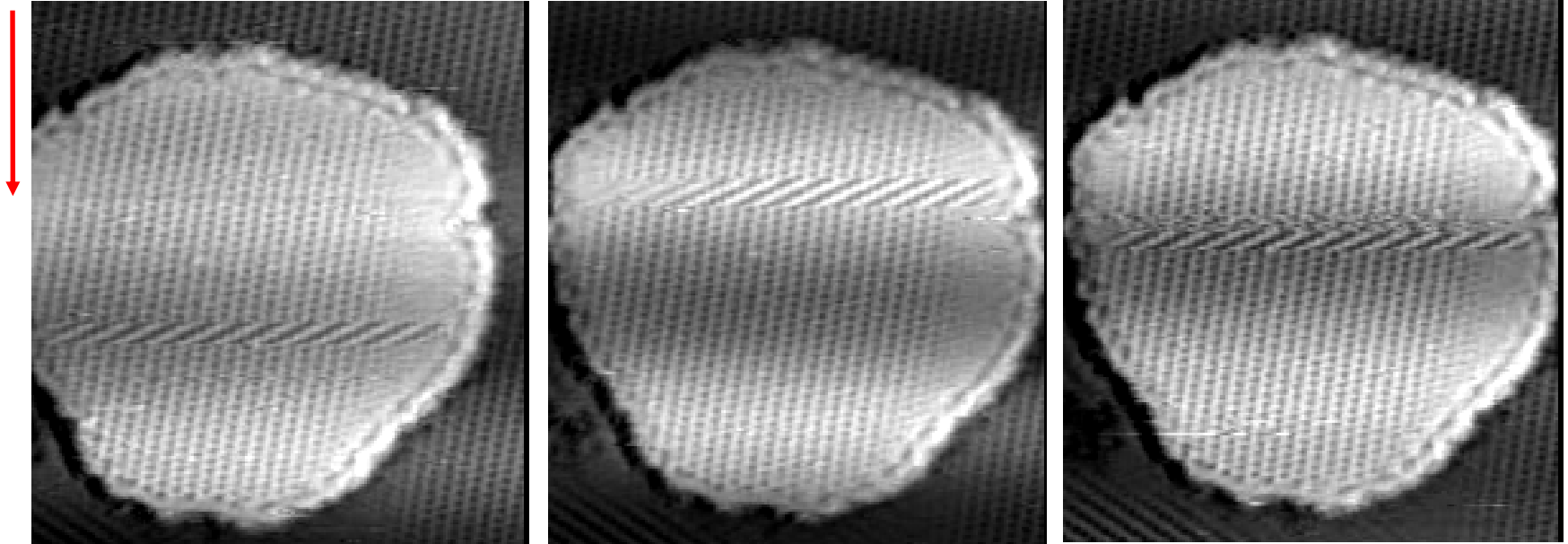
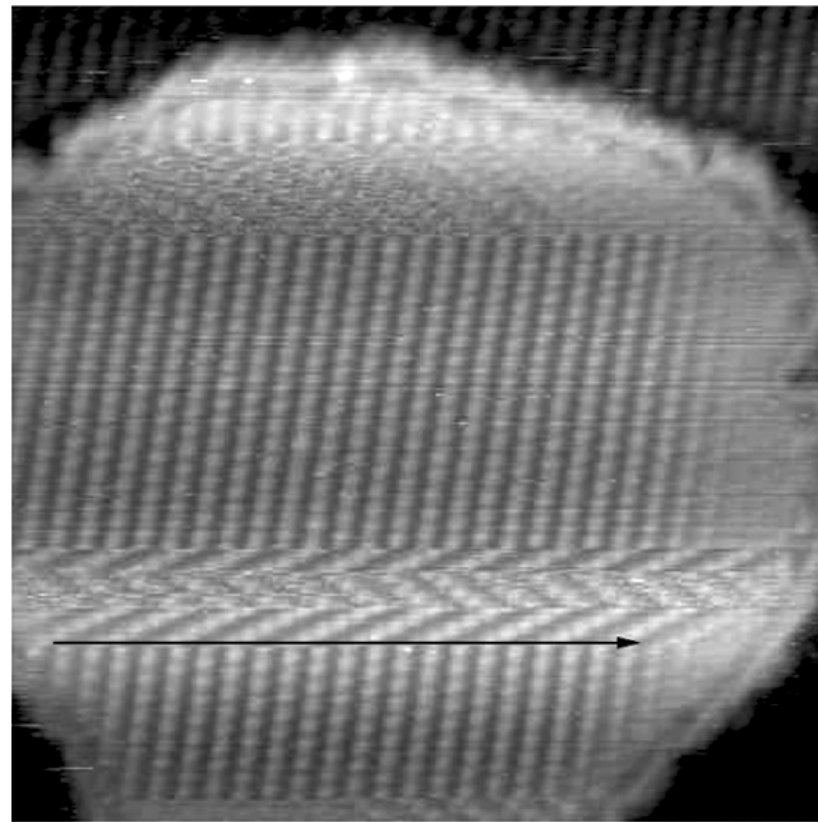


Image size: 34 nm x 38 nm

266 K

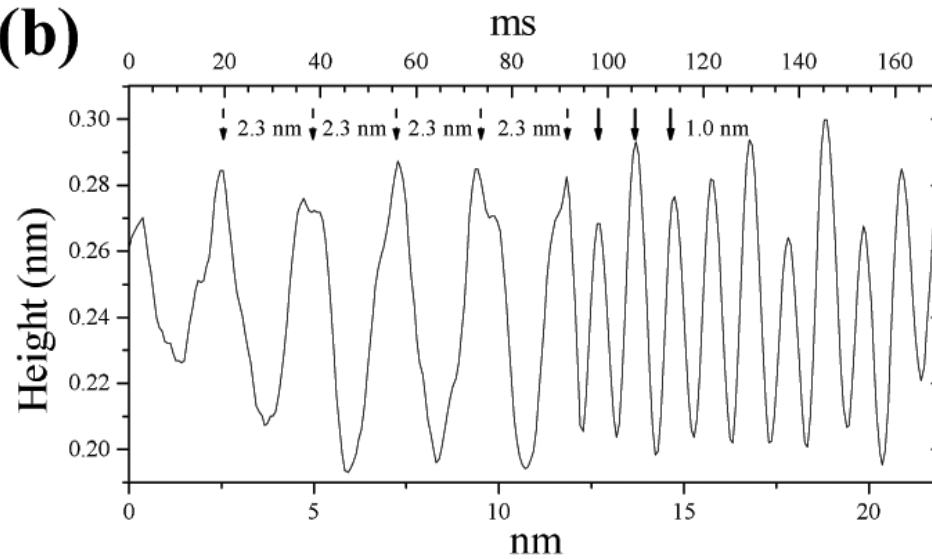


**(a)**

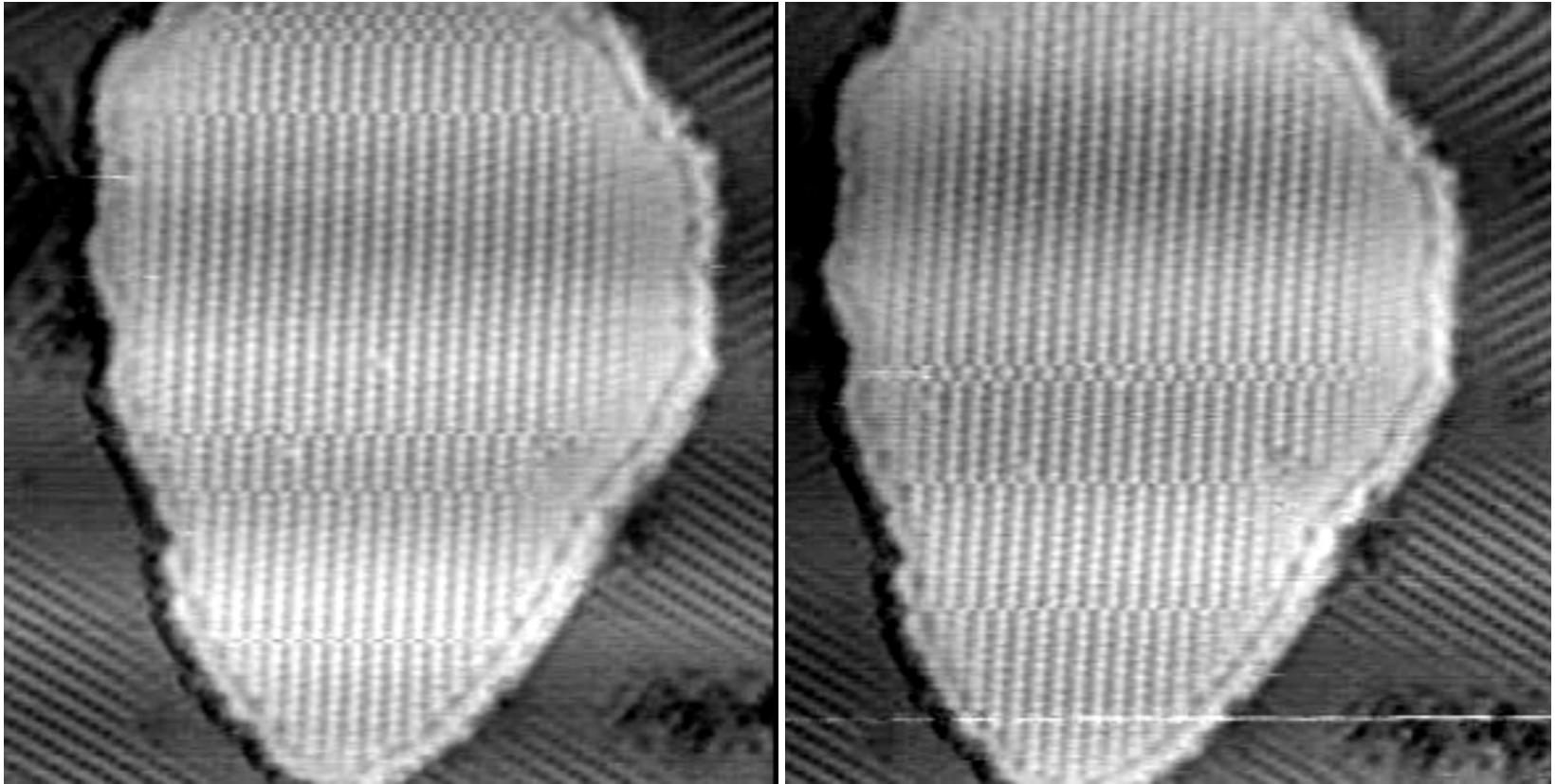


**Slow scan direction**

**(b)**



# Temporal Fluctuations Near the Transition Temperature



**260 K**

Image size: 40 nm x 40 nm

# Electrochemical Scanning Tunneling Microscopy

Angew. Chem. Int.  
Ed. 40, 1162  
(2001).

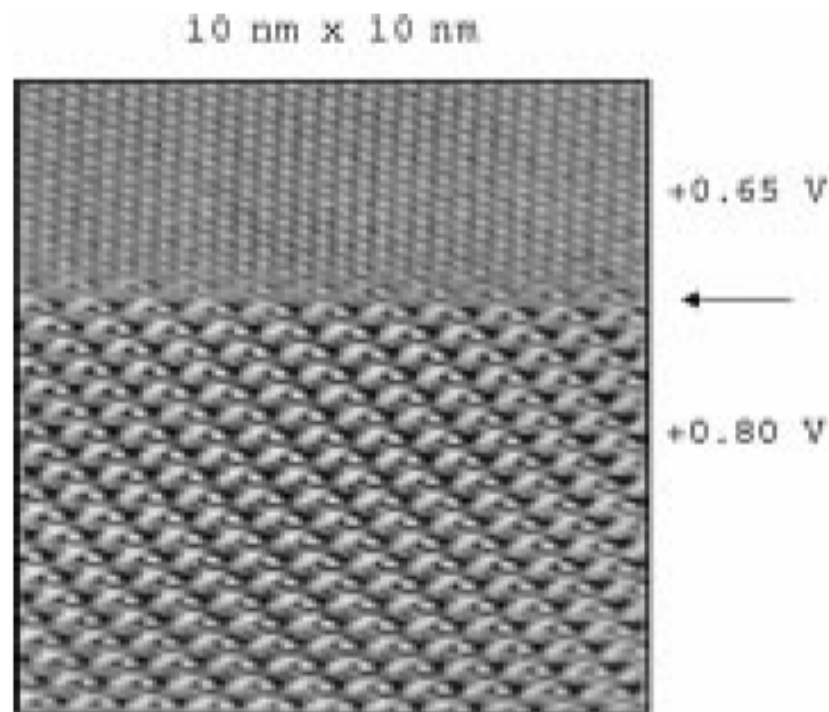


Figure 12. High-resolution STM image of Au(111) in 0.1M  $\text{H}_2\text{SO}_4$ . The upper part shows the Au(111) surface, atomically resolved, at  $+0.65\text{ V}$  versus SCE; the lower part shows the ordered adlayer of sulfate, formed by a potential step to  $+0.80\text{ V}$  versus SCE.

